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# X-ray excited optical luminescence of polynuclear aromatic hydrocarbons

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X-ray excited optical luminescence of  
polynuclear aromatic hydrocarbons

by

Gregory Joseph Oestreich

A Dissertation Submitted to the  
Graduate Faculty in Partial Fulfillment of  
The Requirements for the Degree of  
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Iowa State University  
Ames, Iowa

1979

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## CHAPTER 1: INTRODUCTION

The search for cancer-causing agents began in 1775 when physicians observed an abnormally high occurrence of cancer of the scrotum in chimney sweeps. Today, the carcinogenic and mutagenic properties of polynuclear aromatic hydrocarbons (PAHs), a major component of soot, are well known (1,2). All humans are exposed to many natural and man made sources of PAHs. These compounds are produced in hydrocarbon-fueled combustion processes, both natural (e.g. forest fires (3)) and controlled (e.g. internal combustion engines, (4) fuel-rich flames (5)). In addition to the many existing sources of PAHs, the dwindling supply of petroleum threatens to add another source of PAHs, as coal becomes an energy substitute. PAHs occur in coal tar pitch (6,7), in the environment surrounding coke production (8), in coal conversion processes (9), in coal liquification products (10-12), and even in coal (13).

Once formed, the PAHs can enter the atmosphere and the food chain. The modern coal-burning power plant is one example of a particularly dangerous source of atmospheric PAHs. The PAHs formed in the combustion process enter the atmosphere as gases and subsequently condense on the particulate matter formed in the boiler (14) and finally escape into the environment by being immobilized on the very fine particulate matter not removed by precipitators. In this

form the PAHs are inhaled deeply into the lungs and become imbedded in tissue. The localized concentrations of PAHs in the lung tissues represents a serious health hazard. PAHs also enter the body during the consumption of nourishment and water. Fresh water supplies contain PAHs in the range from 1 part per trillion in ground water to 100 parts per trillion and higher in industrially-polluted surface water (15,16). Certain foods contain large quantities of PAHs. Smoked and charcoal broiled foods have been shown to be dietary sources of PAHs. In one study the content of PAHs ranged from 0 to 141 part per billion in smoked foods and from 0 to 164 part per billion in charcoal broiled foods (17). In a more general study PAHs were found at trace levels in meat, fish, poultry, root vegetables, beverages, dairy products, oils, fats and shortenings (18). The occurrence of PAHs in the diet is an important source of human exposure to carcinogenic substances.

The many different sources and the varied composition of PAH-contaminated materials presents the analytical chemist with a serious problem. Sensitive and selective analytical methods for the characterization of PAHs are required. For these reasons and because of the potentially hazardous exposure of humans to PAHs in industrial (19) and natural environments, there is increasing interest in new analytical concepts for the qualitative and quantitative determination

of these compounds at trace and ultratrace levels (20).

PAHs occur in natural and man-made substances at trace and ultratrace levels in complex matrices (21-24,18). Therefore, sensitive and selective analytical techniques are required to characterize PAH mixtures. Because PAHs are highly luminescent materials (25,26), fluorimetric and phosphorimetric methods are favored for PAH characterization. Unfortunately, broad-band emission of most PAH systems prevents the simultaneous determination of several PAHs and limits the selectivity of luminescent methods.

To improve the selectivity of the luminescent methods for PAH systems, solid state techniques are often used. Two approaches for sharpening the luminescent emission are line-narrowing fluorescence spectroscopy (27,28) and mixed-crystal spectroscopy (29,30,31). Line-narrowing fluorescence spectroscopy employs a laser to excite only those PAH molecules in a particular environment within a low temperature matrix (e.g. glass, crystal or Shpol'skii). Molecules with vibrational levels in the first singlet electronic state which coincide with the laser frequency are excited. After vibrational deactivation these molecules are in equal energy excited states and fluoresce in a narrow frequency range. This technique has been demonstrated with an argon ion laser for anthracene and pyrene (32). Greatly improved selectivity should be possible with a tunable dye

laser in place of the argon ion laser. The second approach requires choice of a solvent or matrix in which the PAHs can reside in a few particular orientations. If PAHs are dissolved in n-alkanes (pentane to nonane) and the resulting solutions are cooled to a temperature in the range of 4 K to 77 K, narrow-lined emission is observed under UV excitation. The impurity PAH molecules in the n-alkane host are held in substitutional sites and lattice broadening of their emission is not observed. These quasilinear spectra are a manifestation of the Shpol'skii effect (33-35). A review of the Shpol'skii effect (36) summarizes the systems which display this behavior. The variety of systems listed suggests the phenomena is quite common. The application of the Shpol'skii effect, excited by UV radiation, to the determination of 3,4-benzopyrene, a potent carcinogen, is well-documented (37-40).

The major drawbacks to luminescence analysis using the Shpol'skii effect are instrumental limitations (41). Scattered radiation from the excitation source is a particularly serious limitation since internal reflection occurs within the n-alkane snows formed upon freezing. The technique known as X-ray Excited Optical Luminescence (XEOL), which employs x-ray excitation, eliminates the problem of crosstalk between emission from the excitation source and luminescent emission from the sample. The conventional



sources (e.g. lasers, mercury lamps, xenon arcs etc.) (42) are replaced by an x-ray tube. XEOL is a sensitive analytical technique capable of detecting impurities at the fractional part per billion level in appropriate solid or gaseous environments (43,44). In an earlier publication (45) we reported the first observation of the Shpol'skii effect from PAHs in n-alkanes under x-ray excitation. The observation of quasilinear fluorescence and phosphorescence of PAHs under x-ray excitation suggested the combination of XEOL and the Shpol'skii effect might be a viable approach to the simultaneous multicomponent determination of complex PAH mixtures.

Another advantage gained by combining the Shpol'skii effect and XEOL is nonspecific excitation of the sample. The coincidence of the absorption band of the PAH molecule and the emission frequency of the excitation source is not a requirement because resonance processes are not responsible for direct excitation of the PAH molecules. Instead, highly selective energy transfer processes are responsible for the sensitized luminescence which is observed from trace PAHs contained in n-alkane microcrystals (45). The observation of sensitized luminescence indicates XEOL should be a sensitive method for the determination of PAHs in Shpol'skii matrices.

To visualize the processes which occur in the proposed excitation mechanism, an energy level diagram of the

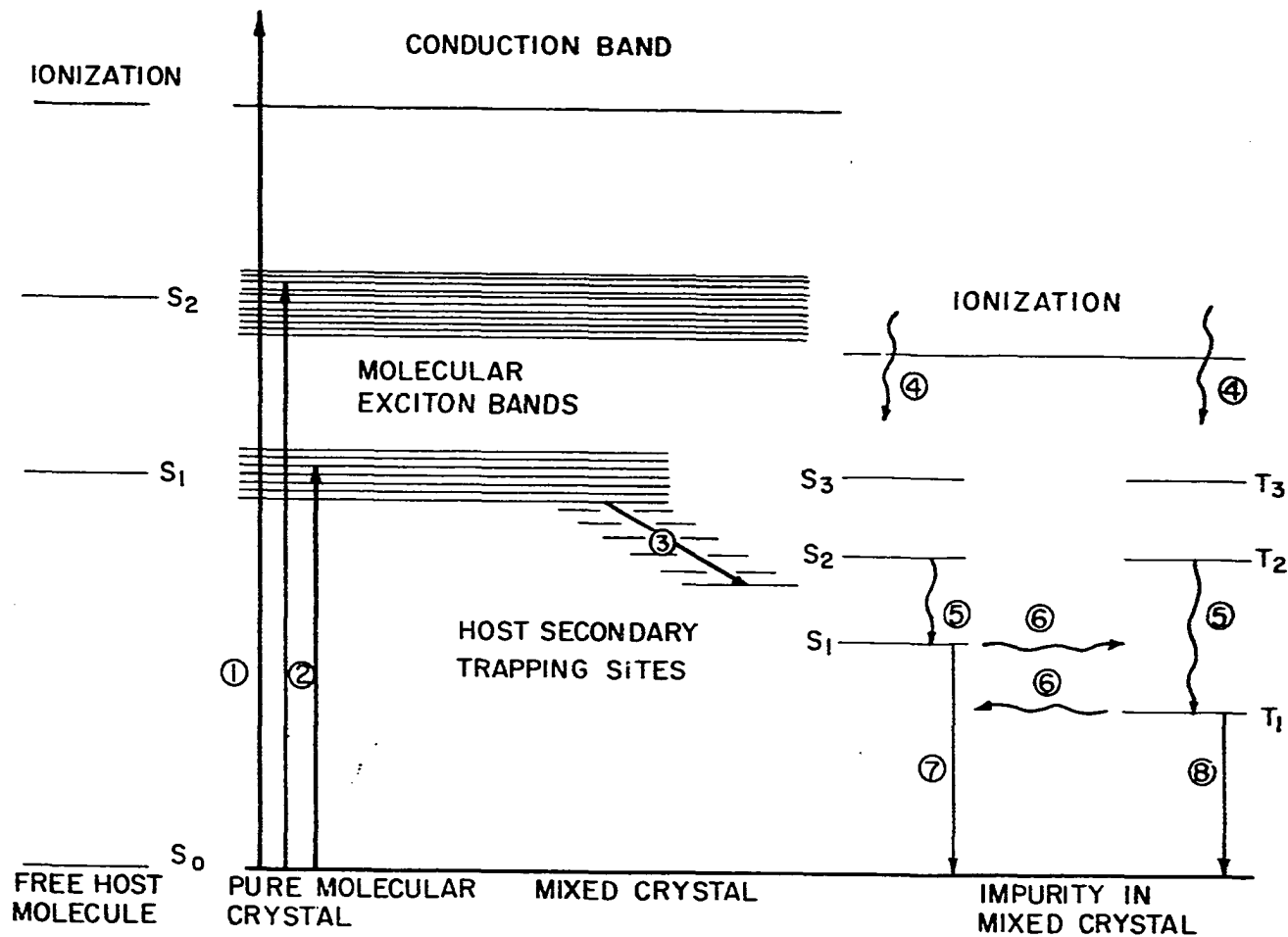


Figure 1. Energy level diagram for a n-alkane-PAH system at 10 K. The numbered transitions are; 1. Formation of the primary photoelectron, 2. Collisional population of molecular exciton bands, 3. Exciton trapped by perturbed host molecule, 4. Recombination, 5. Internal conversion followed by vibrational deactivation, 6. Intersystem crossing, 7. Fluorescence and 8. Phosphorescence.

n-alkane-PAH system at 10 K is presented in Figure 1. An explanation of the excitation mechanism begins with the energy levels of the free host molecule on the left side of Figure 1. The ground state, first two excited singlet electronic states, and the ionization limit are shown. To simplify the diagram, the vibrational levels were not drawn. In the solid state, the ground state and the ionization limit of the free host molecule are analogous to the valence and conduction bands of an ionic crystal. The singlet electronic states of the free host molecule broaden into molecular exciton bands which are characteristic of a molecular assembly of many host molecules. These molecular exciton bands are the transmission lines of the excitation energy. The perturbation exerted by an impurity molecule on neighboring host molecules results in the formation of host secondary trapping sites, shown in the mixed crystal region of the diagram. These perturbed host molecules are important in the selective capture of excitons by the impurity molecules. Finally, on the right side of Figure 1 the energy levels of a typical PAH are depicted as discrete states. The use of a Shpol'skii solvent traps the PAHs in identical environments in the crystal lattice and prevents broadening of the singlet and triplet excited electronic states. The observed optical signal is a composite of fluorescence and phosphorescence transitions of PAH molecules trapped in the

lattice.

The first step in the excitation mechanism is the interaction of x-ray photons with the sample or the sample holder. X-ray photons interact with matter in three ways; 1. Photoelectric effect, 2. Compton effect and 3. Pair production (46,47). At the energies used in XEOL experiments (typically 60 kV.) only the photoelectric effect occurs. Atoms of the solvent or sample holder may absorb an x-ray photon and eject a primary photoelectron with energy in excess of several keV. (process No. 1 in Figure 1). The excited atoms relax by the emission of characteristic fluorescence x-rays or the ejection of Auger electrons. The primary photoelectron, fluorescent x-rays and the Auger electrons collisionally excite neighboring atoms in a cascade process.

The collisional excitation of electrons and atoms of host molecules populates the molecular exciton bands (process No. 2 in Figure 1). The exciton wave migrates through the molecular assembly and the excitation is delocalized (31). As the exciton propagates through the microcrystal it may enter a region in which an impurity molecule is trapped in the lattice. If the exciton migrates to a perturbed host molecule a phonon is produced and the exciton no longer possesses enough energy to migrate freely in the microcrystal. The exciton continues toward the impurity with the production of

additional phonons (process No. 3 in Figure 1) until the impurity traps the exciton and is excited electronically or ionized. The inability of the exciton to return to the bulk of the crystal after the production of phonons near the impurity sites results in the funneling of excitation energy to the impurity. Recombination, internal conversion and intersystem crossing with vibrational deactivation (processes No. 4, 5 and 6 in Figure 1) occur in the impurity. Fluorescence (process No. 7 in Figure 1) and phosphorescence (process No. 8 in Figure 1) return the PAH molecule to the ground state. Thus, the highly selective energy transfer processes produce the optical signal.

The sharp line spectra resulting from the Shpol'skii effect make spectral resolution of several PAHs possible and endow the XEOL technique with some selectivity. However, no monochromator is capable of resolving all lines. Even with the Shpol'skii effect, overlap occurs in the fluorescent and phosphorescent emission of PAHs. Time resolved spectroscopy (TRS) coupled with XEOL would further improve the selectivity of the method. The technique of time resolved spectroscopy (48-50) allows separation of overlapping luminescence of PAHs on the basis of their luminescent decay constants. Since PAHs possess a large range of fluorescent and phosphorescent decay constants (26), it should be possible to time resolve fluorescent components and phosphorescent components. A

pulsed excitation source is required to perform the time resolution experiment. Before coupling XEOL and TRS a pulsed x-ray source has to be constructed.

This dissertation describes the development of XEOL-TRS as a method for the analysis of PAHs. The modification of a medical x-ray unit for use as a pulsed x-ray source under computer control is discussed. The ability to time resolve phosphorescent mixtures but not fluorescent mixtures because of x-ray pulse characteristics is reported. Finally, analytical data is presented on the analysis of synthetic PAH mixtures and other systems that might be amenable to study by the XEOL-TRS technique are suggested.

## CHAPTER 2: FACILITIES

## Experimental Facilities

The experimental facilities, used as basic components in a simple XEOL system, are described in an early publication (51). The basic components plus the additional components of the pulsed XEOL system used in the present study are summarized in Table 1.

In Figures 2 and 3 the essential hardware portions of the pulsed XEOL system are numbered for easy identification. The brass sample chamber, used to shield the operator from scattered x-rays, was redesigned for this system. All seams in the brass structure were fitted with right angle slots to eliminate streaming of scattered x-rays through conventional seams. A reproducible mount for the cryogenic vacuum shield was fitted on top of the chamber. A table, to which the chamber was securely fastened, was added to support a ball bushing and bearing assembly for easy insertion and extraction of the cryogenic system into and out of the vacuum shield. Figure 2 shows the cryogenic system removed from the vacuum shield. The table has three-dimensional adjustments to simplify optical alignment of the system. Optical alignment was performed using a continuous wave He-Ne laser with emission at 632.8 nm. (C. W. Radiation Inc. Mountain View, CA). The sides of the brass box are easily removed and



Figure 2. Photograph of the pulsed XEO system with the cryostat removed from the vacuum shield. The numbered components are: 1. cryostat (cold end), 2. sample holder, 3. ball bushing and bearing assembly, 4. radiation shield, 5. vacuum shield and 6. monochromator.



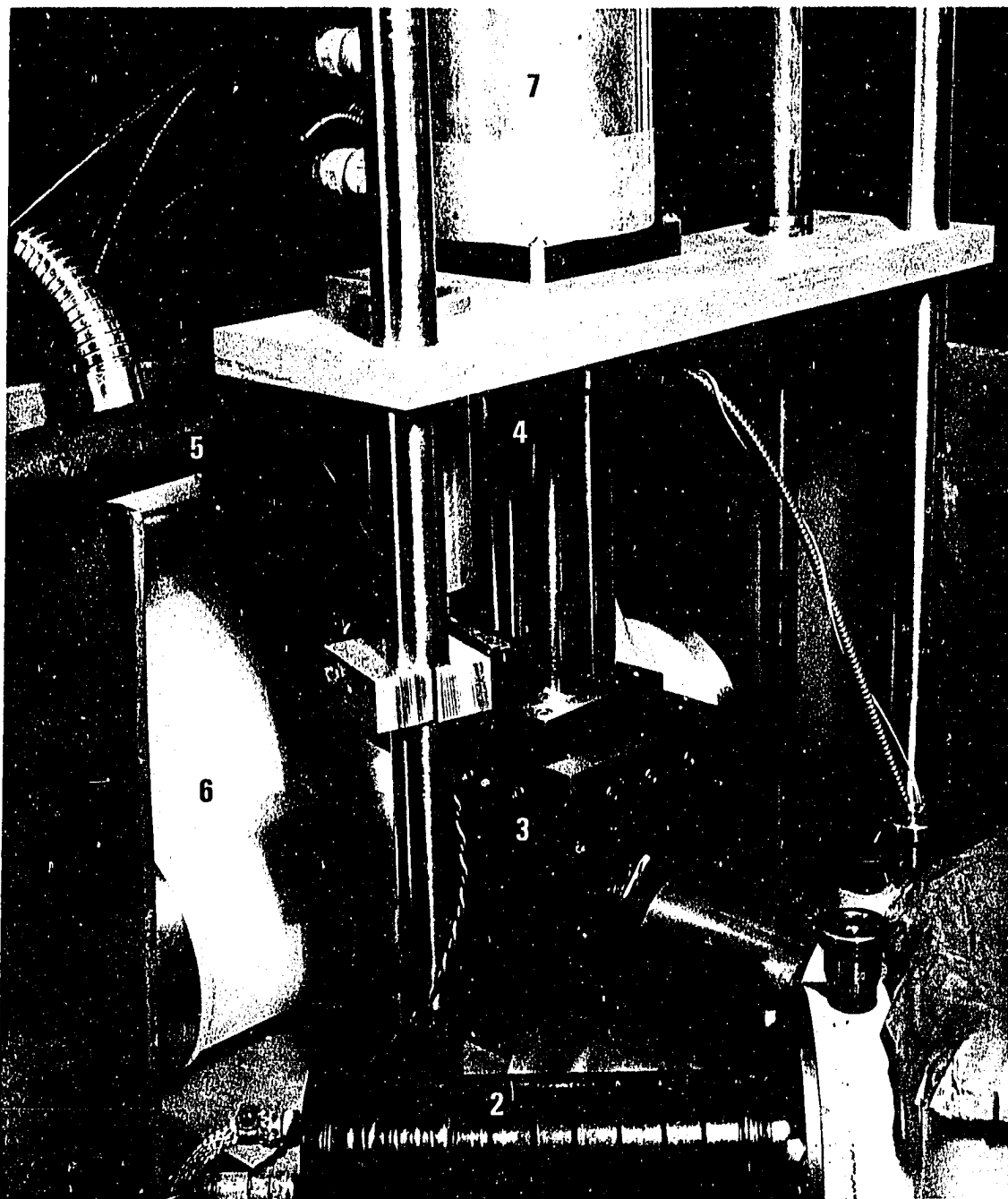


Figure 3. Photograph of the pulsed XEOI system with the cryostat inserted into the vacuum shield. The numbered components are: 1. monochromator, 2. photomultiplier tube in housing, 3. brass sample chamber, 4. vacuum shield, 5. vacuum line, 6. x-ray tube and 7. cryostat (mechanical end).

Table 1. Principal Components of Pulsed XEOL SystemX-ray Sources

DC x-ray power supply	Operated at 50 kV. and 40 mA. Water cooled Maximum 60 kV. 60 mA. (General Electric Corp., Milwaukee, WI Model XRD-6)
DC x-ray tube	Tungsten target Water cooled anode Emission of x-rays from 0.1 nm. to 0.02 nm. (General Electric Corp., Milwaukee, WI Model EA-75X)
Pulsed x-ray power supply	Medical x-ray unit Thyratron pulse circuits modified for computer control (Westinghouse Electric Corp., Greenville, PA)
Pulsed x-ray tube	Medical x-ray tube Operated at 60 kV. 100 mA. using large filament Rotating anode Conduction cooled (The Machlett Laboratories Inc., Stamford, CT)

Spectroscopic Equipment

Monochromator	Scanning 0.3 meter Crossed Czerny Turner mount (McPherson Instrument Corp., Acton, MA, Model No. 218)
Detector	EMI 6256B photomultiplier S-13 response (EMI Gencom Inc., Plainview, NY)
High voltage power supply	Operated at 1200 VDC (NJE Corp., Kenilworth, NJ, Model S-325)

Table 1. (Continued)

External optics	Precision grade quartz lens 1 inch diameter 2 inch focal length (Corion Instrument Corp., Waltham, MA)
Amplifier	Fast current amplifier with adjustable rise time and zero suppression (Keithley Instruments, Cleveland, OH, Model 427)
Recorder	Two pen voltage recorder (Houston Instruments, Austin, TX, Model 5210-5)

Refrigeration and Vacuum Equipment

Helium refrigerator	Helium refrigerant Temperature selectable from 10 K to 360 K with 1 degree resolution (Air Products and Chemicals Inc., Allentown, PA, Model CSA-202)
Diffusion pump	2 inch air cooled (NRC Equipment Co., Newton, MA)
Floor pump	(The Welch Scientific Co., Skokie, IL, Model 1397)
Vacuum gauge	(National Research Corp., Cambridge, MA)

Computer and Interfaces

Computer	PDP8/E minicomputer (Digital Equipment Corp., Maynard, MA)
Control interface	See text
Data interface	(Heath Co., Benton Harbor, MI)

Table 1. (Continued)


---

Buffer	(Heath Co., Benton Harbor, MI)
Analog to Digital Converter	(Redcor Corp., Woodland Hills CA)
Teletype	(Teletype Corp., Skokie, IL, Model-33)

---

replaced to accommodate either a DC or pulsed x-ray tube. The x-ray tubes are positioned to minimize the distance from the anode to the vacuum, because air can severely attenuate the x-ray beam. Figure 3 shows the brass chamber with the pulsed x-ray tube attached and the refrigerator inserted.

The control interface was designed by G. Holland of Ames Laboratory Instrumentation Group and built by technicians in the same group. A simplified circuit diagram of the interface is presented in Figure 4. The interface instructions which control the operation of the x-ray source are indicated on the diagram. The flip flops are equivalent to toggle switches. The AND gates test two computer conditions before allowing pulses to reach the x-ray supply. A second circuit in the control interface generates timing pulses from the line voltage. The simplified circuit is drawn in Figure 5. The two operational amplifiers act as comparators. The voltage dividers, connected to the noninverting inputs, are used to fine tune the phase relationship between the x-ray

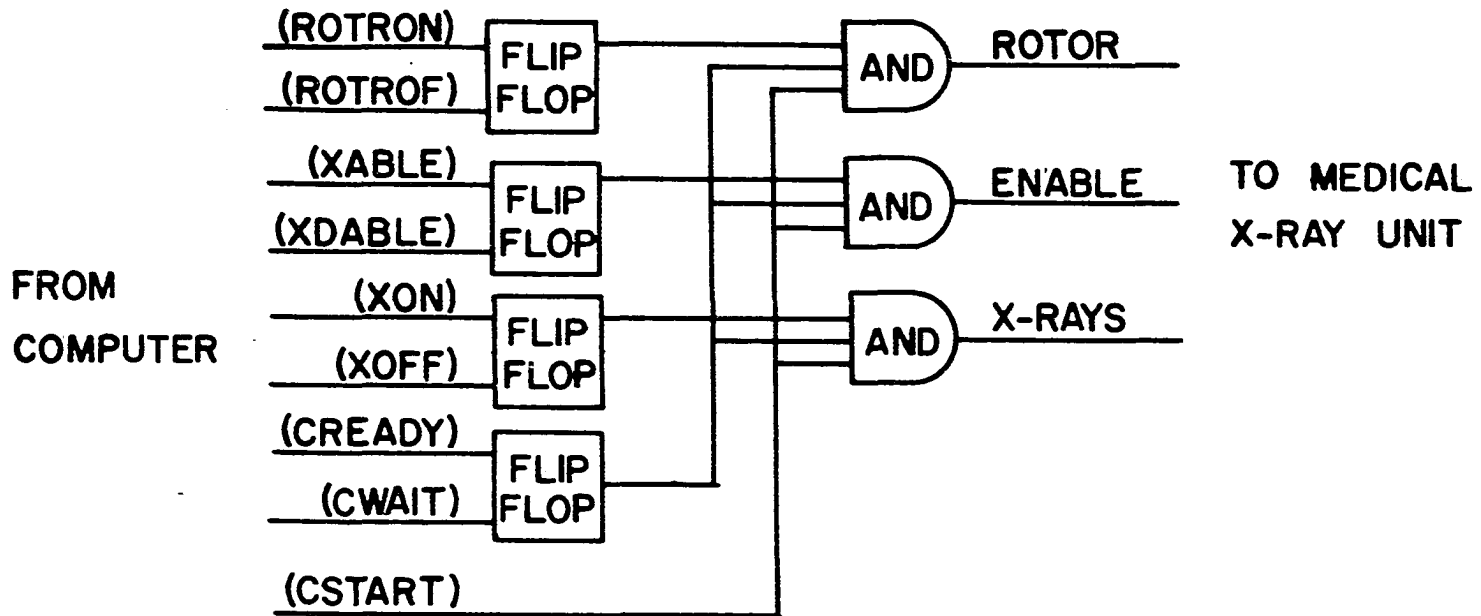


Figure 4. Simplified circuit diagram of the control interface. Interface commands are indicated in parentheses.

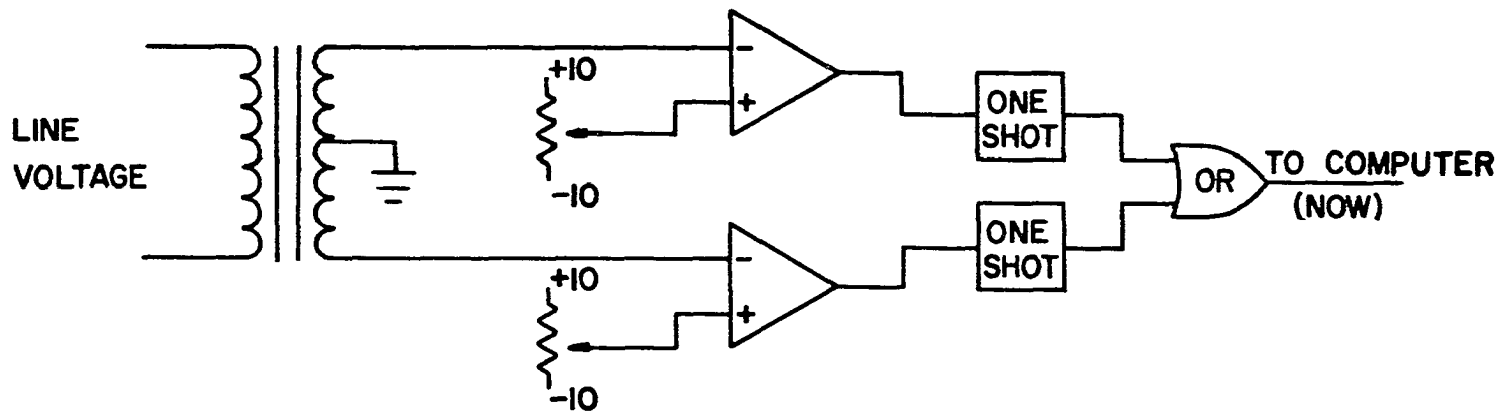


Figure 5. Simplified circuit diagram of the circuit used to generate timing reference pulses.

supply and the timing pulses. The gated integrator, also designed by G. Holland, is an operational amplifier with a feedback capacitor and several input resistors. The circuit board is contained in the control interface chassis. The simplified circuit is drawn in Figure 6. Three input resistances were included to attenuate the input voltage. The integrator is operated with two interface instructions shown on the diagram. All interface instructions, their octal values and functions are summarized in Table 2.

Table 2. Interface Instructions

<u>Instruction</u>	<u>Octal Value</u>	<u>Function</u>
CREADY	6337	Enable control interface
CREADY	6331	Open communication lines
CWAIT	6336	Close communication lines
NOW	6332	Timing pulse
ROTRON	6341	Turn rotor on
FOTROF	6342	Turn rotor off
XABLE	6343	Enable x-ray supply
XDABLE	6344	Disable x-ray supply
XON	6333	Turn x-rays on
XOFF	6334	Turn x-rays off
INBOX	6346	Initialize integrator
STBOX	6345	Start integrator
GETDAT	6354	Transfer data
STATOD	6455	Start A to D conversion
INATOD	6455	Initialize A to D converter

### Computational Facilities

The data, produced by the pulsed XEOL system, is processed by PL/1 and FORTRAN IV programs. These programs are

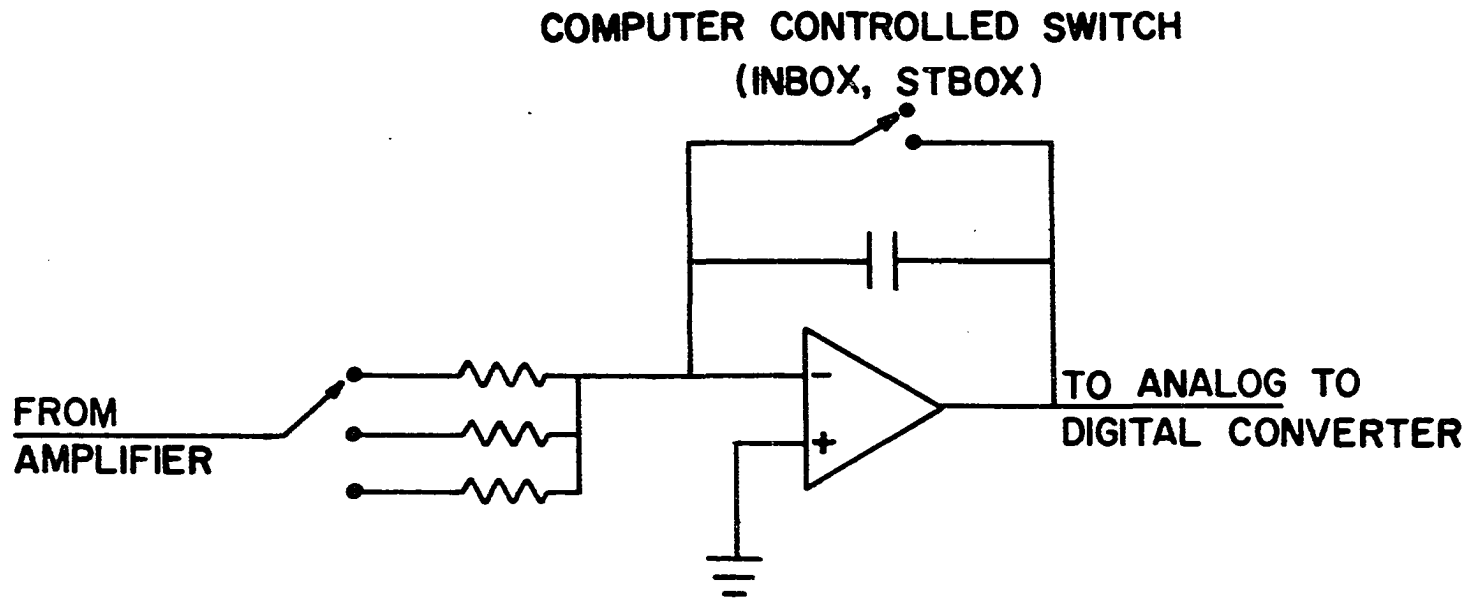


Figure 6. Simplified circuit diagram of the gated integrator. Control instructions are indicated in parentheses.



executed on the IBM 360/65 and ITEL AS/5 computers in the Iowa State University Computation Center. The PL/1 program was written to plot decay curve data using Simplotter (52) and to produce an input data set in the proper format for the FORTRAN IV program, called SMASH (53). SMASH was developed by the neutron activation analysis group at Ames Laboratory to separate complex decay curves and was modified for the present study to handle spectroscopic data. Listings of the PL/1 and SMASH programs appear in Appendix 1 and Appendix 2 respectively.

A conversational system, known as WYLBUR, makes operator interaction with the data processing system possible. WYLBUR was accessed over telephone lines located in our research area. A Decwriter II (Digital Equipment Corp. Maynard, MA) and Teletype (Teletype Corp., Skokie, IL, Model 35) were the devices used to communicate instructions to WYLBUR. WYLBUR is a text editing program with remote job entry and execute file capabilities supported by the Iowa State University Computation Center. The text editing features facilitate program writing and the remote job entry feature simplifies the debugging process. After the paper tape data set is transferred to the computer system, a WYLBUR execute file is used to generate a control data set for the PL/1 program and to create a system job composed of job control language, program listings and data. WYLBUR submits the job to the

system and the results are printed in the computation center.

Another facility available at the Iowa State University Computation Center for displaying graphical data is Simplotter. Simplotter is a FORTRAN program, developed at Ames Laboratory, for general plotting requirements. Simplotter was used to display decay curves, calibration curves and other general data. A PL/1 program was written to access Simplotter directly to plot simple data sets while WYLBUR was used to generate the data set with the proper format. A listing of the WYLBUR execute file and PL/1 program is given in Appendix 3.

The computational facilities, available through the Iowa State University Computation Center, made the time resolution experiment possible. The separation of complex decay curves by a least squares method using a digital computer is a routine exercise. Without the least squares method we would have limited our resolution to simple two-component systems because graphical methods would have been employed. Our ability to use mathematical techniques, such as the SMASH routine, made it possible to extend time-resolved spectroscopy to mixtures with more than three components.

## CHAPTER 3: PULSED XEOL SYSTEM

The pulsed x-ray excited optical luminescence system is shown as a block diagram in Figure 7. At the heart of the system is a dedicated minicomputer. The stringent timing requirements for x-ray pulse generation and the careful measurement of integration periods during data acquisition required the use of a dedicated computer. Human interaction with the system occurs at the teletype where input is typed at the keyboard and output is generated at the punch as paper tape. The assembly language program which generates the x-ray pulse, controls the data acquisition system and handles input and output information is listed in Appendix 4.

The computer interacts with the system through two interfaces. The data interface is used to transfer digital data from the analog-to-digital converter to the computer memory where it is stored until output is punched. The control interface connects the computer, the x-ray supply and the integrator. Timing reference pulses are produced in the control interface.

The excitation source in the luminescence system is a modified medical x-ray unit. The x-ray supply can produce a maximum voltage of 150 kV. across the x-ray tube and a maximum current of 300 mA. through the x-ray tube. The x-ray tube is a rotating anode, medical x-ray tube which is cooled by conduction.

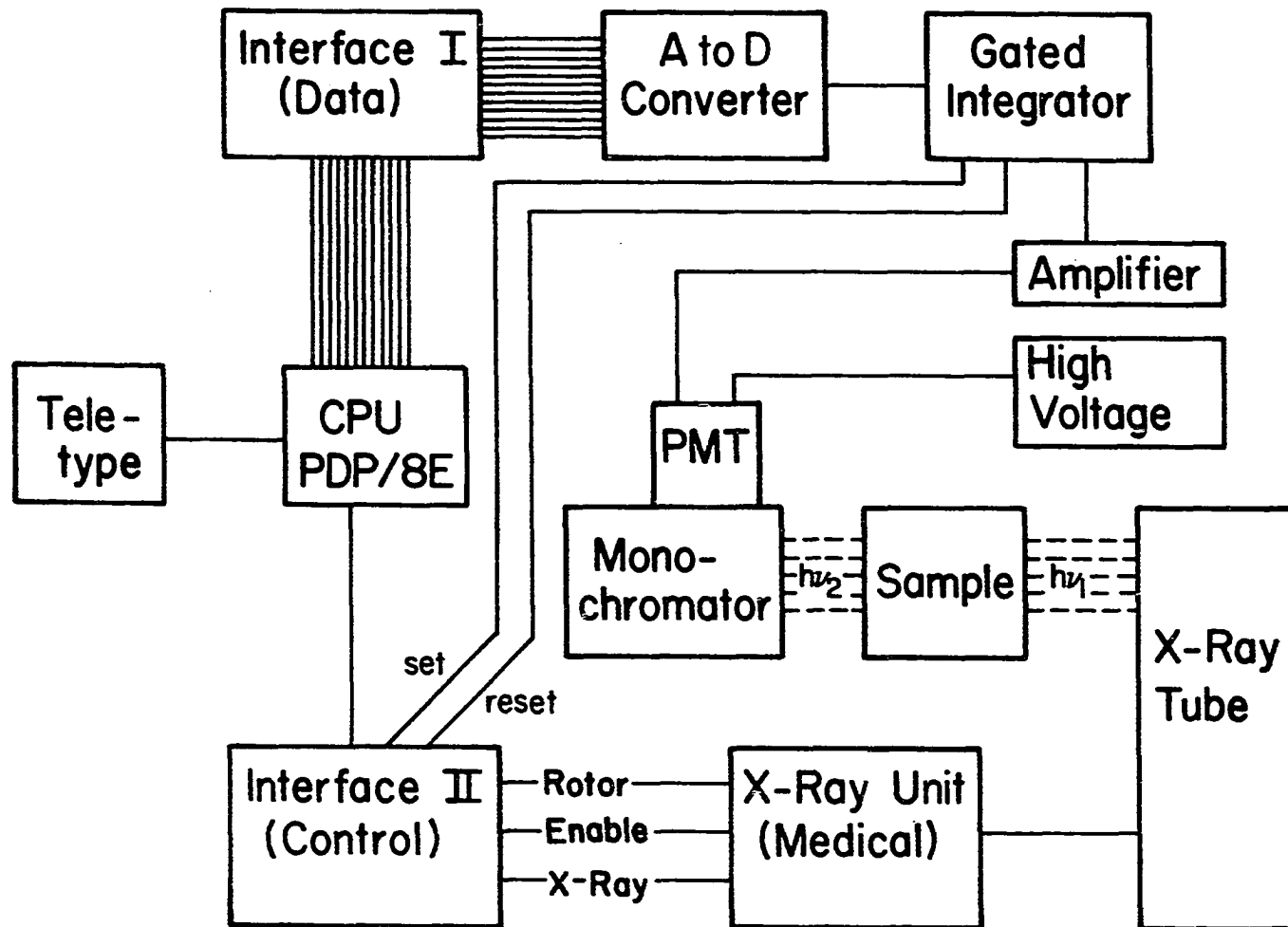


Figure 7. Block diagram of the pulsed x-ray excited optical luminescence system.

Three control signals are required to pulse the x-ray source. First, the rotating anode must be started. The rapid rate of rotation prevents excessive heating of localized areas of the anode surface and subsequent sputtering and pitting. Next the x-ray supply must be enabled. Under normal operation the enable function would produce x-rays. Finally, a gate pulse signals the power supply to release the thyatron switches and activate the x-ray tube for the duration of the pulse.

During the on period of the x-ray pulse, the sample, typically PAHs dissolved in n-heptane at 10 K, is excited. At termination of the x-ray pulse some initial activity exists and decays exponentially. The emission is collected by a lens, dispersed with a monochromator and detected by a photomultiplier tube. The photomultiplier tube current is amplified by a fast response (typically 1-10 msec.) current amplifier and a voltage signal results.

The gated integrator sums the voltage signal for a predetermined period and is reset. Prior to the reset command, the integrator output is sampled and an analog-to-digital conversion is performed. After the integrator is reset the process is repeated until the number of data points, specified by the operator, is obtained. The luminescent decay is characterized by the sequential data points. The timing relationship between the x-ray pulse and

the integration of the voltage signal is precisely controlled by the minicomputer. The digital data are transferred to computer memory where luminescent decay from subsequent x-ray pulses can be added. The signal averaged data are punched on paper tape and analyzed on the Iowa State University Computation Center facilities.

In the following sections detailed explanations of the operation of different phases of the pulsed, x-ray excited, optical luminescence system are presented. The principles of x-ray pulse generation are outlined. The control of the sample temperature and the containment of the sample are described. The data acquisition options are presented and the section on data analysis follows the data after they are punched on paper tape to the final results. Finally, some consequences of the pulsing technique are discussed in the section on x-ray pulse characteristics.

#### X-ray Pulse Generation

The first attempt to produce an x-ray pulse involved a high voltage grid in the x-ray tube which could deflect the electron beam away from the anode. Before implementing the grid approach, the x-ray emission of the DC supply was characterized. A liquid scintillator was irradiated and the response was observed with an oscilloscope. A typical oscilloscope tracing is depicted in Figure 8. A full-wave

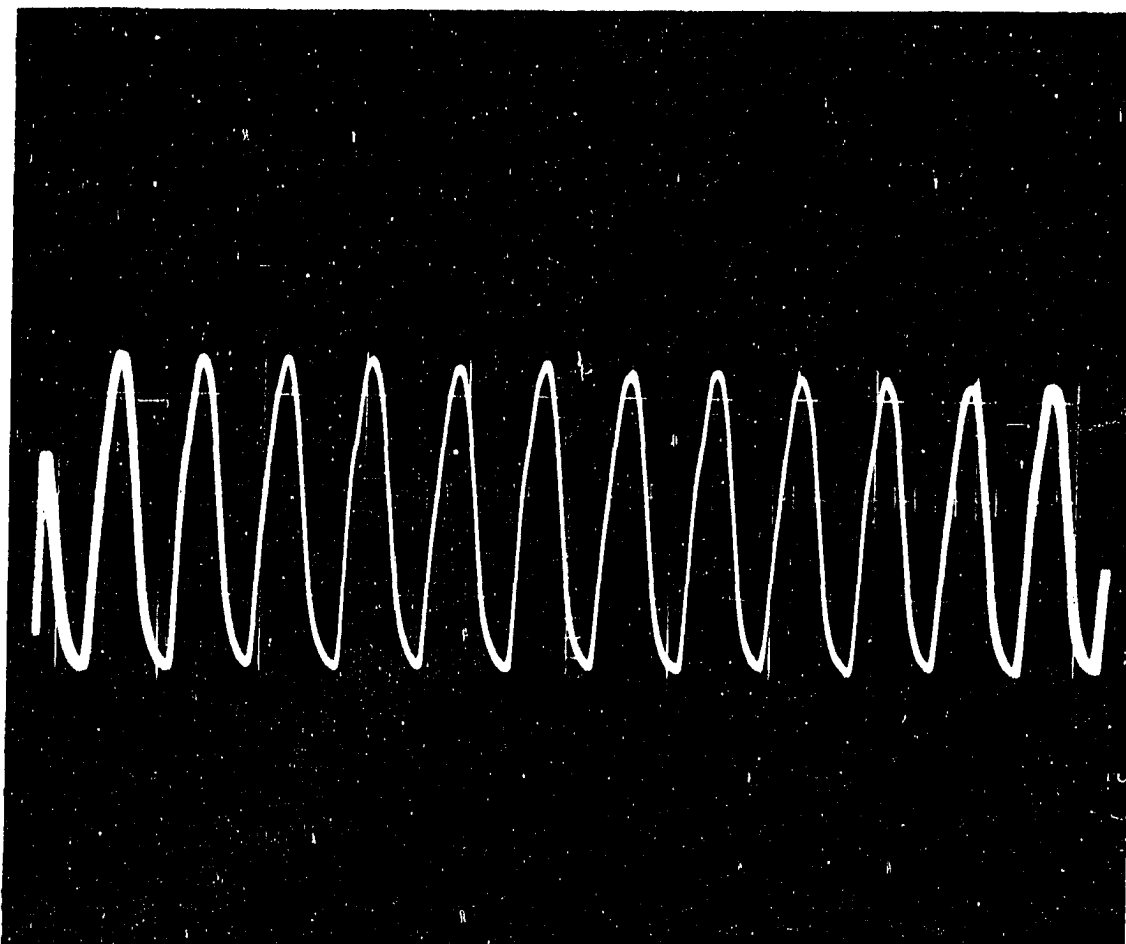


Figure 8. Oscilloscope tracing of the amplifier signal produced by a photomultiplier tube in response to a fast scintillator (perylene in n-heptane) excited by a DC x-ray source. Horizontal scale is 10 msec./cm. and vertical scale is 2 volts/cm.

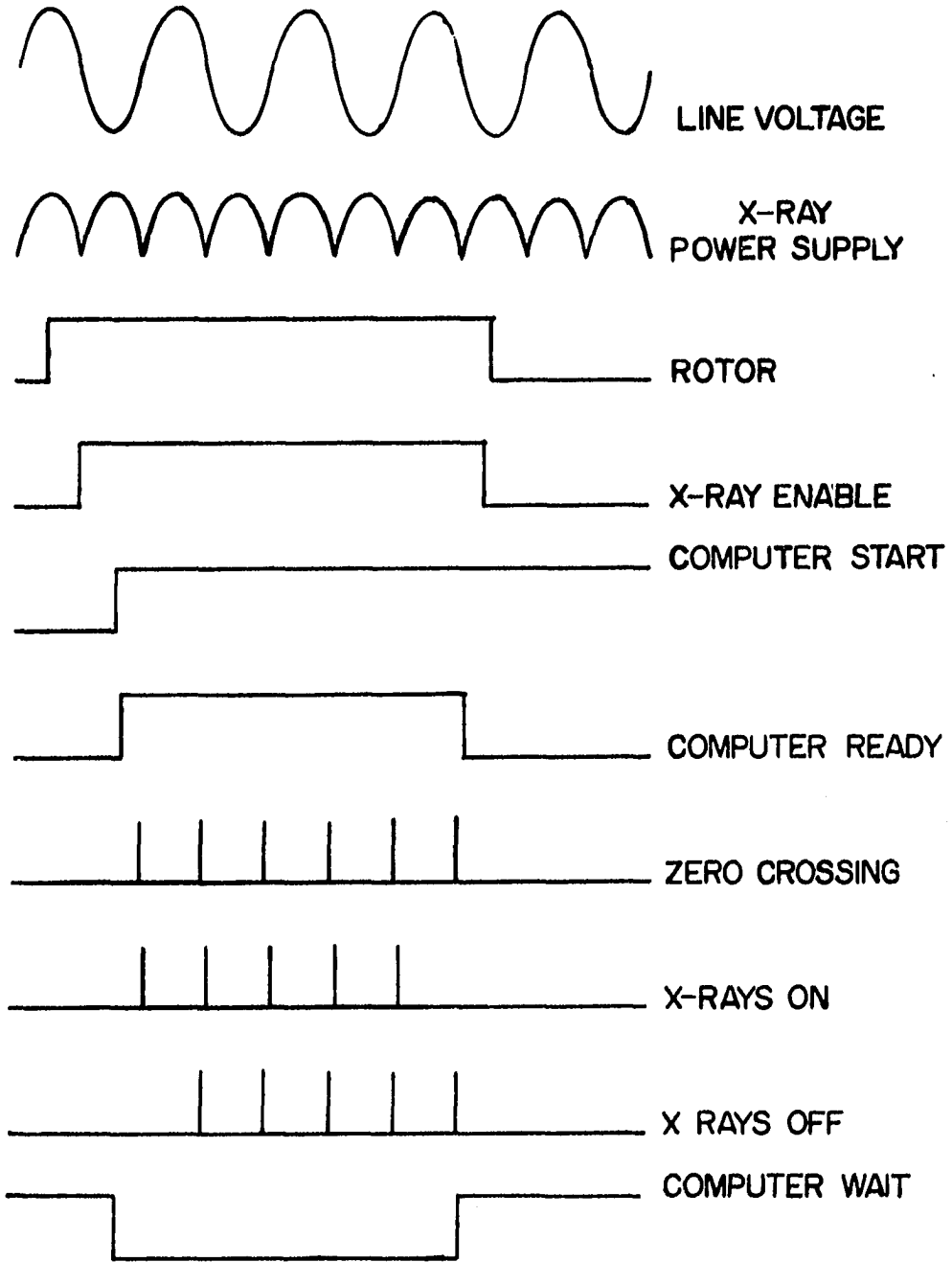
rectified sine-wave with a frequency of 120 cycles per second was observed. The sine waveform and not a DC level was observed because manufacturers of x-ray equipment do not filter the voltage supply which powers the x-ray tube. The size of the capacitors and resistors that are required to filter kilovolt voltage levels are prohibitive. The switch-selectable voltages and currents on x-ray sources are root-mean-square values and represent the DC average of the waveform. The grid approach was abandoned and advantage was taken of the inherent pulsed nature of a DC x-ray supply. If the medical x-ray supply could be turned on at a zero point in the waveform and off at a later zero point, an x-ray pulse which is a multiple of 1/120th of a second in length could be produced.

To generate such an x-ray pulse required precise determination of zero points in voltage waveforms, such as the one shown in Figure 8. A computer was used to control the pulse generation. Because the computer could not monitor the voltage waveform of the medical x-ray unit directly, a virtual link between the computer and the x-ray unit was established with the control interface. The line voltage which powered the control interface was used to produce timing reference pulses every time the line voltage went to zero. Because the entire United States is on the same power grid the timing reference pulses differed from the zero



points of the voltage waveform in the medical x-ray supply by a simple phase relationship. An oscilloscope was used to synchronize the timing reference pulses and the zero points in the voltage waveform with the phase adjustments in the control interface.

Normal operation of the medical unit required two steps to produce x-rays. After the thyatron switches were modified to function under computer control, three steps were required. The rotor had to be started, the x-ray unit had to be enabled, which produced x-rays in normal operation, and the thyatron switches had to be gated. The sequence of events in production of a typical x-ray pulse is shown in Figure 9. After the rotor was started and the x-ray unit was enabled, the computer start command enables the control interface. The computer ready command released the timing reference pulses. At the first zero point the x-rays were turned on and at the next zero point the x-rays were turned off. If a longer excitation period was required, the process was repeated until the number of waves, as specified by the operator, occurred. Variable length excitation periods from 1/120th of a second to several seconds could be produced. The maximum length of x-ray excitation period was limited by the voltage, current and time product which determined the electrical power the x-ray tube had to dissipate as heat.



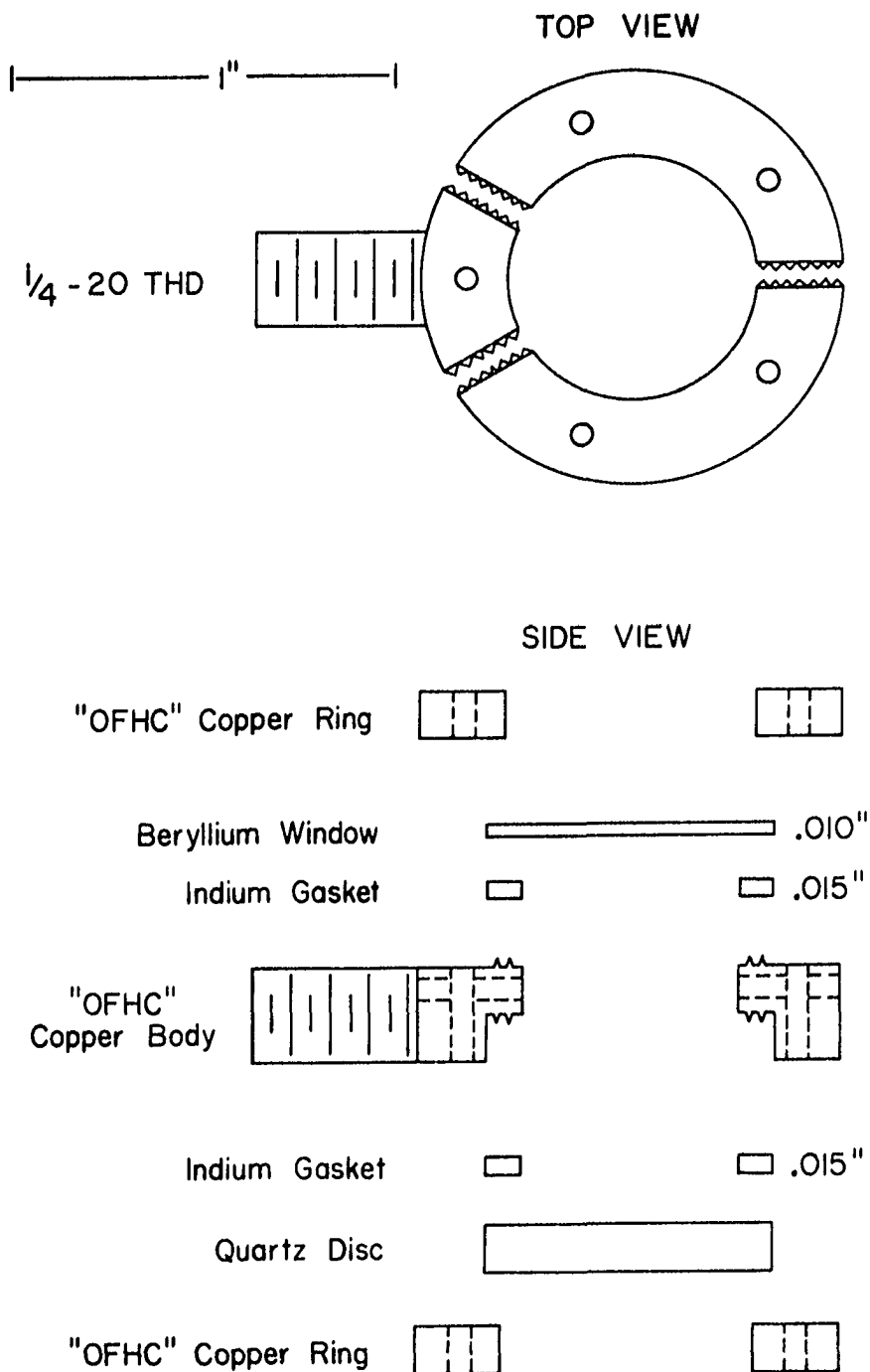
**Figure 9. Timing diagram which illustrates the time relationship and sequence of events in the production of a typical x-ray pulse.**

## Refrigeration and Optical Systems

The pulsed XEOL system was developed to study a variety of samples over a large temperature range. A refrigeration system with the flexibility to study solids, liquids and gases at temperatures in the range from liquid helium to boiling water was desired. A helium refrigerator (see Table 1 for details) was purchased and incorporated in the pulsed XEOL system. The helium refrigerator was a two stage cryostat which worked on the Solvay process and provided the capability of examining the spectra of solids, liquids and gases at thumb-switch-selectable temperatures ranging from 10 to 360 K with 1 K resolution.

Unfortunately, the helium refrigerator presented its own problems. Because the vacuum used to insulate the cryostat from the surroundings prohibited the use of conventional XEOL sample handling techniques, a sample holder which could contain the sample in a vacuum, allow x-rays to irradiate the sample and transmit the optical radiation was designed. The materials problems encountered in designing the sample holder with the specifications mentioned above required a change from the conventional geometry used in an XEOL experiment.

The sample holder used in this study is sketched in Figure 10. The body of the sample holder was made of oxygen-free high conductivity (OFHC) copper. The quarter-twenty thread attaches the holder to the cryostat.



**Figure 10. Sample holder used with the pulsed XEOL system. Main body and retaining rings were fabricated from oxygen free high conductivity copper.**

An indium washer was placed between the cryostat and the holder to compensate for expansion and contraction effects and to insure that thermal contact was made between the cryostat and the sample holder. The sample was held between a beryllium window and a fused quartz disc. Both the window and the disc were sealed to the holder with OFHC copper retaining rings and indium gaskets. Indium gaskets were used because of the ductility of indium at 10 K. Also, 0.2 mm. (0.008 in.) indium gaskets replaced the thicker gaskets shown in Figure 10 because less indium was smeared into the sample holder. The sample was injected into the holder with a syringe through the filling ports. The ports were threaded and sealed with number two screws and indium gaskets. The holder was emptied by removing two of the three number two screws.

A "straight-through" geometry was used with the sample holder described above. The optical diagram is shown in Figure 11. Advantage was taken of the penetrating ability of x-ray radiation and the crossed Czerny-Turner mount of the monochromator. The x-ray cross section of capture for carbon and hydrogen is small so the x-ray beam is not significantly attenuated by a hydrocarbon sample, therefore, the x-ray beam and the luminescence proceed into the monochromator. At the collimating mirror the optical signal is reflected to the grating but the x-ray radiation passes through the mirror and is absorbed by the lead shielding which surrounds the

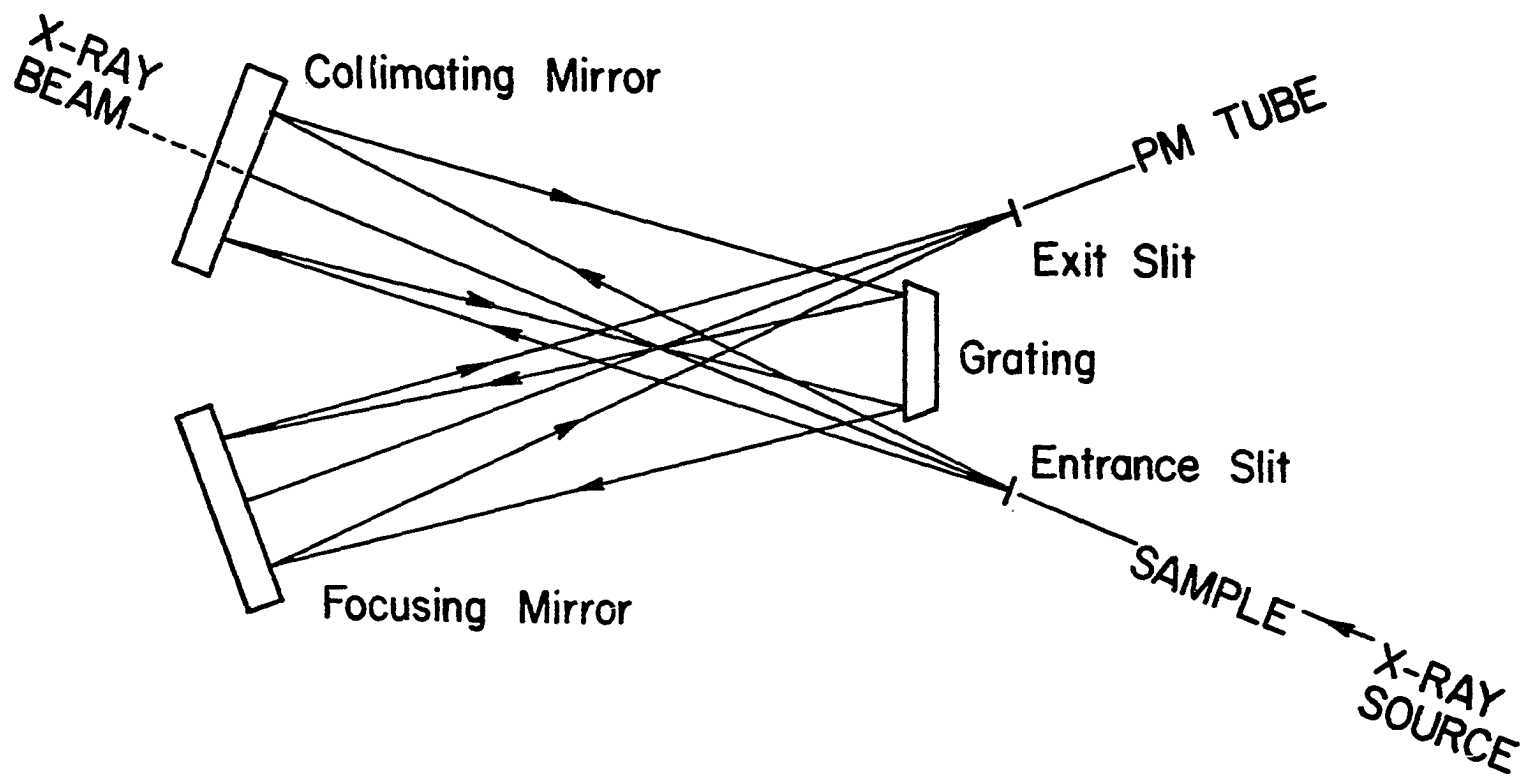


Figure 11. A schematic diagram of the optical system designed around the crossed Czerny-Turner mount of the McPherson monochromator used in the pulsed XEOL system.

monochromator. The optical signal is dispersed at the grating and proceeds to the photomultiplier tube where it is detected. Scattered x-ray radiation does not enter the photomultiplier tube to produce noise because the photomultiplier tube is positioned off the primary optical axis.

### Data Acquisition System

The major objective for construction of the pulsed XEOL system was to obtain decay curve data. The large x-ray flux available with a pulsed source represents an advantage over the DC sources, hence a secondary objective was to obtain pseudo-DC data. The major instrumental components of the data acquisition system were the gated integrator, the analog-to-digital converter and the data interface. The heart of the system, however, was the software which controlled the gated integrator. The software was written to make the data acquisition system operate in one of two modes, a fast mode or a slow mode.

In the fast mode, pseudo-DC data was obtained. The fast mode was used to study fluorescent single component emission. The integrator was started at the zero point of the x-ray wave and reset at the next zero point. The luminescence produced by a single x-ray wave was integrated and the voltage output of the integrator was considered the average

DC level of the luminescence. To improve the signal-to-noise ratio and the statistical values of the data several successive waves could be integrated during an extended pulse and the data of several pulses could be summed to signal average the noise. A mean and standard deviation were calculated and used as an average DC value for subsequent analytical calculations.

In the slow mode, decay curve data were obtained. There were two algorithms for sampling an exponential decay. The first algorithm involved integration of the entire decay curve and periodic sampling of the integrator output. A numerical differentiation generated the original decay curve. The second algorithm divided the decay curve into equal time segments. Each time segment was integrated and the voltage output was plotted as a function of time to obtain the decay curve. The second approach was used because the individual integrations "signal averaged" the noise to a constant value which could be subtracted from each data point and enhanced signal-to-noise ratios as compared to the discrete sampling algorithm resulted.

Three integration periods (1000, 100 and 10 msec.) were programmed for the gated integrator, so that a large range of decay constants could be studied. The reset time of the integrator was 1 millisecond, hence a small percentage of the signal is lost. To illustrate, use of the 10 millisecond



integration period means 10 percent of the signal was lost during the reset time whereas with the 1000 millisecond integration period, only 0.1 percent of the signal was lost. The same "real-time" must be integrated to obtain equivalent signal-to-noise ratios if different integration periods are used. For example, if 10 decay curves are summed using the 1000 millisecond integration period then 100 decay curves have to be summed using the 100 millisecond integration period and 1000 decay curves have to be summed using the 10 millisecond integration period to obtain equivalent signal-to-noise ratios.

In both modes the data acquisition system proceeded in several steps. The analog signal from the fast response current amplifier was integrated according to the algorithm of the mode. The integrator output was digitized by the analog-to-digital converter in 20 microseconds. The digitized signal was passed to the computer through the data interface in a parallel transmission. The data was temporarily stored in the computer until output was punched and then the paper tape was processed by the large computer system as described in the next section.

### Data Analysis

The pulsed XEOL system generated large quantities of numerical data in either mode of operation. To process these

data, sophisticated computational facilities were needed. Furthermore, the time resolution experiment was dependent on a numerical characterization of simple or complex decay curves. The statistical techniques needed to characterize the decay curves were ideally suited for computer analysis. For these reasons it was necessary to accumulate data with the minicomputer but process the data on a more sophisticated computer system.

The Iowa State University Computation Center operates an IEM 360/65 and an AS/5 computer system. PL/1 and FORTRAN IV are among the many languages supported by the system. An interactive system, known as WYLBUR, is also available. WYLBUR, PL/1 and FORTRAN IV were used extensively for the analysis of the numerical data.

The paper tape data set generated by the assembly language program contained control information used in the assembly language program and the numerical data collected from the experiment. The data set was transferred to the large computer and stored on disc. WYLBUR was used to construct a job which calculated the experimental results. If the fast mode was run the job contained only a PL/1 program which read the data from disc and calculated a mean and standard deviation. The results were printed with a data dump of the important control variables. If the slow mode was run, the job contained a PL/1 program and a modified FORTRAN IV

program. The PL/1 program read the data from disc and plotted the decay curve using Simplotter. The data dump was generated and an output data set was created which was the input for the FORTRAN IV program, called SMASH. SMASH either calculated a decay curve by a direct-search method or used a linear least squares procedure to calculate initial activities of the luminescence. The results of the SMASH program were printed by the output routines contained within the program.

After the data analysis job was completed, the output was retrieved from the Iowa State University Computation Center. The results were extracted from the printed material. If wavelength or concentration plots were desired, another job could be created with a WYLBUR execute file and PL/1 program, which generated a computer plot with Simplotter. Analytical data were calculated with a hand calculator.

All the programs mentioned in this section are listed in Appendices 1-4. The PL/1 programs were written specifically for this study but the SMASH program was borrowed from the neutron activation analysis group and the input routine was modified to facilitate operation of the program. The job control language which regulates execution of the job is listed in Appendix 5. The WYLBUR execute file which created the job is listed in Appendix 6.

## X-ray Pulse Characteristics

The method used to generate the x-ray pulse limited the range of the time resolution experiment. The limitation is manifest by a differential equation which relates the number of excited molecules as a function of time to a supply term and a depletion term. The relation is expressed in equation 1;

$$N' = S*F - k*N \quad (1)$$

where N represents the number of excited molecules as a function of time, S is the cross section for capture of an x-ray photon, F is the driving function or functional form of the excitation source (  $F = \sin(\omega t)$  ) and k is the decay constant of the excited molecule. The equation holds only while the x-ray pulse is active. The solution is given in equation 2;

$$N = S[k*\sin(\omega t) - \omega*\cos(\omega t)] / [k^2 + \omega^2] \quad (2)$$

Three cases are considered to simplify the form of the solution. If  $k \gg \omega$ , which corresponds to phosphorescent emission, then equation 3 results;

$$N = (S/\omega) \cos(\omega t) \quad (3)$$

As the x-ray pulse (  $\sin(\omega t)$  ) goes to zero, the number of excited molecules goes to a maximum and an initial activity

exists after the x-ray pulse. If  $k \ll \omega$ , which corresponds to fluorescent emission, then equation 4 results:

$$N = (S/k)\sin(\omega t) \quad (4)$$

Now, as the x-ray pulse goes to zero so does the number of excited molecules and no initial activity exists after the x-ray pulse. Finally, if  $k \approx \omega$  then no simplification of the equation is possible. Some initial activity does exist after the x-ray pulse but the decay is severely distorted by the shape of the excitation pulse. Fourier techniques are used to deconvolute the data and extract the decay curve.

To summarize the three cases, with the x-ray pulse used in the present study the time resolution experiment was limited to phosphorescent emission. Fluorescent emission could not be time resolved but was studied by observation of single component emission with the pseudo-DC mode. No intermediate decay curves were observed from the PAHs studied, but as the scope expands to include other types of organic compounds it will be necessary to develop the Fourier techniques to deconvolute the data.

## CHAPTER 4: EXPERIMENTAL PROCEDURES

## Preparation of Chemicals, Solvents and Solutions

All of the PAHs used in the XEOL study are listed in Table 3. The PAHs were purified by zone refining or vacuum sublimation as indicated in the table. The crude PAHs were sealed in a glass tube under a partial pressure of helium and melted before being zone refined. A minimum of five passes on a ten-stage zone refiner were used to purify the PAHs. The zone refined tubes were scratched with a file and broken in thirds. The top and bottom thirds of the tube were discarded and the middle third was retained. The PAHs were chipped and scraped from the glass tube when needed for solutions. To vacuum sublime coronene and benzo-ghi-perylene, the two compounds were sealed individually in a vacuum under a water-cooled glass probe. A mineral oil bath was used to sublime the PAHs which subsequently condensed on the glass probe. The glass probe was removed from the vacuum and the PAH was scraped from the surface and stored for later use. Vacuum sublimation was used because too little starting material was available for zone refining. Only naphthalene and fluorene were used as received.

On the basis of their XEOL spectra, seven of the PAHs were used as model compounds for the time resolution experiments. Triphenylene, coronene, chrysene, phenanthrene,

fluoranthene, naphthalene and fluorene exhibited phosphorescent emission. Perylene and 3,4-benzopyrene were used as model compounds for the single component fluorescent experiments.

Table 3. Polynuclear Aromatic Hydrocarbons

<u>Compound</u>	<u>Purity</u>
Naphthalene	As received
Anthracene	Zone refined
Phenanthrene	Zone refined
1,2-Benzanthracene	Zone refined
Pyrene	Zone refined
Chrysene	Zone refined
Triphenylene	Zone refined
1,2,5,6-Dibenzanthracene	Zone refined
3,4-Benzopyrene	Zone refined
Perylene	Zone refined
Benzo-ghi-perylene	Vacuum sublimed
Coronene	Vacuum sublimed
Fluorene	As received
Fluoranthene	Zone refined

Three n-alkane solvents were used, n-hexane, n-heptane and n-octane. The solvents were distilled and passed through a cation exchange resin in the silver form to remove the last traces of aromatic impurities. A weak bond is formed between the silver cation and the pi bond of the aromatic system. If the price of the solvents should become prohibitive the purification procedure can be used to recycle the n-alkane solvents. Gas chromatographic analysis of the purified solvents revealed the only contaminants were trace amounts of

isomeric aliphatic hydrocarbons.

Stock solutions of the PAHs were prepared in volumetric flasks from weighed quantities of purified PAHs. Concentrations ranged from 0.01 M to 0.0001 M. Solubility limited the maximum concentration for several PAHs. PAHs which dissolved slowly were equilibrated overnight or vigorously stirred by an ultrasonic cleaner. Concentrated stock solutions were prepared to minimize adsorption and decomposition effects commonly observed with very dilute solutions. All stock solutions were stored in the dark to avoid photodecomposition. Dilute solutions were prepared as needed on a day-to-day basis from the stock solutions. No successive dilutions were performed to minimize pipetting errors.

#### Time Resolved Spectroscopy

The principles of time resolved spectroscopy are based on the radiative lifetimes of excited molecules. The functional form of the time dependence of single component luminescence is given in equation 5:

$$I(t) = I(0) \exp(-kt) \quad (5)$$

$I(t)$  is the emitted intensity as a function of time,  $I(0)$  is the initial intensity at the termination of the excitation pulse,  $k$  is the decay constant of the excited species and  $t$



is the time. If many species are emitting simultaneously the time dependent intensity is expressed by equation 6:

$$I(t) = \sum_i I(0)_i \exp(-k_i t) \quad (6)$$

The total intensity is the sum of the intensities of all the emitting species.

The time resolution experiment is divided into two phases. First, decay curves are obtained from the individual luminescent species and decay constants are determined by substitution of the data into equation 5. Second, decay curves from mixtures of luminescent species are collected. The decay constants, determined from single component decay curves, are substituted into equation 6 and the initial intensity of each component is calculated. Finally, the initial intensities are related to the concentration of the luminescent species in the sample.

To prepare either phase of the time resolution experiment the steps listed in Table 4 are performed. After the preparations are completed, the experiment is initiated by operator interaction with the minicomputer. The step by step operation of the minicomputer is described in Table 5.

After the experiment is completed and the paper tape data set is transferred to disc, WYLBUR is used to prepare a job which processes the data. If a decay constant is sought certain conventions are followed. A preliminary job is

Table 4. Stepwise Preparation of Pulsed XEOL System-----

1. Inject the sample into the holder and seal the holder with indium gaskets and number two screws (Approximately 1.0 ml. of sample is needed to fill the holder).
2. Attach the holder and radiation shield to the cryostat and insert the cryostat into the vacuum shield.
3. Connect the vacuum line and pull a vacuum on the contents of the vacuum shield.
4. Start the refrigerator and wait for the sample to cool.
5. Turn on the medical x-ray unit and select the current and voltage for the x-ray pulse (typically 60 kv., 100 mA.).
6. Make certain the slits are opened (typically 1000 micrometers), the monochromator is tuned to zero order and the photomultiplier tube is on (typically 1200 volts).
7. Turn on the computer power key and the teletype.-----

created which generates a plot of the decay curve. An estimate of the half life is made from the decay curve by measuring the time the intensity drops to one half the initial value. The decay constant is equal to 0.693 divided by the half life. A second job is generated which contains SMASH. The estimate of the decay constant is input into SMASH as a negative number. The negative estimate signals SMASH to perform a direct search for the decay constant. The initial estimate is used to calculate a maximum value for the quality of fit. A search vector is followed and the value for the quality of fit is minimized as the search vector proceeds to

the final value of the decay constant. At the completion of the calculation output is generated which lists the initial data and the calculated fit with the estimated decay constant and with the final decay constant.

Table 5. Minicomputer Operation-----

1. Load the assembly language program into memory if the program is not already present in memory (Consult the operations manual).
2. Depress all address switches and press the extended address load switch.
3. Load 200 octal into the address switches and press the address load switch.
4. Place the halt switch in the up position, press the clear switch and the continue switch (The teletype should print a message).
5. Enter the date and time as requested and answer subsequent questions. Typical answers are; Number of waves = 480, Number of passes = 10, Transient decay = 800, Number of data points = 100, Range code = 3. After the last question is answered the experiment will start automatically.
6. Turn the punch on and wait for the next question to be printed by the teletype.
7. After the experiment is completed depress the halt switch and tear the paper tape data set off the punch.
8. Roll the paper tape and submit it at the Iowa State University Computation Center for transfer to disc.-----

A complex decay curve can be time resolved with SMASH if different conventions are used. The same WYLBUR execute file

is used to prepare the job. A decay constant, which has been determined from single component data, is entered for each species which contributed to the decay curve. All decay constants are entered as positive numbers. The positive decay constants signal SMASH to perform a linear least squares procedure to calculate the initial intensities of the various components. The quality of fit is calculated and if the value does not fall between specific limits, error messages are generated. The error messages indicate whether too many or too few decay constants were entered. The output contains the initial data and the calculated data. The initial intensities are listed with the corresponding decay constants.

The output produced by the job is retrieved from the computation center and the calculated results are extracted from the printed matter and tabulated. If analytical results are sought the calculated results are normalized for amplifier gain and integrator input resistance. The normalization factors are listed in Table 6. After the results are normalized, calibration curves are plotted or unknown concentrations of PAH's are calculated.

### Fluorescence Measurements

If fluorescent emission is measured the capacitor in the gated integrator is reduced by a factor of 60. Greater integrator sensitivity is needed because the integration

Table 6. Normalization Factors

<u>Amplifier Gain</u>	<u>Input Resistor</u>	<u>Normalization Factor</u>
1 X 10 <sup>8</sup>	50K ohms	1
	100K ohms	2
1 X 10 <sup>7</sup>	25K ohms	5
	50K ohms	10
	100K ohms	20
1 X 10 <sup>6</sup>	25K ohms	50
	50K ohms	100
	100K ohms	200

period is shortened to 1/120th of a second when single waves are integrated. After the integrator is modified the pulsed XEOL system is prepared as described in Table 4. The x-ray supply is adjusted to 90 kV. and 300 mA. because a shorter pulse is used for the fluorescence experiment and the x-ray tube can dissipate the heat. The experiment is initiated as described in Table 5 but different input is used. The fast mode is specified for the assembly language program and only the number of waves in the pulse and the number of passes are entered. Typically 40 waves and 20 passes are selected. The experiment begins after the last question is answered.

Even though computerized data analysis techniques exist for the fast mode, the techniques were not used. The data collected from fluorescent emission were analyzed with a programable calculator. If analytical results are desired the calculated results are normalized with the factors given in

Table 6. A mean and standard deviation were calculated from the signal averaged data obtained for each wave in the pulse. However, the data obtained from the first twenty waves were discarded because the x-ray flux produced by the x-ray tube is not stable immediately after the x-ray tube is turned on. The mean is used to profile emission bands, generate calibration curves and calculate unknown PAH concentrations.

## CHAPTER 5: RESULTS AND DISCUSSION

## Decay Constant Values

The first step in the time resolution experiment was the determination of decay constants of the phosphorescent PAHs. These constants were determined from the stock solutions prepared from purified PAH materials. Because the pulsed XEOL system was untested, a reproducibility study of the determination of several decay constants was performed. The five day stability of the system was measured for triphenylene, coronene, chrysene, phenanthrene and fluoranthene, and a mean was calculated from five values obtained on different days. The decay constants obtained on five different days for seven PAHs are listed in Table 7. Two of the values in the table were excluded from statistical calculations by the Dixon criterion. The excluded values resulted from an error in the search routine used by SMASH, because noise in the measurement system can cause a large spread in the data points which describe a decay curve, with the greatest spread late in the decay scheme, and a false minimum in the quality of fit can be sought by the search vector. The frequency of occurrence of the error in the search routine was governed by the signal-to-noise ratio of the data. The mean and percent relative standard deviation of each decay constant are summarized in Table 8.

Table 7. Five Day Determination of Decay Constants<sup>1</sup>

<u>Compound</u>	<u>Day 1</u>	<u>Day 2</u>	<u>Day 3</u>	<u>Day 4</u>	<u>Day 5</u>
Triphenylene	0.0696	0.0687	0.0688	0.0699	0.0689
Coronene	0.1160	0.1157	0.1165	0.1155	0.1169
Fluorene	0.1704	0.1690	0.1707	0.1704	0.1703
Phenanthrene	0.2775	0.2781	0.2460 <sup>2</sup>	0.2736	0.2746
Naphthalene	0.3388	0.3483	0.3550	0.3385	0.2878 <sup>2</sup>
Chrysene	0.3831	0.3809	0.3817	0.3849	0.3806
<u>Fluoranthene</u>	<u>1.1231</u>	<u>1.1425</u>	<u>1.2067</u>	<u>1.0931</u>	<u>1.0222</u>

<sup>1</sup>All quantities reported in sec<sup>-1</sup>

<sup>2</sup>Values excluded by Dixon Criterion

Table 8. Decay Constant Statistics<sup>1</sup>

<u>Compound</u>	<u>Mean Decay Constant</u>	<u>% RSD</u>
Triphenylene	0.0692	0.77
Coronene	0.1161	0.50
Fluorene	0.1702	0.39
Phenanthrene	0.2760	0.79
Naphthalene	0.3452	2.3
Chrysene	0.3822	0.46
<u>Fluoranthene</u>	<u>1.1175</u>	<u>6.0</u>

<sup>1</sup>All quantities reported in sec<sup>-1</sup>

If the decay constants are not independent of concentration, analytical applications of time resolved spectroscopy would be impossible. The concentration independent behavior of the decay constants had to be verified. Triphenylene, coronene, phenanthrene, chrysene and fluoranthene were selected for these verifications. The results are presented in Table 9. With the exception of the lowest concentration values for phenanthrene, chrysene and



fluoranthene, the decay constants reported in Table 9 agreed with the values tabulated in Table 8. Therefore, the independent behavior of the decay constants with concentration was verified. The three values at the lowest concentration were severely distorted by a background luminescence. When the concentration dependence study was performed the background interference was not understood and no correction was made. The source and nature of the background luminescence will be discussed in the next section.

Table 9. Concentration Dependence of Decay Constants<sup>1</sup>

<u>Compound</u>	<u>1 X 10<sup>-3</sup>M</u>	<u>1 X 10<sup>-4</sup>M</u>	<u>1 X 10<sup>-5</sup>M</u>	<u>1 X 10<sup>-6</sup>M</u>
Triphenylene	0.0700	0.0705	0.0708	0.0715
Coronene	-----	0.1171	0.1180	0.1182
Phenanthrene	0.2791	0.2770	0.2820	0.3037
Chrysene	0.3851	0.3879	0.3805	0.4950
<u>Fluoranthene</u>	<u>1.2374</u>	<u>1.1924</u>	<u>0.9067</u>	<u>-----</u>

<sup>1</sup>All quantities reported in sec<sup>-1</sup>

A comparison of the decay constants observed in this study with literature values is shown in Table 10. Examination of the tabulated values indicates XEOL-TRS and conventional methods give comparable results. The agreement

between decay constants obtained from optical excitation and x-ray excitation helps to unravel the XEOL excitation mechanism. Normally, the decay constants of phosphorescent species in a highly ionized environment are significantly different from the decay constants of phosphorescent species in a neutral environment. Thus, x-ray excitation as compared to optical excitation does not affect the environment of the excited species appreciably even though ionized intermediates are produced by x-ray interaction with matter. Finally, the results obtained from decay curves of individual PAHs are summarized as decay constants, lifetimes and half lives in Table 11. The decay constant and the lifetime are reciprocally related and the half life is 0.693 divided by the decay constant.

#### Mixture Analysis by Time Resolution

One advantage of time resolved spectroscopy was demonstrated by some early results obtained from simple two component systems. As a first example of the usefulness of time resolved spectroscopy, a mixture of triphenylene and phenanthrene was studied. On the right hand side of Figure 12 the DC spectra of triphenylene and phenanthrene are presented with the background trace and the DC spectrum of a mixture of the two compounds. The double lines which extend from the top spectrum to the bottom spectrum indicate the region of the

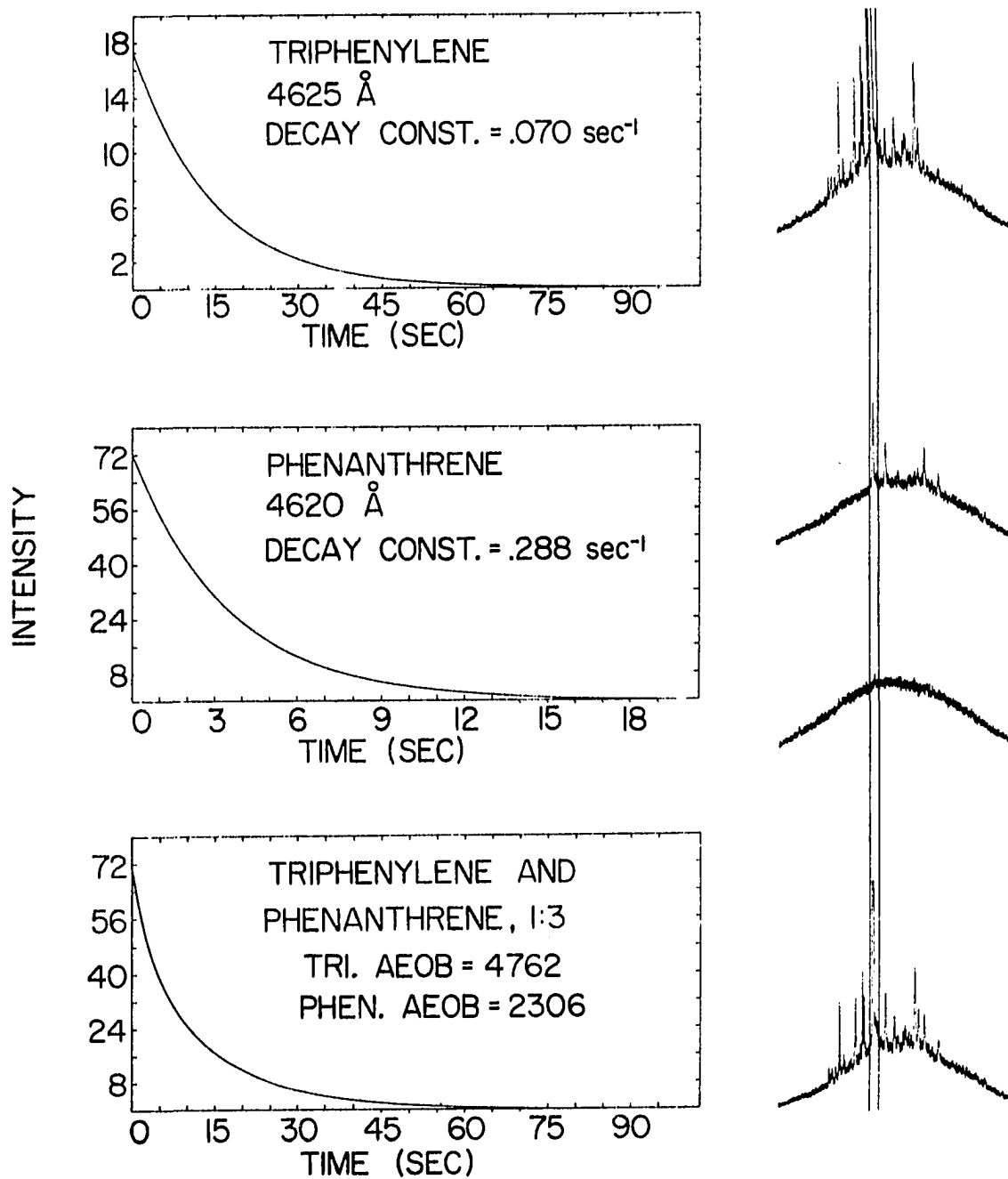


Figure 12. Time resolution of the phosphorescence emission from a mixture of triphenylene and phenanthrene in n-heptane by use of the pulsed XEOL technique.

Table 10. Comparison of XEOL and Published Decay Constants<sup>1</sup>

<u>Compound</u>	<u>XEOL-TKS</u>	<u>Birks (26)</u>	<u>McClure (54)</u>
Triphenylene	0.069	0.062	0.062
Coronene	0.12	0.11	0.11
Fluorene	0.17	0.20	0.20
Phenanthrene	0.28	0.29	0.30
Naphthalene	0.34	0.42	0.38
Chrysene	0.38	0.38	0.40
<u>Fluoranthene</u>	<u>1.12</u>	<u>1.18</u>	<u>----</u>

<sup>1</sup>All quantities reported in sec<sup>-1</sup>

Table 11. Decay Constants, Lifetimes and Half Lives of PAHs

<u>Compound</u>	<u>Decay Constant</u>	<u>Lifetime</u>	<u>Half Life</u>
Triphenylene	0.069 sec <sup>-1</sup>	14.5 sec	10.0 sec
Coronene	0.116 sec <sup>-1</sup>	8.6 sec	6.0 sec
Fluorene	0.170 sec <sup>-1</sup>	5.9 sec	4.1 sec
Phenanthrene	0.276 sec <sup>-1</sup>	3.6 sec	2.5 sec
Naphthalene	0.345 sec <sup>-1</sup>	2.9 sec	2.0 sec
Chrysene	0.382 sec <sup>-1</sup>	2.6 sec	1.8 sec
<u>Fluoranthene</u>	<u>1.118 sec<sup>-1</sup></u>	<u>0.89 sec</u>	<u>0.62 sec</u>

spectra isolated by the monochromator. An obvious spectral interference is observed. On the left hand side of Figure 12 the decay curves for the individual compounds and the mixture are drawn. The decay constants used to time resolve the spectral interference are given on the top two plots and the initial intensities are summarized on the bottom plot. The nonzero initial intensities prove the spectral interference can be resolved temporally. A second example is presented in Figure 13 for the mixture of triphenylene and chrysene.

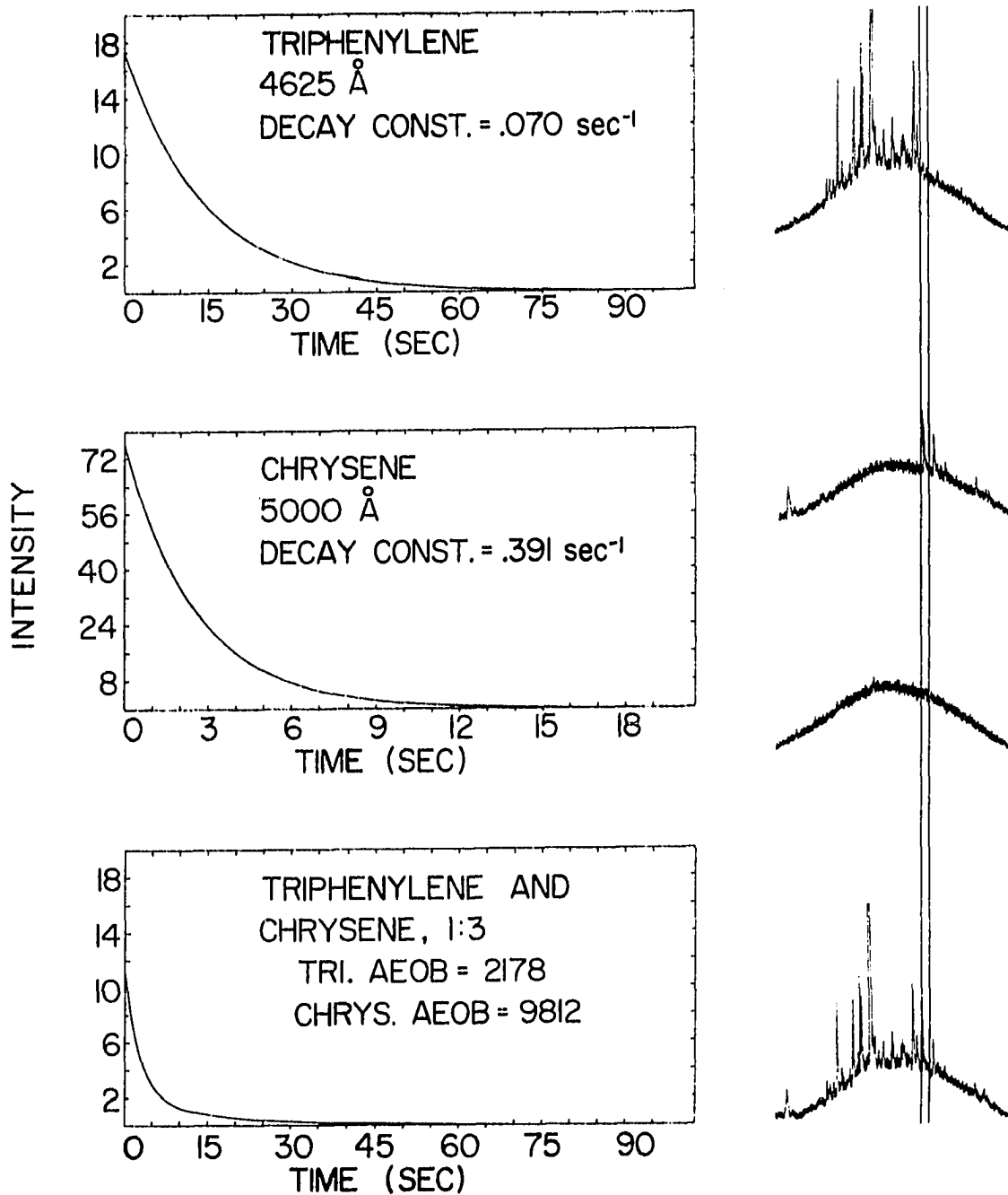


Figure 13. Time resolution of the phosphorescence emission from a mixture of triphenylene and chrysenes in n-heptane by use of the pulsed XEOL technique.

To determine the problems encountered in the time resolution of more complex mixtures with the pulsed XEOL system, a five component system which contained triphenylene, coronene, chrysene, phenanthrene and fluoranthene was examined. The five PAHs were selected because their decay constants cover a large range of values with no overlap.

Even though the five components in the mixture share no common emission band and spectral interferences are not severe, a second advantage of time resolved spectroscopy was demonstrated when the five component mixture was time resolved. The individual lines in the emission bands of the PAHs were weak and analytical determinations based on emission of single lines lacked sensitivity. To demonstrate the improved sensitivity of PAH determination by time resolved spectroscopy the monochromator was tuned to zero order and the slits were opened to 1 millimeter. In this way all the light emitted by the sample proceeded through the monochromator unresolved. If the monochromator had not been an integral part of the pulsed XEOL system, only a lens and a mirror would have been used to transmit the optical signal to the photomultiplier tube. With the slits opened to 1 millimeter the optical throughput of the monochromator obviously increased and the sensitivity of the measurement improved. The amount of scattered radiation which reached the detector also increased as the slits were opened, but with

time resolution only radiation which is characterized by a specific decay constant was detected. All other radiation produces a DC background which is removed by a simple subtraction.

Complex decay curves of several dilutions of the mixture were collected with the pulsed XEOL system. Each decay curve was time resolved and the results were normalized. Analytical calibration curves, both linear and logarithmic, for each component in the mixture were plotted and are drawn in Figures 14-18. Several unexpected features were observed for the logarithmic and linear plots of concentration versus intensity.

The first unexpected feature was the nonlinear behavior of the calibration curves. An approximate slope of one half was observed for the log plots, which indicated that the observed intensity was a function of the half power of concentration. Two explanations for the one half slope are possible. First, a half power rate expression could exist as an intermediate step in the kinetic scheme which describes the excitation mechanism. For example, a half power rate expression is observed for some free radical reactions (e.g. the formation of chlorine free radicals from molecular chlorine). Ionized species and free radicals are produced when x-rays interact with matter. The second possibility is based on the scattering of light within the translucent

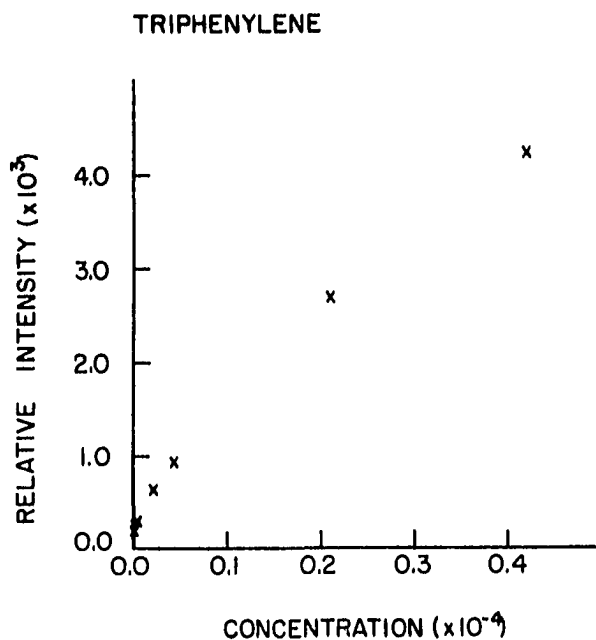


Figure 14a. Linear plot of intensity versus molar concentration for triphenylene.

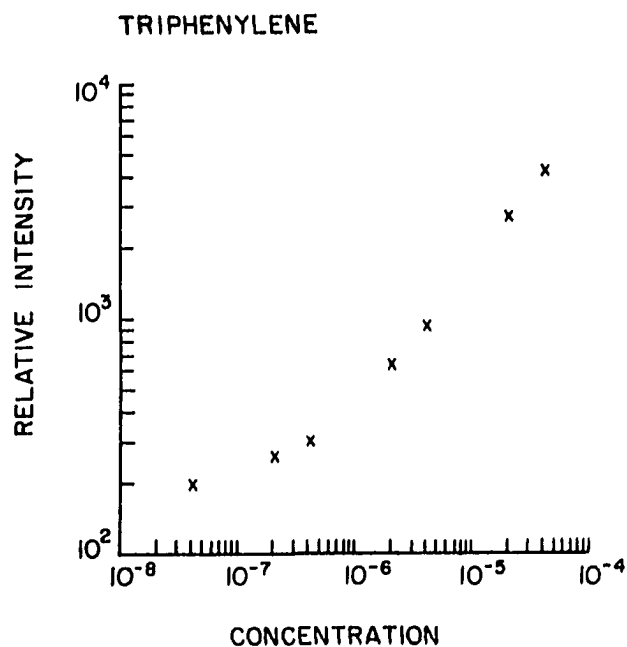


Figure 14b. Logarithmic plot of intensity versus molar concentration for triphenylene.



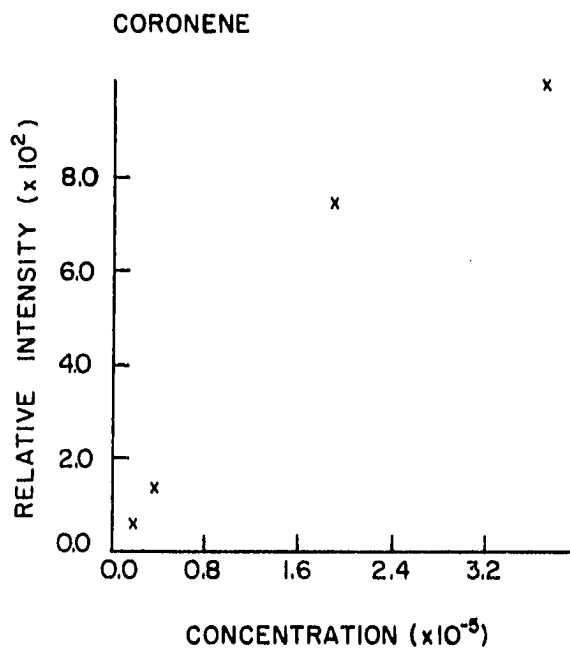


Figure 15a. Linear plot of intensity versus molar concentration for coronene.

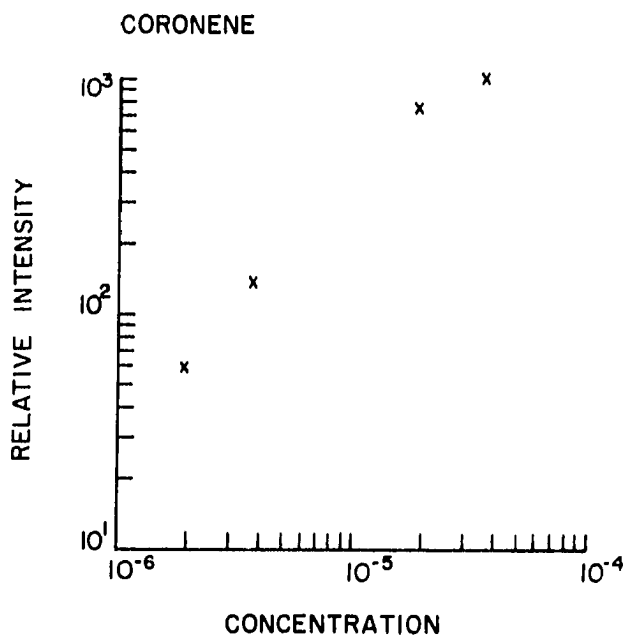


Figure 15b. Logarithmic plot of intensity versus molar concentration for coronene.

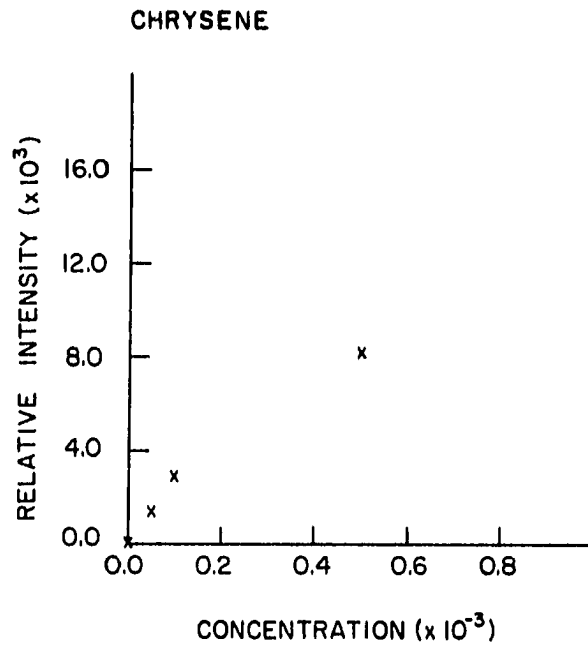


Figure 16a. Linear plot of intensity versus molar concentration for chrysene.

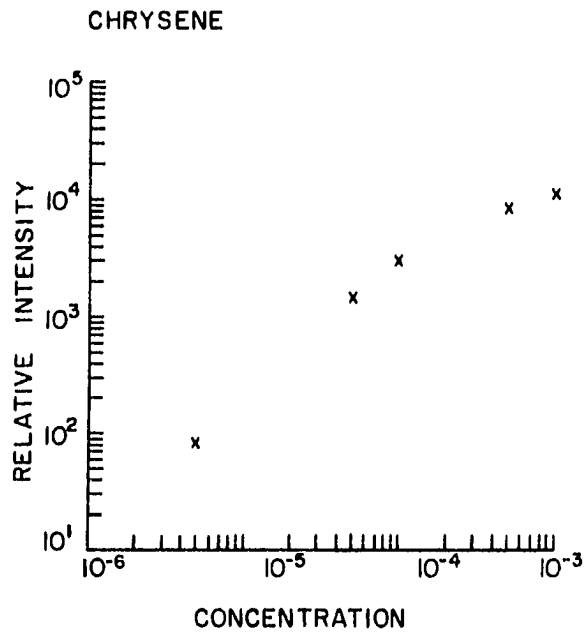


Figure 16b. Logarithmic plot of intensity versus molar concentration for chrysene.

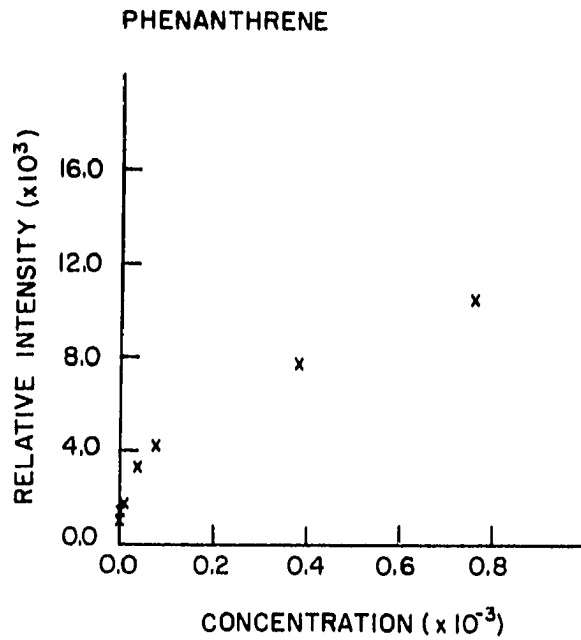


Figure 17a. Linear plot of intensity versus molar concentration for phenanthrene.

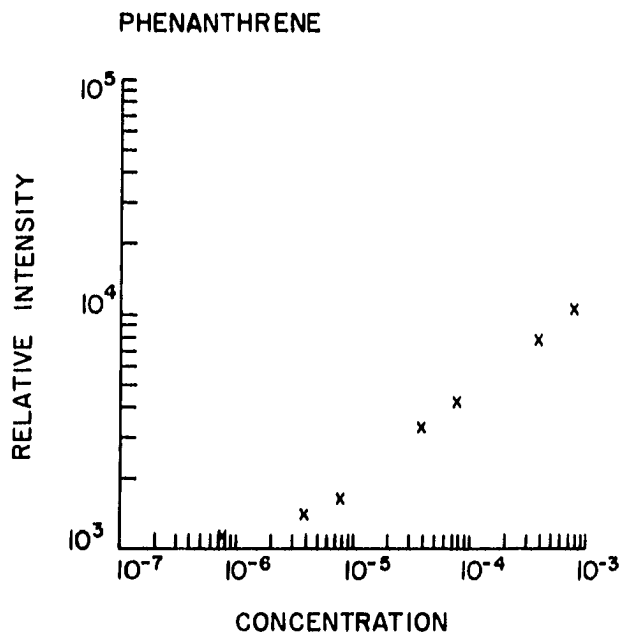


Figure 17b. Logarithmic plot of intensity versus molar concentration for phenanthrene.

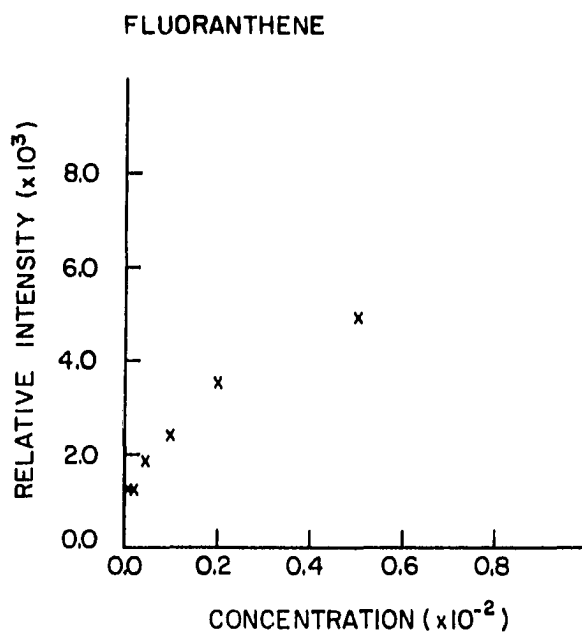


Figure 18a. Linear plot of intensity versus molar concentration for fluoranthene.

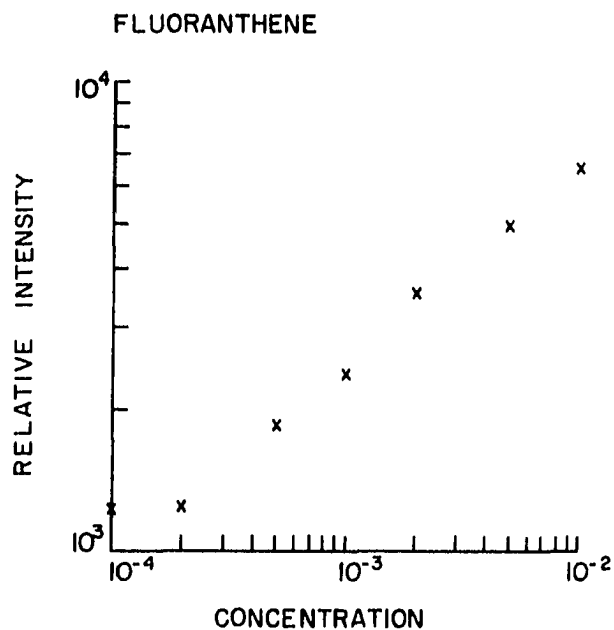


Figure 18b. Logarithmic plot of intensity versus molar concentration for fluoranthene.

sample. The emission of the sample originates from different depths within the sample and not just the sample surface. Formation of a microcrystalline snow when n-alkanes are frozen produced many reflective surfaces within the sample. Internal reflection and optical scattering reduced the probability of detection of a photon which originated in the interior of the sample as compared to a photon which originated on the surface of the sample. The relationship between concentration of luminescent species and the probability of detection of a photon emitted in the n-alkane snow as a function of distance from the surface of the sample must be considered. The functional behavior of the probability of detection as a function of distance from the surface of the sample could be responsible for the observed half power dependence of intensity on concentration. Escape depth considerations are common in many surface techniques and empirical functions have been used to make corrections for probabilities of escape for x-rays, photons and electrons (55). The answer to the question of which interpretation is correct, or if some other factors need to be considered could not be answered in the course of the present investigation.

The second unexpected feature was the flattening of the fluoranthene and triphenylene analytical calibration curves at low concentration. This flattening could be attributed to a background luminescence from the quartz window in the

sample holder characterized by decay constants with values approximately equal to the decay constants for triphenylene and fluoranthene. The background luminescence of the quartz window at 10 K contains two slow components with decay constants 0.068 and 1.160  $\text{sec}^{-1}$ . The second component was six times as intense as the first, hence a greater background effect was observed for fluoranthene as compared to triphenylene. The source of the background luminescence is defects and impurities in the quartz which become luminescent centers at low temperatures (56). Above 200 K no background luminescence is observed. Two possible solutions to this problem are considered in the next chapter.

Finally, the analytical calibration curves for coronene and chrysene flattened at high concentration. The observed behavior is not concentration quenching because singlet-triplet absorption is a forbidden process. The exact nature of the effect is not fully understood but energy transfer between luminescent species at high concentration and photochemical decomposition may be contributing to the observed behavior. Elucidation of photochemical processes in n-alkane systems induced by x-ray irradiation will be needed to understand the relationship between the observed intensity and high concentration of PAHs in the n-alkane snow.

To test the applicability of time resolved spectroscopy for analytical problems, three synthetic unknown PAH mixtures

were prepared and analyzed. The analysis was performed in triplicate and the results are tabulated in Table 12. All the values in the table are reported in micrograms. The uncertainties range from a few percent to 20 percent relative. Values for coronene and chrysene are not reported for unknown No. 1 because the amount present was below the detection limit for that particular sample. The phenanthrene value for unknown No. 2 and the chrysene value for unknown No. 3 were low because of peculiarities in SMASH discussed earlier. Although the data in Table 12 are promising, additional development undoubtedly will be required before XEOL-TRS can make a major contribution to the determination of PAHs in complex mixtures.

Table 12. Analytical Data from XEOL-TRS Analysis<sup>1 2</sup>

<u>Compound</u>	<u>Unknown No. 1</u>		<u>Unknown No. 2</u>		<u>Unknown No. 3</u>	
	<u>Actual</u>	<u>Found</u>	<u>Actual</u>	<u>Found</u>	<u>Actual</u>	<u>Found</u>
Triphenylene	0.57	0.64±0.05	2.0	1.9±0.2	5.7	5.7±0.9
Coronene	0.60	-----	3.0	3.0±0.3	6.0	5.4±2
Chrysene	5.7	-----	11	12±2	23	13±1
Phenanthrene	1.6	1.3±0.4	8.9	5.0±0.4	36	34±7
<u>Fluoranthene</u>	<u>100</u>	<u>120±10</u>	<u>200</u>	<u>200±40</u>	<u>400</u>	<u>440±80</u>

<sup>1</sup>All quantities reported in micrograms

<sup>2</sup>Analysis performed in triplicate

## Single Component Analysis by Fluorescence

The pseudo-DC mode was used to measure fluorescent emission induced by the greater x-ray flux available from the medical x-ray supply. Wavelength profiles were obtained for 3,4-benzopyrene and perylene in the wavelength region around 427.5 nm. and 453.0 nm., respectively. Analytical calibration curves were plotted from normalized data obtained from the maxima of the wavelength profiles. The analytical calibration curves were used to analyze three synthetic unknowns. The third unknown contained both compounds whereas the other two unknowns contained only a single component. The analysis was performed in triplicate and the results are tabulated in Table 13. All values are reported in micrograms.

Table 13. Fluorescence Data from Pulsed XEOL Analysis<sup>1 2</sup>

<u>Compound</u>	<u>Unknown No. 1</u>		<u>Unknown No. 2</u>		<u>Unknown No. 3</u>	
	<u>Actual</u>	<u>Found</u>	<u>Actual</u>	<u>Found</u>	<u>Actual</u>	<u>Found</u>
Perylene	2.5	1.6±0.8	---	-----	12.6	2.9±0.2
3,4-Benzopyrene	---	-----	2.3	2.2±0.6	3.2	2.5±2

<sup>1</sup>All quantities reported in micrograms

<sup>2</sup>Analysis performed in triplicate

The results are disappointing for the mixture and the uncertainties are unacceptable for all three unknowns. The large uncertainties are caused by the inability to



reproducibly peak the monochromator on the maximum intensity wavelength of the emission band and the fluorescent background emitted by the sample holder. Location of the maximum intensity wavelength of the emission band was a long tedious process with the pseudo-DC excitation source as compared to the standard DC excitation source and an alternate approach was sought. Suggestions for the correction of these problems are discussed in the next chapter. The analysis of the mixture is further complicated by the suppression of 3,4-benzopyrene emission by perylene. Interferences of the type observed for unknown No. 3 are expected when fluorescence analysis is performed with PAHs because energy transfer processes play a major role in the excitation and deexcitation mechanisms of many PAH systems. After appropriate system improvements the XEOL technique could be applied to the fluorescent analysis of single component PAH systems. However, single component PAH analysis is not practical because PAHs occur in complex mixtures. Therefore, the use of internal reference compounds, prior isolation of PAHs by ring size and alkyl substitution or other innovative analytical approaches will be required before XEOL can be applied to the fluorescent analysis of PAHs.

## Discussions and Conclusions

The results reported in this chapter demonstrate the feasibility of the XEOL-TRS technique for the analysis of simple mixtures of phosphorescent PAHs. The technique could obviously be applied to other organic phosphorescent systems. The present study is the first application of XEOL to organic systems and many basic principles were established. The use of low temperatures and unconventional geometries are two examples. Techniques for the determination of decay constants were developed. As the scope expands to other organic systems, Fourier techniques and phase resolution will be required to measure shorter decay constants. The examination of fluorescence produced with a high power x-ray pulse demonstrated the flexibility of the pulsed XEOL system to study fluorescence and phosphorescence. The combination of XEOL with conventional pulsed fluorescence techniques will expand the scope of the XEOL method. Finally, the temperature flexibility, supplied by the helium refrigerator employed in the pulsed XEOL system, makes possible the study of a wide range of solids, liquids and gases.

XEOL coupled with time resolved spectroscopy does not solve all the problems of PAH analysis. The technique in the present state of development does not compete with gas or liquid chromatography, GC-MS or conventional fluorescence techniques. The improvements discussed in the next chapter if

implemented should improve the capabilities of the pulsed XEOL system. However, the true potential of the method as applied to PAH analysis will not be appreciated fully until a nanosecond width x-ray pulse is used for excitation. A synchrotron produces an intense x-ray pulse of nanosecond width which would eliminate the limitations imposed on the present study by the pulse characteristics. As time and space become available on national synchrotron facilities a proposal, based on the work presented here, should be prepared. The improved sensitivity and more general applicability of time resolved fluorescence as opposed to time resolved phosphorescence should be stressed. Interferences (e.g. the suppression of 3,4-benzopyrene emission by perylene) could be characterized by the pulsed XEOL system in the pseudo-DC mode prior to the synchrotron study. Even with ideal x-ray excitation sources and unlimited computational facilities the XEOL technique would not be the ultimate method for the analysis of PAH mixtures. The PAH problem is complex and many analytical techniques will be required to characterize natural and man made mixtures of PAHs.

## CHAPTER 6: MISCELLANEOUS OBSERVATIONS AND FUTURE WORK

The work reported earlier (13,45), combined with the results presented in this dissertation, is the first application of XEOL to an organic system. Furthermore, the use of a pulsed x-ray excitation source is a novel approach to XEOL. These two facts suggest the scope of application for XEOL coupled with conventional luminescent methods is very broad and requires additional investigation.

Before new applications of XEOL are considered, modifications of the pulsed XEOL system are described in the following section. Implementation of the modifications would eliminate many of the problems encountered in the PAH study. In the next section the effects of solvent composition are discussed and suggestions are presented for the enhancement of the sensitivity of the PAH analysis by XEOL. Finally, XEOL results obtained from novel systems are presented in the last section and new applications of XEOL to analytical problems are indicated.

## Pulsed XEOL System Modifications

The major problem encountered in the analysis of PAHs with the pulsed XEOL system was the background luminescence emitted by the quartz window in the sample holder. To correct the problem, the quartz window can be replaced by a window composed of a different material or removed completely.

Several window materials were tested to eliminate the background luminescence but no suitable substitute was found. Single crystal quartz was not available when the other materials were tested. A sample of single crystal quartz should be obtained and tested as a substitute window material.

An alternate approach to eliminate the background luminescence from the quartz window in the sample holder involved deposition of the sample on a cold beryllium disk from a flowing gas stream. A doughnut-shaped manifold with twelve directional ports was designed. At the present time deposition techniques are being developed. The major problems that need to be solved are improved vacuum control, measurement and control of sample deposition and efficient vaporization and transport methods for the PAH material. After the problems are solved, many interesting experiments are possible, in particular, x-ray generation of reactive species and photochemical reactions. The deposition of gaseous samples on a cold surface opens the realm of matrix isolation to study by the XEOL technique.

Another problem, encountered in the fluorescence study, was the inability to reproducibly position the monochromator at a specific wavelength. Mechanical play in the wavelength counter and large temperature variations in the laboratory contributed to the problem. To correct the difficulty

software should be developed to calculate a polynomial fit from discrete data points which characterize the profile of the emission band. A numerical differentiation of the polynomial produces the derivative of the emission band shape. The wavelength of maximum intensity is equal to one of the roots of the polynomial expression which represents the derivative set equal to zero. The maximum intensity is calculated by substitution of the wavelength of maximum intensity into the original polynomial. These numerical methods eliminate the need to position the monochromator reproducibly because only the relative positions of the data points with respect to one another are required. The relative positions can be accurately determined by use of a computer-controlled stepper motor to position the monochromator at the discrete wavelengths in the profile of the emission band. The software and interface needed to operate a stepper motor by computer control were developed by D. Kalnicky (57) and are available in the laboratory. A stepper motor should be purchased and mounted on the monochromator and modifications of software for use of the stepper motor should be started.

In addition to the modifications described in the preceding paragraphs, optimization of the x-ray pulse characteristics is imperative. The trade offs between voltage, current, and pulse duration of the x-ray pulse

should be studied. Figures 19-21 are plots of intensity versus current, voltage and pulse duration. A factor of two increase in current or pulse duration doubles the measured intensity but an approximate fifty percent increase in voltage produces an equivalent enhancement. Optimization of PAH analysis with respect to the three pulse parameters, within the limits determined by the energy the x-ray tube must dissipate as heat, should enhance the sensitivity and lower the detection limits of the XEOL technique.

#### Solvent Composition

The host matrix or solvent composition for an organic system, e.g. PAHs in n-alkane solvents, is an important factor in all XEOL experiments. The host matrix has to interact with the primary x-ray radiation and support energy transfer processes which excite the guest species. Very few host matrices exhibit XEOL emission from guest species. A better understanding of the excitation processes in those matrices which exhibit XEOL emission should be developed in the near future. The results of a study of the excitation mechanism for PAHs in n-alkanes in particular, will assist in the prediction of new organic systems which will exhibit XEOL emission. The importance of solvent composition for the PAH study is demonstrated by two probing experiments.

## INTENSITY VS CURRENT

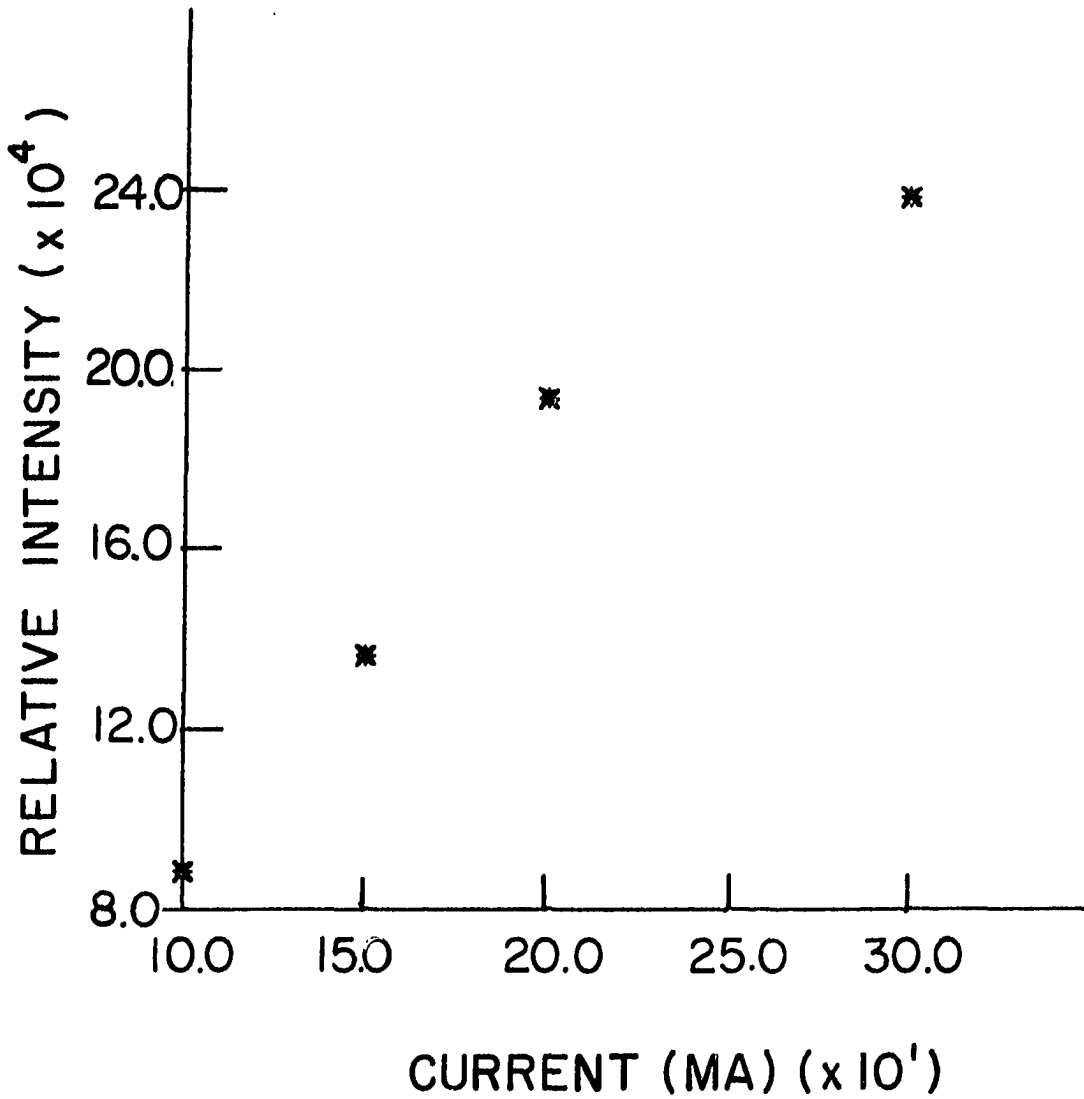


Figure 19. Measured intensity as a function of the current of the electron beam used to produce the x-ray pulse.



## INTENSITY VS VOLTAGE

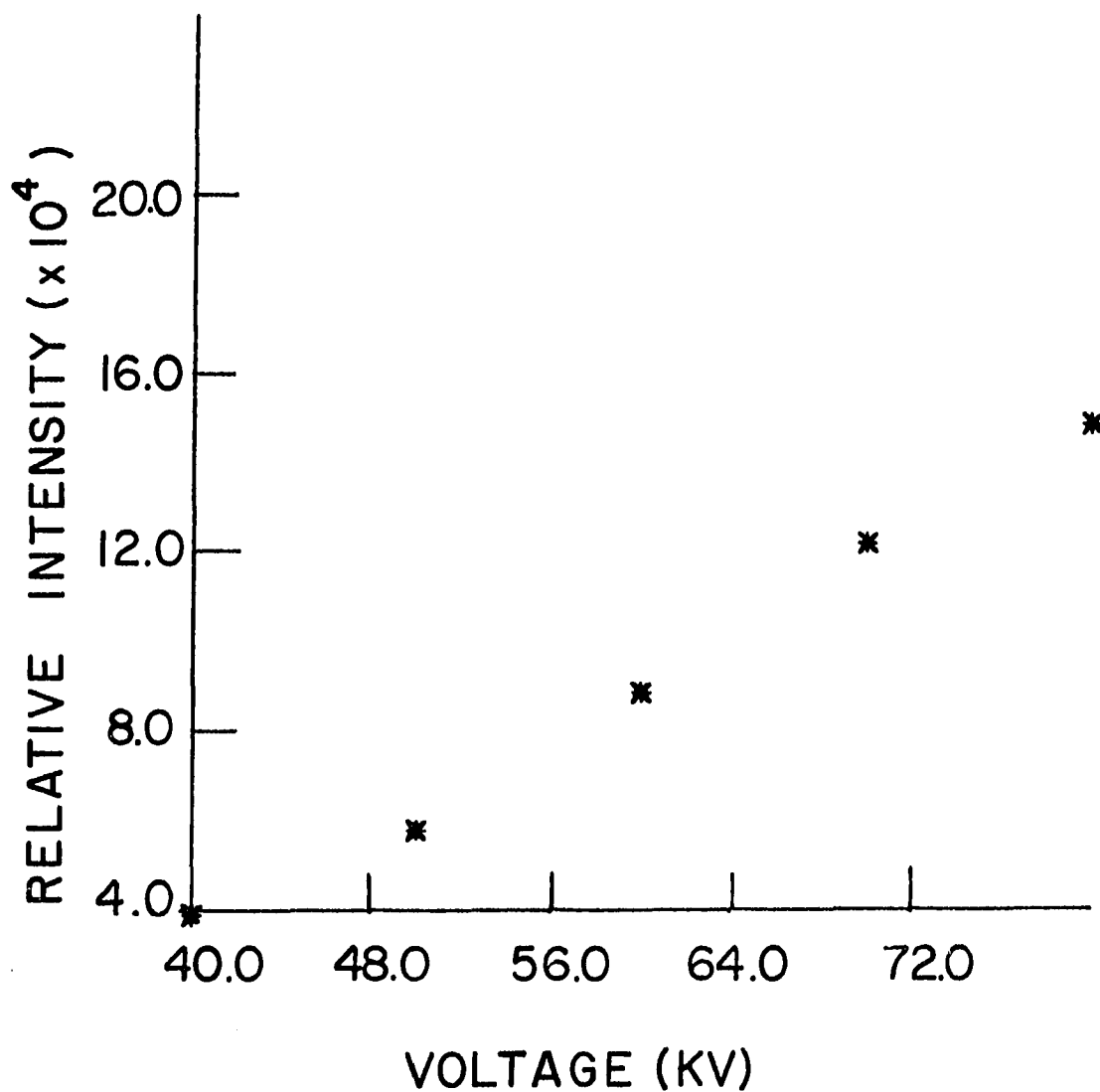


Figure 20. Measured intensity as a function of the acceleration voltage experienced by the electron beam used to produce the x-ray pulse.

## INTENSITY VS PULSE DURATION

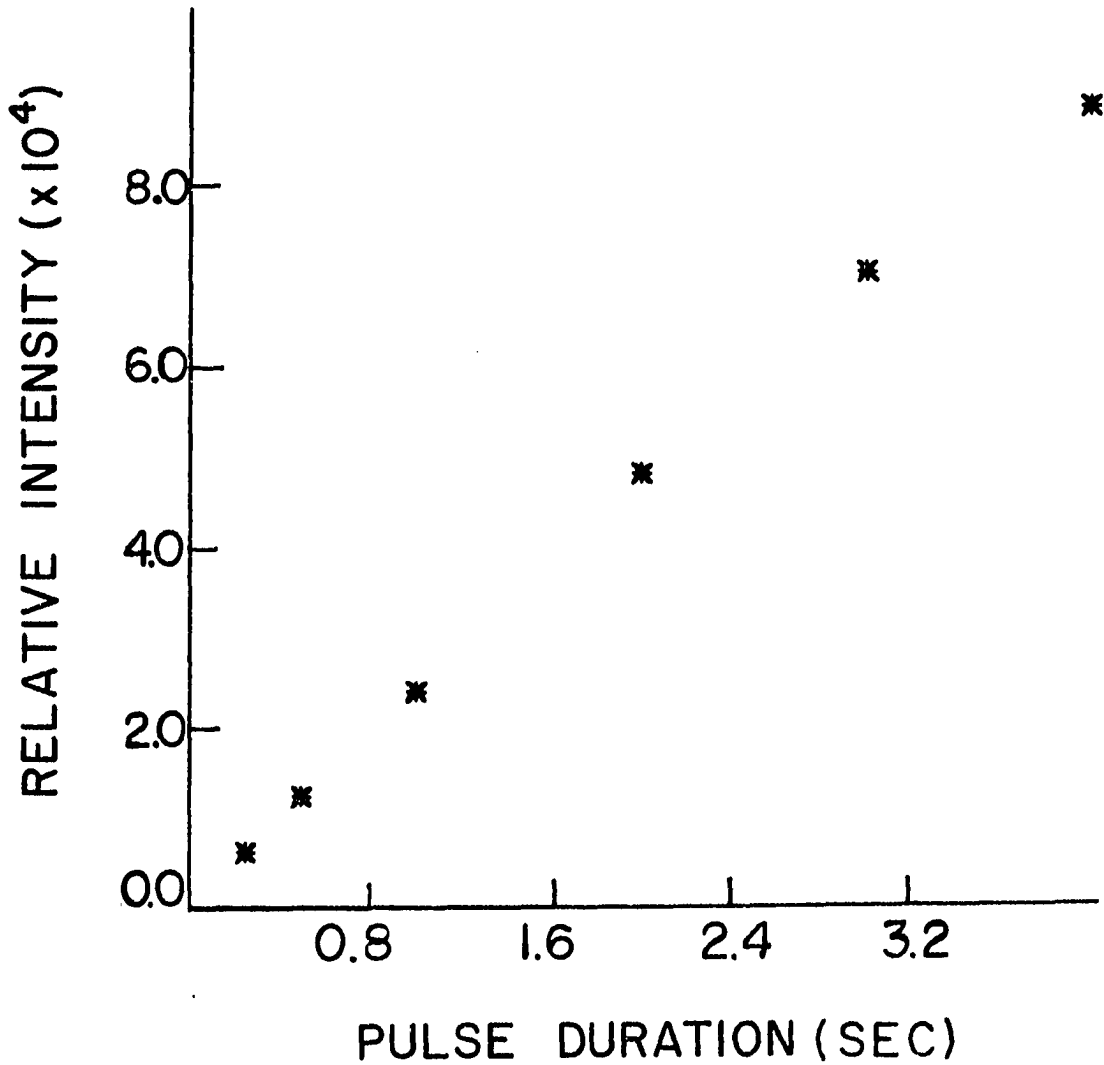


Figure 21. Measured intensity as a function of the duration of the x-ray pulse.

The first experiment examined the effect of n-alkane chain length on the structure of the XEOL spectrum.

Anthracene and 3,4-benzopyrene were examined in n-hexane, n-heptane and n-octane. The three anthracene spectra are presented in Figures 22-24. The emission band for anthracene in n-hexane is broad and structureless whereas in n-heptane several sharp lines are observed and in n-octane a weak band is observed. A different effect is observed for 3,4-benzopyrene as shown in Figures 25-27. The structure of the emission sharpens and the intensity increases as the chain length increases. Similar solvent effects are observed for all the PAHs studied. These solvent effects and others previously observed for UV excitation of n-alkane-PAH systems (35,58-61) need to be investigated so that the analysis of PAHs by the XEOL technique can be optimized.

A second probing experiment on solvent composition involved the introduction of a heavy atom to the n-alkane-PAH system by addition of iodobutane or tetra-n-butyllead to the solvent. Addition of a heavy atom to the solvent induces the external heavy atom effect in PAH systems (62-64). The increase of the spin-orbit coupling of excited singlet and triplet states results in an increase in the rate of intersystem crossing between singlet and triplet states and thus enhanced phosphorescence emission. Analytical applications of the external heavy atom effect in UV excited,

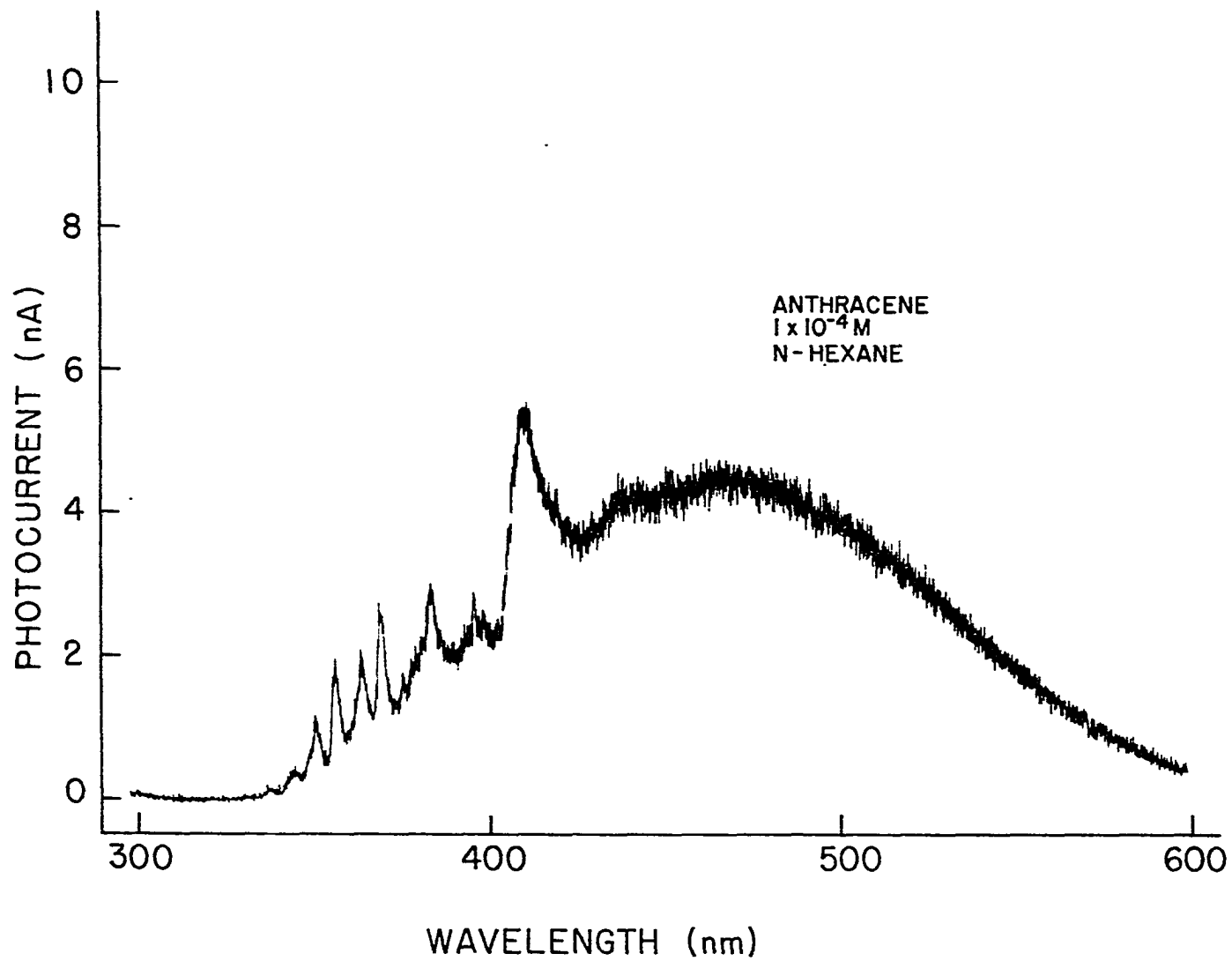


Figure 22. XEL spectrum of anthracene in n-hexane at a concentration of  $1 \times 10^{-4} \text{ M}$ .

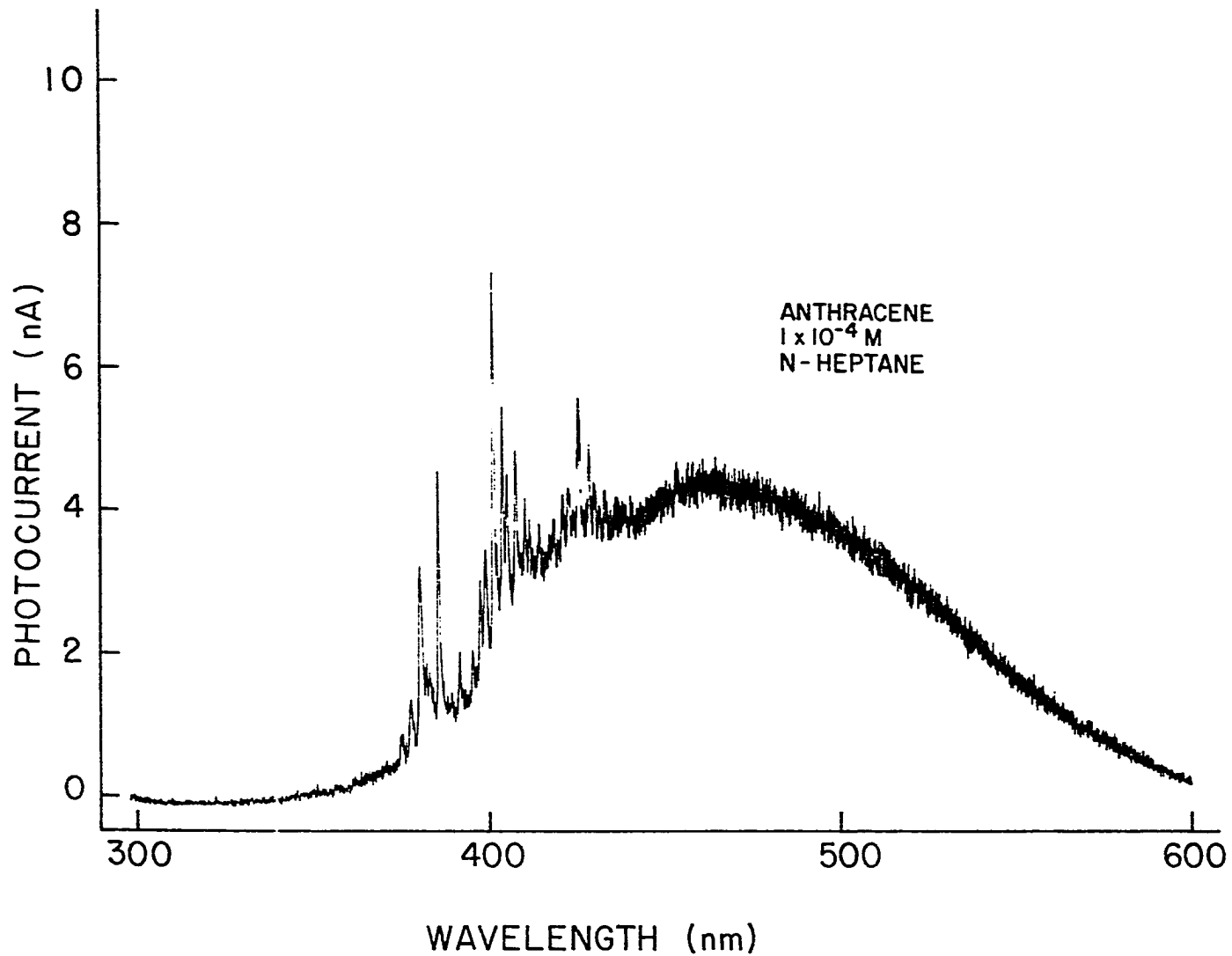


Figure 23. XECI spectrum of anthracene in n-heptane at a concentration of  $1 \times 10^{-4} \text{ M}$ .

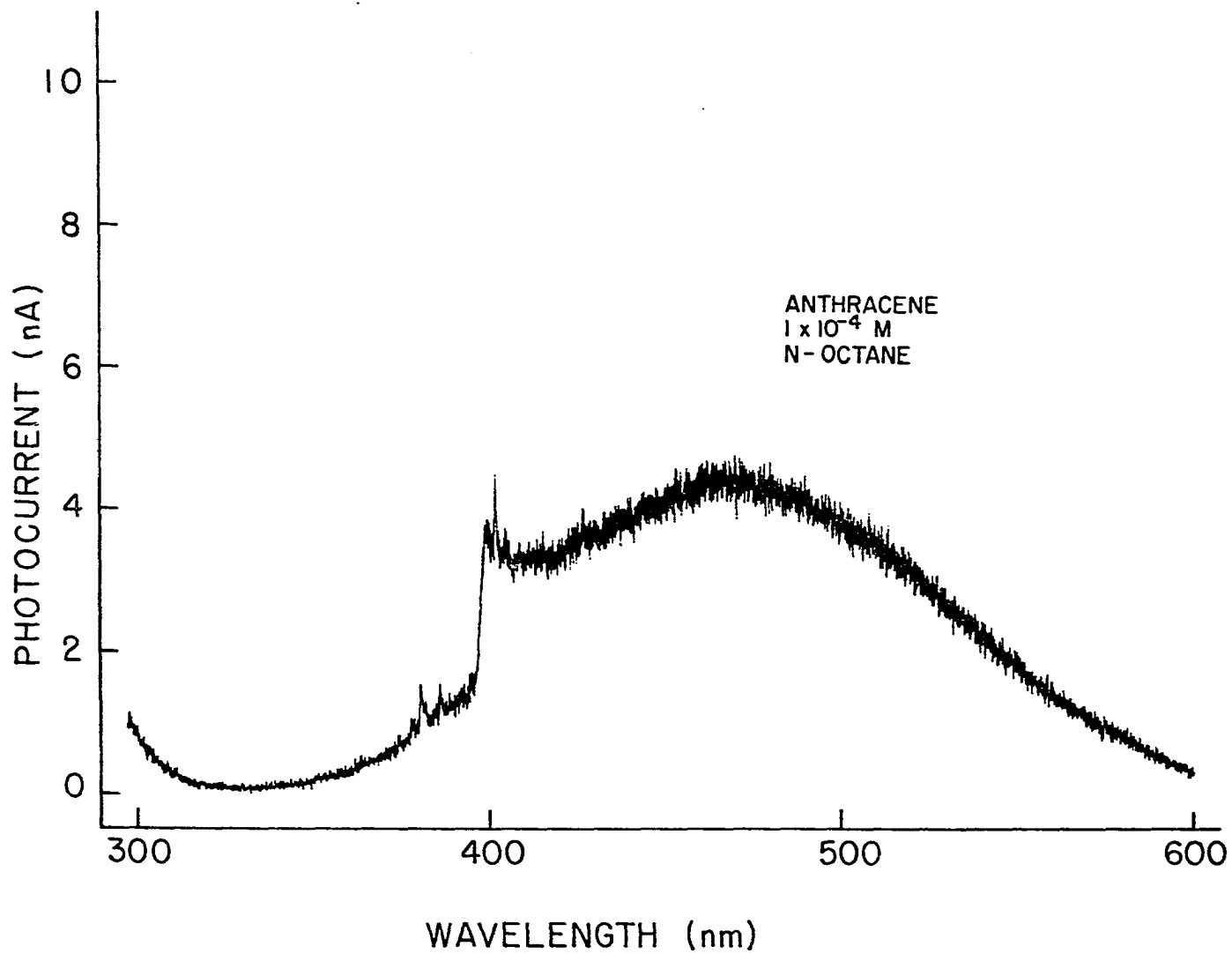


Figure 24. XECL spectrum of anthracene in n-octane at a concentration of  $1 \times 10^{-4}$  M.

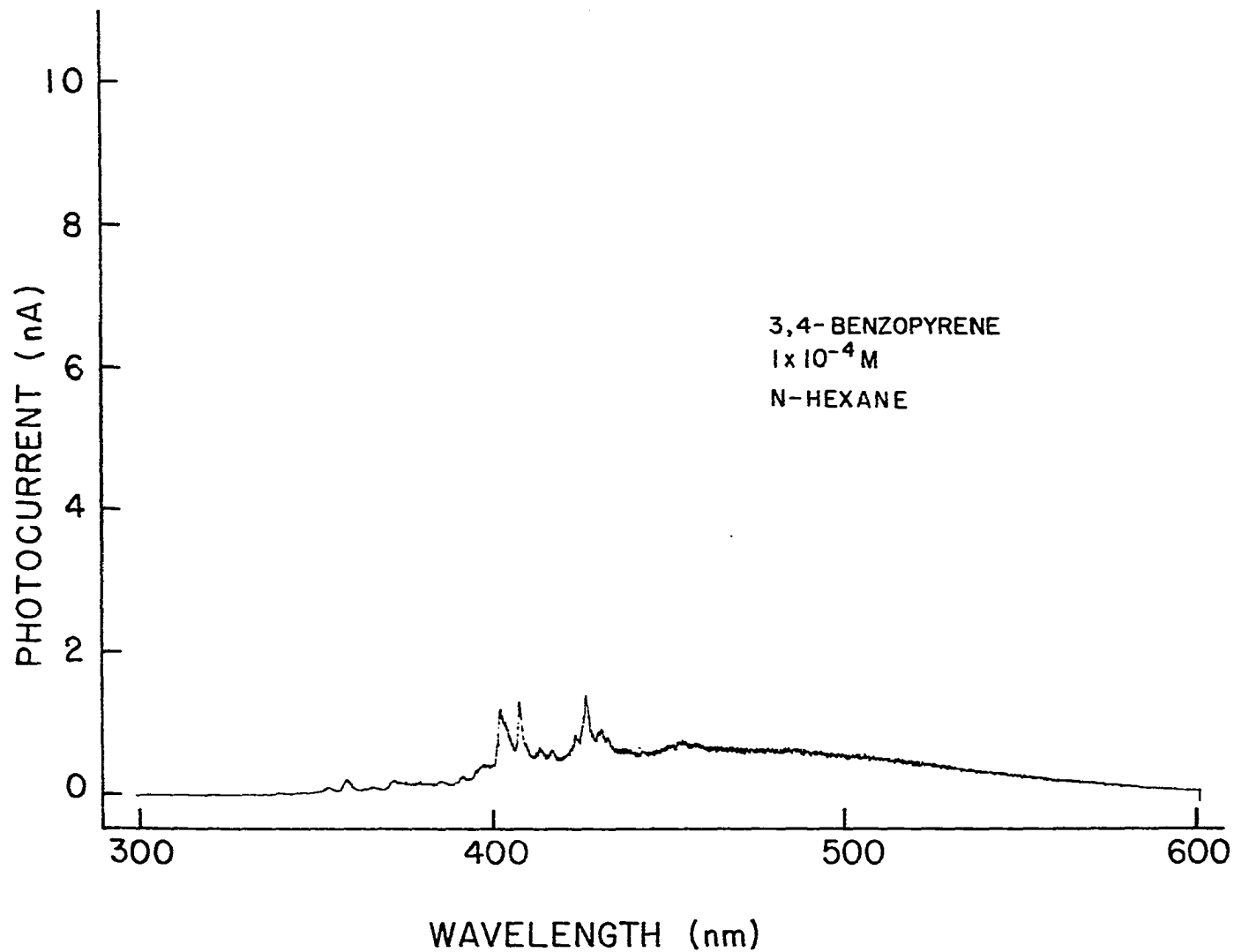


Figure 25. XECI spectrum of 3,4-benzopyrene in n-hexane at a concentration of  $1 \times 10^{-4}$  M.

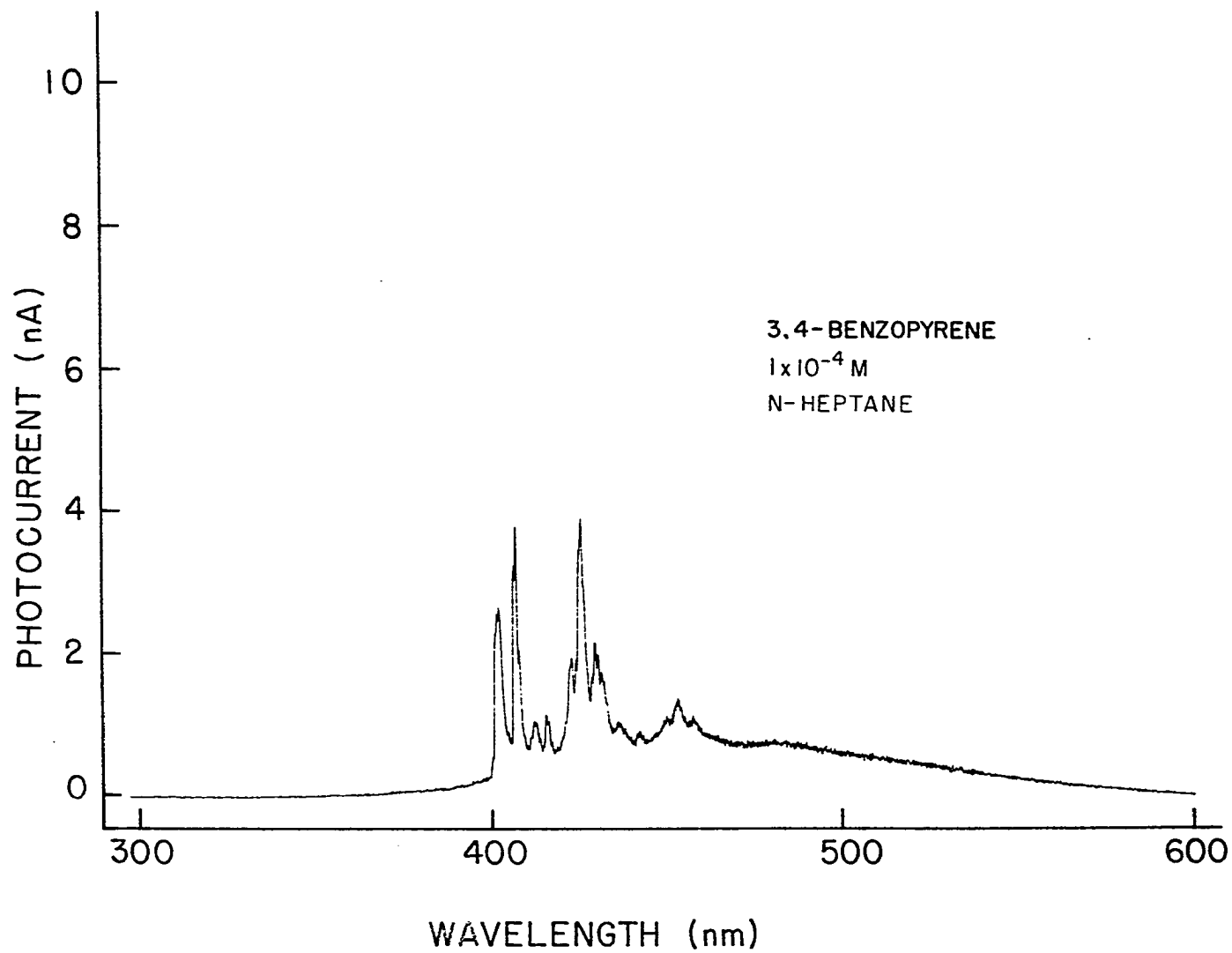


Figure 26. YECL spectrum of 3,4-benzopyrene in n-heptane at a concentration of  $1 \times 10^{-4}$  M.



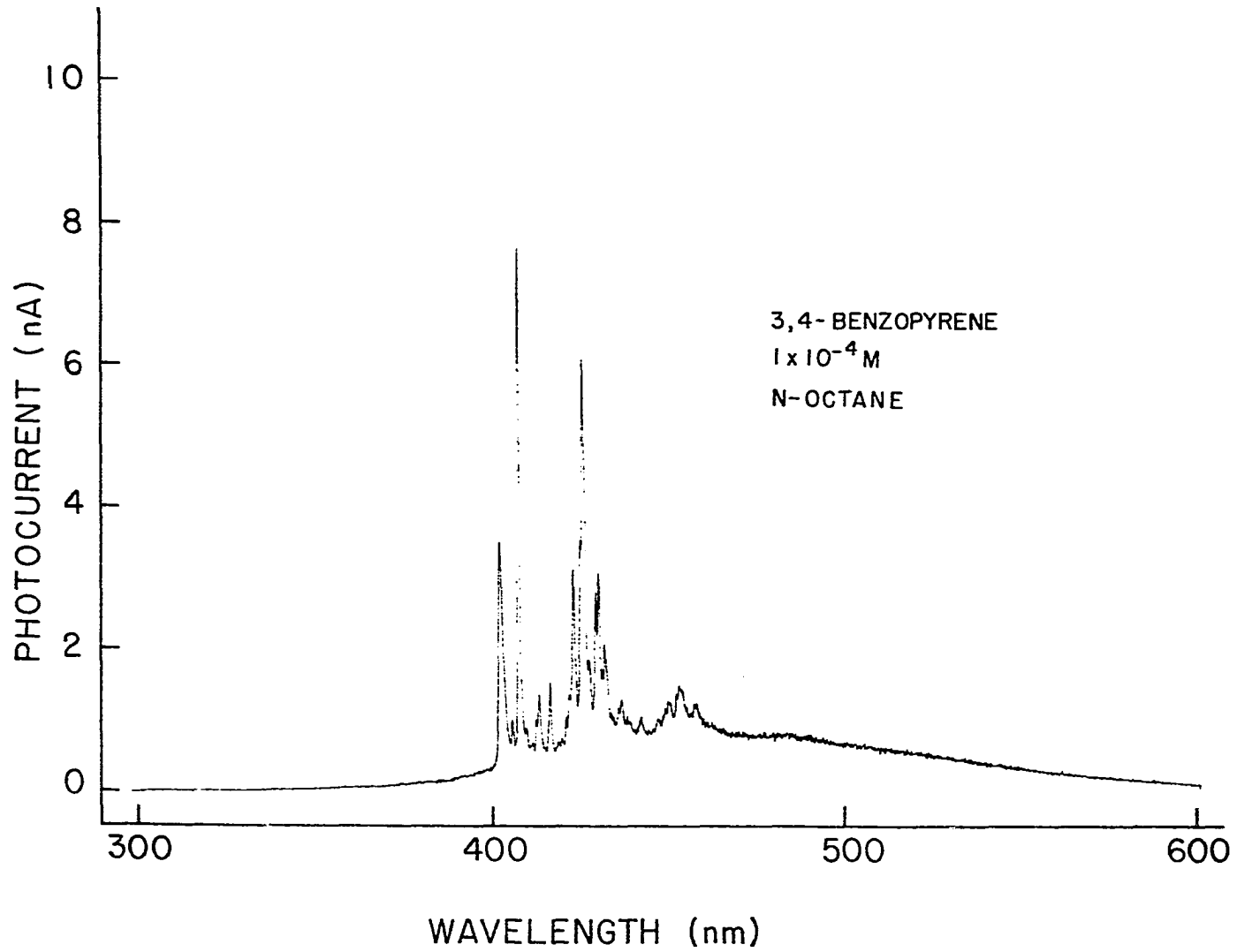


Figure 27. XECL spectrum of 3,4-benzopyrene in n-octane at a concentration of 1 X 10<sup>-4</sup> M.

PAH systems are numerous (65-67). Furthermore, the x-ray capture cross section of an atom increases with atomic number (47). Therefore, the addition of a heavy atom to the solvent results in a host with a large x-ray capture cross section and a second enhancement of the luminescence emission should result with the XEOL technique. The heavy atom host captures more x-ray photons than a hydrocarbon host and the energy of the x-ray beam is more efficiently converted to electronic excitation energy for the PAH guest molecules.

No effect was observed for iodobutane but an enhancement was observed for tetra-n-butyllead. Table 14 summarizes the effect of tetra-n-butyllead on five PAHS at a concentration of 10 microliters of tetra-n-butyllead per 1 milliliter of n-heptane. The results indicate improved detection limits could be achieved with the addition of a heavy atom to the solvent. Future experiments should be scheduled to study the effect of heavy atom concentration on the signal and decay constant of the analyte. Also, the optimum concentration of heavy atom and the optimum heavy atom need to be determined.

#### Other Systems Amenable to Study by XEOL

An obvious application of the XEOL study of PAHS is the characterization of fuel oils by the PAH fraction as described by the U. S. Coast Guard (68). Fuel oil samples were collected and XEOL spectra were obtained. The initial

Table 14. External Heavy Atom Effect on PAH Emission

Compound	Conc.	Signal Without Heavy Atom	Signal With Heavy Atom	Percent Increase
Fluoranthene	1X10 <sup>-2</sup> M	8642	76050	780%
Chrysene	1X10 <sup>-3</sup> M	13019	21060	62%
Phenanthrene	1X10 <sup>-3</sup> M	31484	47200	50%
Triphenylene	1X10 <sup>-3</sup> M	88157	123700	40%
Coronene	1X10 <sup>-4</sup> M	8454	9360	11%

results were not competitive with the U. S. Coast Guard results, hence the fuel oil samples are being stored until the instrumental modifications have been completed. After the modifications are tested, the fuel oil samples will be characterized by XEOL spectra and complex decay curves. Characterization of fuel oils by complex decay curves will be one more method of identification necessary to fingerprint fuel oil spills and stock supplies of fuel oils.

XEOL emission from the final system considered was discovered by accident. The first experiments performed with the gas manifold involved the co-deposition of argon and PAHs on the beryllium disc to take advantage of the large x-ray capture cross section of argon as compared to carbon and hydrogen. A routine examination of a "pure" argon deposit revealed a complex spectrum, as shown in Figure 28. The many lines and bands are characteristic of nitrogen, oxygen and other gaseous impurities in argon. Possible analytical applications for the determination of these gases in argon

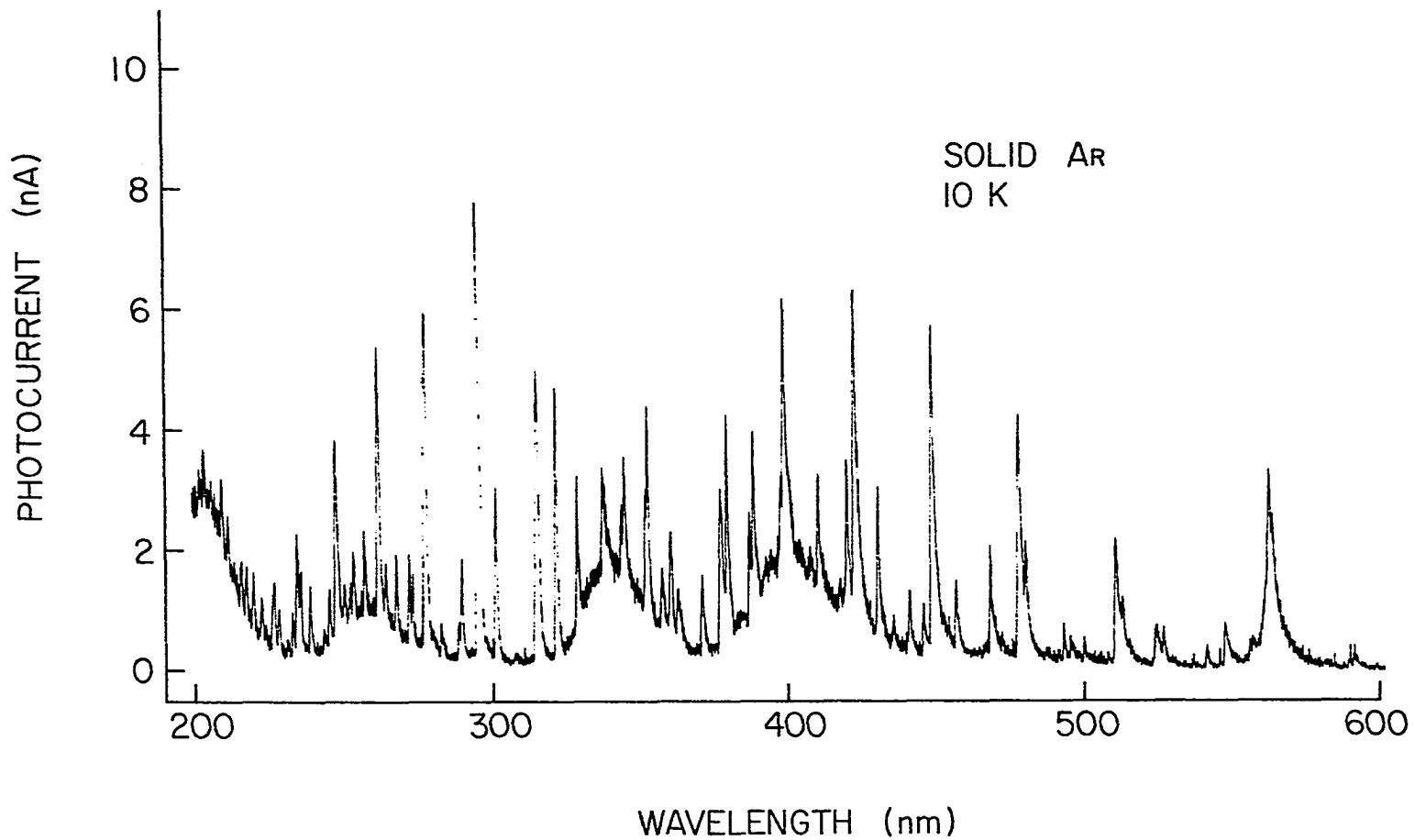


Figure 28. XECL spectrum of solid argon deposited on a beryllium window at 10 K from a flowing gas stream.

should be investigated.

In Figures 29 and 30 the spectra of krypton and xenon are shown. The broad bands in the short wavelength region suggest that these materials may be better suited as hosts for PAHs and other luminescent organic molecules. This possibility is being investigated. The origins of the other lines in the two spectra are unknown but trace gaseous impurities are the most likely sources.

The combination of rare gases and hydrocarbons, both aliphatic and aromatic, opens many avenues of research for the XEOL technique in the pulsed and DC modes. The many matrices with varying degrees of heavy atom concentration, structural peculiarities and x-ray capture cross sections should supply ideal XEOL environments for many different types of organic analytes.

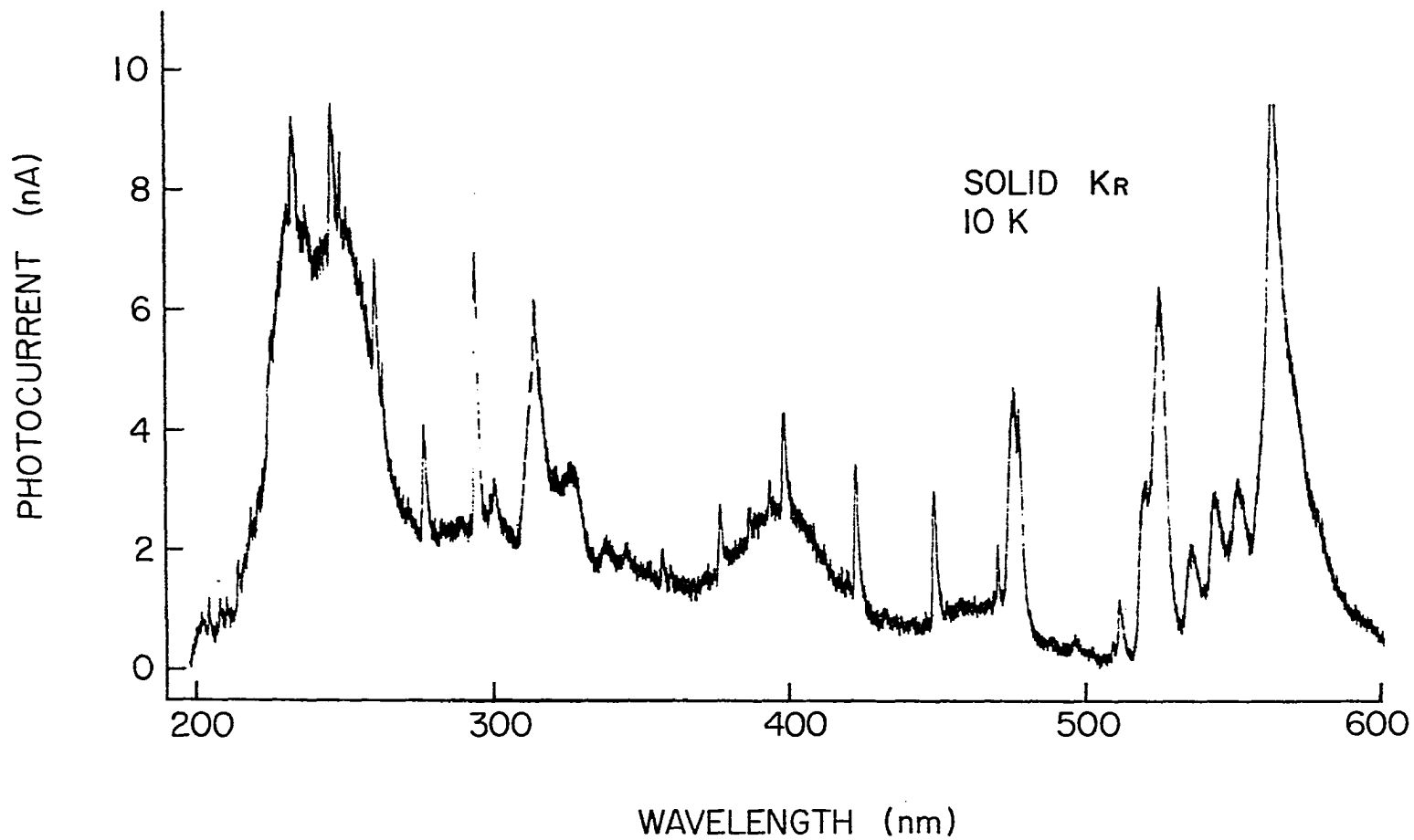


Figure 29. XECL spectrum of solid krypton deposited on a beryllium window at 10 K from a flowing gas stream.

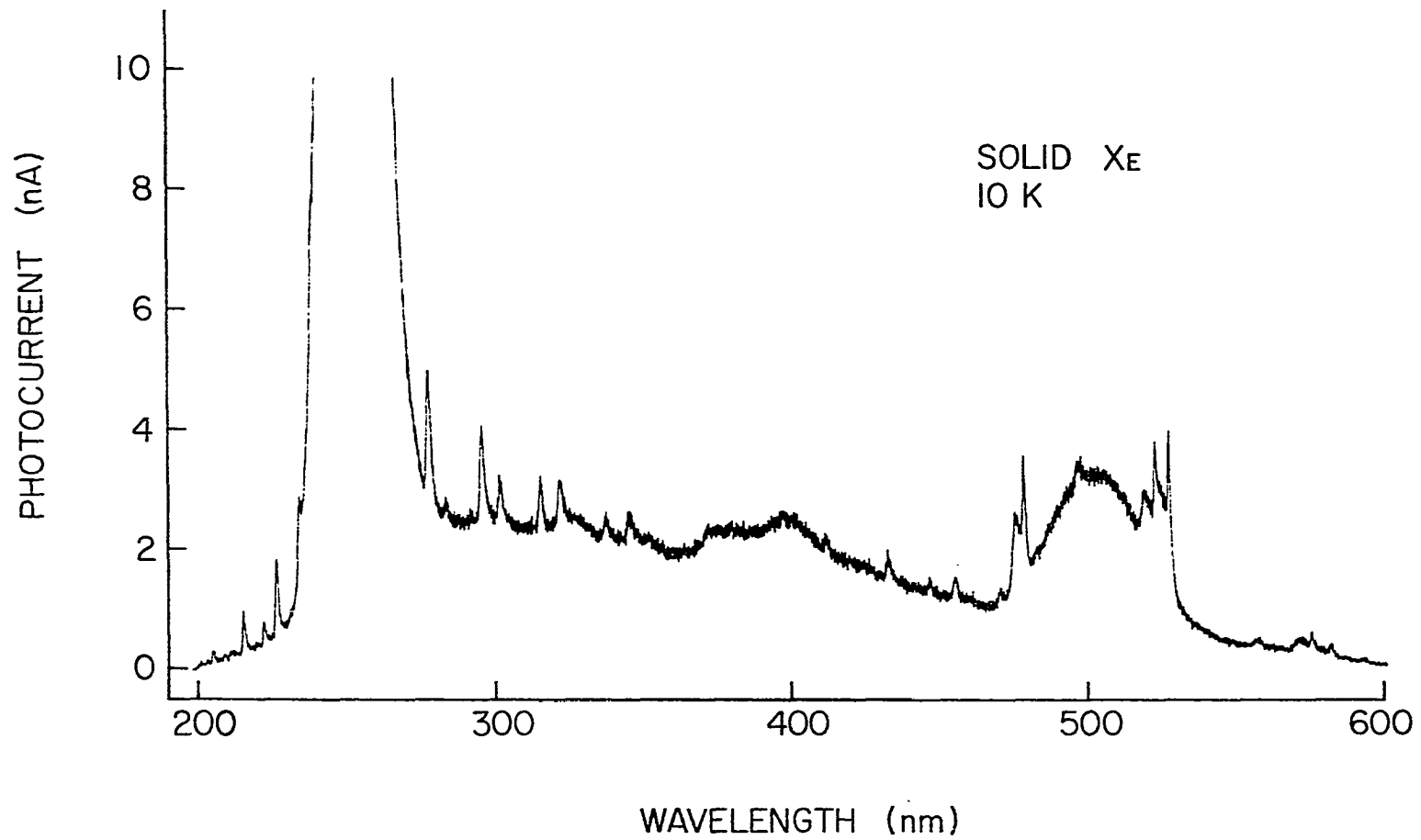


Figure 30. XECL spectrum of solid xenon deposited on a beryllium window at 10 K from a flowing gas stream.

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## APPENDIX 1: TRS3

TRS3 is the PL/1 program which reads the experimental data from disc and generates the output data set which is the input data for SMASH. The PL/1 program translates data from a format specified by the assembly language program which runs on the PDP8/E minicomputer to data in the proper format for SMASH. Execution of TRS3 is the first major step in the job which calculates experimental results. TRS3 is run automatically by the WYLBUR execute file which appears in Appendix 6. The operation of TRS3 is controlled by a group of input variables which specify the number of experiments which were performed and the mode of the pulsed XEOL system employed for each experiment. If the slow mode is specified TRS3 plots the decay curve with Simplotter. Simplotter is accessed by the CALL GRAPH and CALL GRAPHS statements which appear in the listing. A CALL ORIGIN statement, one of the Simplotter options, is used to move the position of the graph on the paper on which the graph is plotted. A listing of the source statements of TRS3 is given on the following pages.

```

(STRG, SUBRG) :
CORE: PROCEDURE OPTIONS (MAIN);
  DCL GRAPH ENTRY (FIXED BIN, (*) FLOAT, (*) FLOAT,
    FIXED BIN, FIXED BIN, FLOAT, FLOAT, FLOAT,
    FLOAT, FLOAT, FLOAT, CHAR(20), CHAR(20),
    CHAR(20), CHAR(20));
  DCL GRAPHS ENTRY (FIXED BIN, (*) FLOAT, (*) FLOAT,
    FIXED BIN, FIXED BIN, CHAR(20));
  DCL ORIGIN ENTRY (FLOAT, FLOAT, FIXED BIN);
  DCL IN FILE INPUT;
  DCL OUT FILE OUTPUT ENVIRONMENT (CONSECUTIVE);
  DCL OPTION(50) FIXED;
  DCL (REJECT, INPUT) CHAR(80);
  DCL (X1(POINTS), Y1(POINTS), CORRECT(POINTS),
    ADDRESS(POINTS)) FLOAT CONTROLLED;
  DCL (SUMSQR(POINTS), VAR(POINTS)) FLOAT CONTROLLED;
  DCL (LAB1, LAB2) CHAR(20);
  DCL COMP(NCOMP) FLOAT CONTROLLED;
  DCL (DATE, TIME) CHAR(6);
  DCL (RUNS, PASSES, NUMWAV, POINTS) FIXED BIN;
  DCL (HEAD, XLAB, YLAB, GLAB, DATLAB) CHAR(80);
  CALL ORIGIN (0.0, 1.0, 1);
  GET FILE (IN) LIST (RUN);
  DO I=1 TO RUN;
    GET FILE (IN) LIST (OPTION(I));
  END;
  RUNCNT=RUN; M=1;
GETIN: GET EDIT (REJECT) (COL(1), A(70)) COPY;
  GET EDIT (INPUT) (COL(1), A(63)) COPY;
  GET STRING (INPUT) EDIT (DATE, TIME, RUNS, NUMWAV,
    PASSES, POINTS, LUMIN) (A(6), X(2), A(4),
    X(2), 5(F(5), X(2)));
  IF LUMIN=1 THEN
    GET STRING (INPUT) EDIT (DELTIM, RANGE)
      (X(49), 2(F(5), X(2)));
  J=1;
  ALLOCATE Y1(POINTS);
INDAT: GET EDIT (INPUT) (COL(1), A(70)) COPY;
  DO I=1 TO 7;
    GET STRING (SUBSTR(INPUT, (10*I-9), 8)) EDIT
      (Y1(J)) (F(8));
    IF J=POINTS THEN GO TO ENDIN;
    J=J+1;
  END;
  IF J-=POINTS+1 THEN GO TO INDAT;
ENDIN: RUNCNT=RUNCNT-1;
  J=1;
  Y1=-Y1;
  ALLOCATE CORRECT(POINTS);
  ALLOCATE ADDRESS(POINTS);

```

```

CORIN:GET EDIT (INPUT) (COL(1),A(70)) COPY;
      DO I=1 TO 5;
            GET STRING (SUBSTR(INPUT,(14*I-13),14)) EDIT
            (CORRECT(J),ADDRESS(J)) (2(F(5),X(2)));
            IF CORRECT(J)=0 THEN GO TO CORR;
            J=J+1;
      END;
      IF CORRECT(J-1)≠0 THEN GO TO CORIN;
CORR: ALLOCATE SUMSQR(POINTS);
      J=1;
INSQR:GET EDIT (INPUT) (COL(1),A(70)) COPY;
      DO I=1 TO 7;
            GET STRING (SUBSTR(INPUT,(10*I-9),8)) EDIT
            (SUMSQR(J)) (F(8));
            IF J=POINTS THEN GO TO ENDSQR;
            J=J+1;
      END;
      IF J≠POINTS+1 THEN GO TO INSQR;
ENDSQR:DO I=1 TO POINTS;
      IF CORRECT(I)=0 THEN GO TO ENDIT;
      SUMSQR(ADDRESS(I))=SUMSQR(ADDRESS(I))+
      CORRECT(I)*16777216;
      END;
ENDIT:FREE CORRECT;
      FREE ADDRESS;
      IF LUMIN=0 THEN GO TO FAST;
      ALLOCATE VAR(POINTS);
      VAR=ABS(SUMSQR-Y1**2/PASSES)/(PASSES-1);
      FREE SUMSQR;
      CHECK=999;
      DO I=1 TO POINTS;
            IF VAR(I)≠0 THEN CHECK=MIN(CHECK,VAR(I));
      END;
      DO I=1 TO POINTS;
            IF VAR(I)=0 THEN VAR(I)=CHECK;
      END;
      Y1=Y1/PASSES;
      ALLOCATE X1(POINTS);
      X1(1)=0;
      IF RANGE=1 THEN RANVAL=0.01;
            ELSE IF RANGE=2 THEN RANVAL=0.1;
            ELSE RANVAL=1;
      DO I=2 TO POINTS;
            X1(I)=X1(I-1)+RANVAL;
      END;
      GET FILE (IN) EDIT (LAB1,LAB2) (COL(1),2(A(20)));
      CALL ORIGIN (11.0,0.0,1);
      CALL GRAPH (POINTS,X1,Y1,1,7,9,7,0,0,0,0,
      'TIME (SEC)', 'INTENSITY', LAB1, LAB2);
      CALL GRAPHS (POINTS,X1,Y1,0,121,DATE||' ' ||TIME);

```

```

IF OPTION(M)=1 THEN GO TO SMASH;
DUMP: PUT PAGE;
PUT SKIP LIST ('TRS2 DATA DUMP');
PUT SKIP LIST ('DATE',DATE,'TIME',TIME,'RUN NO.',
              RUNS);
PUT SKIP LIST ('NUMBER OF PASSES',PASSES,
              'NUMBER OF XRAY WAVES',NUMWAV);
IF LUMIN=0 THEN GO TO CONT1;
PUT SKIP LIST ('TRANSIENT DECAY TIME (USEC)',(DELTIM*
              5+10),'INTEGRATION TIME (MSEC)',(10**RANGE));
PUT SKIP;
PUT SKIP LIST ('THE TIME VALUES ARE:');
PUT SKIP LIST (X1);
CONT1: PUT SKIP;
PUT SKIP LIST ('THE INTENSITY VALUES ARE:');
PUT SKIP LIST (Y1);
PUT SKIP;
PUT SKIP LIST ('THE VARIANCE VALUES ARE:');
PUT SKIP LIST (VAR);
PUT PAGE;
M=M+1;
IF RUNCNT-1=0 THEN GO TO GETIN;
PUT FILE (OUT) SKIP;
GO TO STOP;
SMASH: AVE=0; IFIRST=0; DEADT=0.0; SIGMAB=0.0;
DO I=1 TO 10;
      AVE=AVE+Y1 (POINTS+1-I);
END;
BACKGR=AVE/10;
GET FILE (IN) EDIT (ISMASH) (COL(1),F(2));
DO I=1 TO ISMASH;
      GET FILE (IN) EDIT (NCOMP,INPU,IPLLOT)
      (COL(1),3(F(5)));
      PUT FILE (OUT) EDIT (NCOMP,POINTS,IFIRST,
      INPU,DEADT,BACKGR,SIGMAB,IPLLOT)
      (COL(1),4(F(5)),3(F(12,3)),X(19),F(5));
      GET FILE (IN) EDIT (HEAD) (COL(1),A(80));
      PUT FILE (OUT) EDIT (HEAD) (COL(1),A(80));
      IF IPLLOT=0 THEN GO TO CONT3;
      GET FILE (IN) EDIT (XLAB,YLAB,GLAB,DATLAB)
      (COL(1),4(A(20)));
      PUT FILE (OUT) EDIT (XLAB,YLAB,GLAB,DATLAB)
      (COL(1),4(A(20)));
CONT3: ALLOCATE COMP(NCOMP);
      GET FILE (IN) EDIT (COMP) ((NCOMP)(F(10,3)));
      PUT FILE (OUT) EDIT (COMP) (COL(1),(NCOMP)
      (F(10,3)));
      FREE COMP;
      IF INPU<0 THEN GO TO CONT4;
      PUT FILE (OUT) EDIT (Y1) (COL(1),6 E(12,5));

```



```
                PUT FILE (OUT) EDIT (X1) (COL(1),6 E(12,5));  
                PUT FILE (OUT) EDIT (VAR) (COL(1),6 E(12,5));  
CCNT4:END;  
        GO TO DUMP;  
FAST: AVE=SUM(Y1)/POINTS;  
      VARI=0;  
      DO I=1 TO PCINTS;  
            VARI=VARI+((Y1(I)-AVE)**2);  
      END;  
      VARI=VARI/(POINTS-1);  
      STAND=SQRT(VARI);  
      PUT SKIP LIST ('THE AVERAGE VALUE IS:',AVE);  
      PUT SKIP LIST ('THE STANDARD DEVIATION IS:',STAND);  
      PUT SKIP;  
      GO TO DUMP;  
STOP: END CORE;
```

## APPENDIX 2: SMASH

SMASH is a FORTRAN IV program which determines decay constants for single component decay curves and initial intensities for each component in a multiple component decay curve. The operation of SMASH is described elsewhere (53). Several modifications were made on the input routines and declaration statements to facilitate the execution of the program for the analysis of spectroscopic data. SMASH is the second major step in the job which calculates experimental results. A listing of SMASH with the modifications appears on the following pages.

```

C
C   SMASH, A PROGRAM FOR THE ANALYSIS OF DECAY CURVES,
C   BY P.J.M. KCRTHOVEN AND F.S. CARLSEN
C
  CALL SMASH1
  STOP
  END
  SUBROUTINE SMASH1
  DIMENSION IPAR(10),SSIZE(10),X(10),Y(10)
  REAL LAMBDA(10)
  COMMON NSTEPS,NCOMP,FIT2,IFIRST,SSIZE,LAMBDA,ORFIT,
1NVAR,FIT1
1  NSTEPS=0
  KOUNT=0
  CALL SMINP1
  IF (NCOMP) 2,63,2
2  ICONV=NVAR*400
3  KOUNT=KOUNT+1
  DO 4 I=1,NCOMP
4  IPAR(I)=0
  IA=0
  IB=0
  CALL SMFIT1
  FIT1=FIT2
  IF (NVAR) 6,5,6
5  IFIRST=0
6  IF (IFIRST) 10,7,10
7  CALL SMOUT1(1)
  IFIRST=1
  IF (NVAR) 8,1,8
8  IF (KOUNT-1) 10,9,10
9  ORFIT=FIT2
10 TEMFIT=FIT2
11 FIT1=TEMFIT

C
C   INITIAL SEARCH
C
  DO 25 I=1,NCOMP
  X(I)=LAMBDA(I)
  IF (SSIZE(I)) 13,12,13
12 IPAR(I)=0
  GO TO 25
13 LAMBDA(I)=LAMBDA(I)+SSIZE(I)
  CALL SMFIT1
  IF (NSTEPS-ICONV) 14,14,62
14 IF (FIT2-FIT1) 15,20,20
15 IF (IPAR(I)-2) 16,17,16
16 IPAR(I)=0
17 IF (ABS(FIT2-FIT1)-0.000001) 19,18,18
18 IB=1

```

```

      IPAR(I) = 1
19  FIT1=FIT2
      GO TO 25
20  LAMBDA(I) = X(I) - SSIZE(I)
      CALL SMFIT1
      IF (NSTEPS-ICONV) 21,21,62
21  IF (FIT2-FIT1) 22,23,23
22  SSIZE(I) = -SSIZE(I)
      GO TO 15
23  LAMBDA(I) = X(I)
      IF (IPAR(I) - 2) 24,25,24
24  IPAR(I) = 0
25  CONTINUE

```

C  
C  
C

```

      END INITIAL SEARCH

26  DO 27 I=1,NCOMP
      IF (IPAR(I) - 1) 27,38,27
27  CONTINUE
      IF (IB) 28,33,28
28  DO 32 I=1,NCOMP
      IF (IPAR(I) - 2) 30,29,30
29  SSIZE(I) = SSIZE(I) * 0.2
      IPAR(I) = 0
30  IF (ABS(SSIZE(I)) - 0.00002*LAMBDA(I)) 31,32,32
31  SSIZE(I) = 0.0
32  CONTINUE
      IB=0
      GO TO 58
33  DO 34 I=1,NCOMP
      IF (ABS(SSIZE(I)) - 0.00002*LAMBDA(I)) 34,34,35
34  CONTINUE
      IF (ABS(FIT1-FIT2) - 0.000001) 61,3,3
35  DO 37 I=1,NCOMP
      SSIZE(I) = SSIZE(I) * 0.2
      IF (ABS(SSIZE(I)) - 0.00002*LAMBDA(I)) 36,37,37
36  SSIZE(I) = 0.0
37  CONTINUE
      GO TO 58

```

C  
C  
C

```

      ADJUST PARAMETERS FOR THE SELECTED SEARCH

38  TEMFIT=FIT1
      DO 43 I=1,NCOMP
      TEMP=LAMBDA(I)
      IF (IPAR(I) - 1) 40,39,40
39  LAMBDA(I) = LAMBDA(I) * 2.0 - X(I)
40  X(I) = TEMP
      IF (IA-1) 41,43,41
41  IPAR(I) = 0

```

```

      IF (SSIZE(I)) 42,43,42
42  IPAR(I)=1
43  CONTINUE
      CALL SMFIT1
      IF (NSTEPS-ICONV) 44,44,62
44  IF (FIT2-FIT1) 45,46,46
45  FIT1=FIT2
C
C      SELECTED SEARCH
C
46  DO 54 I=1,NCOMP
      IF (IPAR(I)-1) 54,47,54
47  Y(I)=LAMBDA(I)
      LAMBDA(I)=LAMBDA(I)+SSIZE(I)
      CALL SMFIT1
      IF (NSTEPS-ICONV) 48,48,62
48  IF (FIT2-FIT1) 53,49,49
49  LAMBDA(I)=Y(I)-SSIZE(I)
      CALL SMFIT1
      IF (NSTEPS-ICONV) 50,50,62
50  IF (FIT2-FIT1) 51,52,52
51  SSIZE(I)=-SSIZE(I)
      GO TO 53
52  LAMBDA(I)=Y(I)
      IPAR(I)=2
      GO TO 54
53  IA=1
      IB=1
      FIT1=FIT2
54  CONTINUE
C
C      END SELECTED SEARCH
C
      IF (FIT1-TEMFIT) 38,55,55
55  DO 57 I=1,NCCMP
      IF (IPAR(I)-1) 57,56,57
56  IPAR(I)=2
57  LAMBDA(I)=X(I)
      IA=0
      GO TO 11
58  IF (FIT2-TEMFIT) 10,59,59
59  DO 60 I=1,NCCMP
60  LAMBDA(I)=X(I)
      GO TO 11
61  CALL SMOUT1 (0)
      GO TO 1
62  CALL SMOUT1 (-1)
      GO TO 1
63  STOP
      END

```

C  
C  
C

## SUBROUTINE INPUT

```

SUBROUTINE SMINP1
  DIMENSION IDENT(20), HALFL(10), SSIZE(10), XLAB(5),
  1YLAB(5), DATLAB(5), GLAB(5), TM(1000), RATE(1000),
  2DIFF(1000), ACALC(1000), AO(10), C(10,10), P(1000,10),
  3BGRND(1000), SIGMBG(1000), RAVAR(1000), DFIT(10),
  4VAR(1000), COUNTS(1000), DELTAT(1000), WDIFF(1000),
  5X(10), HL(10)
  REAL LAMBDA(10)
  INTEGER DF
  COMMON NSTEPS, NCOMP, FIT2, IFIRST, SSIZE, LAMBDA, ORFIT,
  1IDENT, TM, RATE, VAR, XLAB, YLAB, GLAB, DATLAB, IPLOT, COUNTS,
  2ACALC, DIFF, DF, HL, AO, C, P, WDIFF, KS, DEADT, BACKGR, SIGMAB,
  3RAVAR, IWRT, FIT1, NVAR, DELTAT, NP, HALFL, TO
  NVAR=0
  READ(5,101) NCOMP, NP, IFIRST, INPU, DEADT, BACKGR, SIGMAB,
  1IDUAL, IPLOT
101 FORMAT(4I5,3F12.3,14X,2I5)
  IF(IPLOT) 116,115,116
116 CALL ORIGIN(0.0,0.0,0)
  CALL ORIGIN(0.0,1.0,1)
115 IF(NCOMP) 102,145,102
102 READ(5,103) (IDENT(I), I=1,20)
103 FORMAT(20A4)
  IF(IPLOT) 104,105,104
104 READ(5,103) XLAB, YLAB, GLAB, DATLAB
105 READ(5,106) (HALFL(I), I=1, NCOMP)
106 FORMAT(8F10.3)
  IF(INPU) 129,112,111
111 NCOMP=0
  GO TO 145
112 READ(5,126) (COUNTS(I), I=1, NP)
  READ(5,126) (TM(I), I=1, NP)
  READ(5,126) (VAR(I), I=1, NP)
126 FORMAT(6E12.5,8X)
113 DO 127 I=1, NP
  RATE(I)=COUNTS(I)-BACKGR
  RAVAR(I)=RATE(I)/VAR(I)
  DELTAT(I)=TM(I)
127 CONTINUE
  DO 128 I=2, NP
128 TM(I)=TM(I)-TM(1)
  TO=TM(1)
  TM(1)=0.0
129 DO 130 I=1, NCOMP
  IF(HALFL(I)) 220,230,220
230 LAMBDA(I)=0.0
  GO TO 130

```

```

220 LAMBDA (I) =ABS (HALFL (I))
130 CONTINUE
    IF (NCOMP-1) 107, 107, 108
108 XN=0.0
    IWRIT=1
    CALL SMFIT1
    FIT1=FIT2
    DO 131 I=1, NCOMP
    X (I) =LAMBDA (I)
    IF (HALFL (I)) 132, 136, 136
132 XX=LAMBDA (I) *0.05
    LAMBDA (I) =LAMBDA (I) +XX
    CALL SMFIT1
    IF (FIT2-FIT1) 133, 134, 134
134 LAMBDA (I) =LAMBDA (I) -2.0*XX
    CALL SMFIT1
    IF (FIT2-FIT1) 133, 136, 136
133 DFIT (I) =FIT1-FIT2
    GO TO 135
136 DFIT (I) =XN- 1.0
135 LAMBDA (I) =X (I)
131 CONTINUE
    DO 140 I=1, NCOMP
    K=NCOMP-1
    DO 140 J=1, K
    IF (DFIT (J) -DFIT (J+1)) 141, 140, 140
141 SWAP=DFIT (J)
    DFIT (J) =DFIT (J+1)
    DFIT (J+1) =SWAP
    SWAP=LAMBDA (J)
    LAMBDA (J) =LAMBDA (J+1)
    LAMBDA (J+1) =SWAP
    SWAP=HALFL (J)
    HALFL (J) =HALFL (J+1)
    HALFL (J+1) =SWAP
140 CONTINUE
107 IWRIT=0
    NSTEPS=0
    DO 142 I=1, NCOMP
    IF (HALFL (I)) 143, 144, 144
143 SSIZE (I) =0.05*LAMBDA (I)
    NVAR=NVAR+1
    GO TO 142
144 SSIZE (I) =0.0
142 CONTINUE
145 RETURN
    END

```

```

C
C   SUBROUTINE FIT
C

```

```

SUBROUTINE SMFIT1
  DIMENSION TM(1000), P(1000,10), V(10), RATE(1000),
  1A0(10), ACALC(1000), DIFF(1000), HL(10), IDENT(20),
  2YLAB(5), GLAB(5), DATLAB(5), COUNTS(1000), DELTAT(1000),
  3HALFL(10), RAVAR(1000), CC(10,10), PAR(10), WDIFF(1000),
  4XLAB(5), SSIZE(10), VAR(1000), C(10,10)
  REAL LAMBDA(10)
  INTEGER DF
  COMMON NSTEPS, NCOMP, FIT2, IFIRST, SSIZE, LAMBDA, ORFIT,
  1IDENT, TM, RATE, VAR, XLAB, YLAB, GLAB, DATLAB, IPLOT, CCOUNTS,
  2ACALC, DIFF, DF, HL, A0, C, P, WDIFF, KS, DEADT, BACKGR, SIGMAB,
  3RAVAR, IWRTIT, FIT1, NVAR, DELTAT, NP, HALFL, TO
  NSTEPS=NSTEPS+1
  IF (NSTEPS-1) 700,701,700
701 DO 702 I=1, NCOMP
702 PAR(I)=1.0E60
700 DO 2031 J=1, NCOMP
  IF (PAR(J)-LAMBDA(J)) 300,2031,300
300 DO 203 I=1, NP
  DECAYF=-LAMBDA(J)*TM(I)
  IF (ABS(DECAYF)-50.0) 202,201,201
201 P(I,J)=0.0
  GO TO 203
202 P(I,J)=EXP(DECAYF)
203 CONTINUE
2031 CONTINUE
  DO 204 I=1, NCOMP
  IF (PAR(I)-LAMBDA(I)) 320,204,320
320 V(I)=0.0
  DO 204 K=1, NP
  V(I)=V(I)+P(K,I)*RAVAR(K)
204 CONTINUE
  DO 2051 I=1, NCOMP
  DO 2051 J=1, NCOMP
  IF (PAR(I)-LAMBDA(I)) 2205,2206,2205
2206 IF (PAR(J)-LAMBDA(J)) 2205,2207,2205
2207 C(I,J)=CC(I,J)
  GO TO 2051
2205 C(I,J)=0.0
  DO 205 K=1, NP
  C(I,J)=C(I,J)+P(K,I)*P(K,J)/VAR(K)
  205 CC(I,J)=C(I,J)
2051 CONTINUE
  DO 2500 I=1, NCOMP
2500 PAR(I)=LAMBDA(I)
  CALL SMATNV(C, NCOMP, DETERM)
  DO 206 I=1, NCOMP
  A0(I)=0.0
  DO 206 J=1, NCOMP
206 A0(I)=A0(I)+C(I,J)*V(J)

```



```

RS=0.0
DO 208 I=1, NP
ACALC (I)=0.0
DO 207 J=1, NCOMP
207 ACALC (I)=ACALC (I) +P (I, J) *A0 (J)
DIFF (I)=RATE (I) -ACALC (I)
RS=RS+DIFF (I) **2/VAR (I)
208 CONTINUE
DF=NP-NCOMP
XDF=DF
FIT2=SQRT (RS/XDF)
IF (IWRIT) 217, 751, 217
751 DO 211 I=1, NCOMP
IF (LAMBDA (I)) 210, 209, 210
209 HL (I)=0.0
GO TO 211
210 HL (I)=LAMBDA (I)
211 CONTINUE
IF (NSTEPS-1) 215, 212, 215
212 IF (IFIRST) 213, 217, 213
213 WRITE (6, 214) (I, I=1, NCOMP)
214 FORMAT (1H1, 5H STEP, 6X, 3HFIT, 9X, 9 (1H-, I1, 1H-, 8X), 1H-,
1I2, 1H-/1H0)
215 WRITE (6, 216) NSTEPS, FIT2, (HL (I), I=1, NCOMP)
216 FORMAT (I5, F13.6, 9F11.4, F12.4)
217 RETURN
END

```

C  
C  
C

SUBROUTINE MATINV

```

SUBROUTINE SMATNV (A, N, DETERM)
DIMENSION A (10, 10), PIVOT (10), INDEX (10, 2), IPIVOT (10)
EQUIVALENCE (IROW, JROW), (ICOLU, JCOLU), (AMAX, T, SWAP)

```

C  
C  
C

INITIALIZATION

```

DETERM=1.0
DO 301 J=1, N
301 IPIVOT (J)=0
DO 314 I=1, N

```

C  
C  
C

SEARCH FOR PIVOT ELEMENT

```

AMAX=0.0
DO 306 J=1, N
IF (IPIVOT (J) -1) 302, 306, 302
302 DO 305 K=1, N
IF (IPIVOT (K) -1) 303, 305, 318
303 IF (ABS (AMAX) -ABS (A (J, K))) 304, 305, 305
304 IROW=J

```

```

        ICOLUM=K
        AMAX=A (J, K)
305  CONTINUE
306  CONTINUE
        IPIVOT (ICOLUM) =IPIVOT (ICOLUM) +1
C
C      INTERCHANGE ROWS TO PUT PIVOT ELEMENT ON DIAGONAL
C
        IF (IROW-ICOLUM) 307,309,307
307  DETERM=-DETERM
        DO 308 L=1, N
        SWAP=A (IROW, L)
        A (IROW, L) =A (ICOLUM, L)
308  A (ICOLUM, L) =SWAP
309  INDEX (I, 1) =IROW
        INDEX (I, 2) =ICOLUM
        PIVOT (I) =A (ICOLUM, ICOLUM)
        DETERM=DETERM*PIVOT (I)
C
C      DIVIDE PIVOT ROW BY PIVOT ELEMENT
C
        A (ICOLUM, ICOLUM) =1.0
        DO 310 L=1, N
310  A (ICOLUM, L) =A (ICOLUM, L) /PIVOT (I)
C
C      REDUCE NON-PIVOT ROWS
C
311  DO 314 L1=1, N
        IF (L1-ICOLUM) 312,314,312
312  T=A (L1, ICOLUM)
        A (L1, ICOLUM) =0.0
        DO 313 L=1, N
313  A (L1, L) =A (L1, L) -A (ICOLUM, L) *T
314  CONTINUE
C
C      INTERCHANGE COLUMNS
C
        DO 317 I=1, N
        L=N+1-I
        IF (INDEX (L, 1) -INDEX (L, 2)) 315,317,315
315  JROW=INDEX (L, 1)
        JCOLUM=INDEX (L, 2)
        DO 316 K=1, N
        SWAP=A (K, JROW)
        A (K, JROW) =A (K, JCOLUM)
        A (K, JCOLUM) =SWAP
316  CONTINUE
317  CONTINUE
318  RETURN
        END

```

C  
C  
C

## SUBROUTINE OUTPUT

```

SUBROUTINE SMOUT1(ICASE)
  DIMENSION DATLAB(5),AO(10),P(1000,10),SAZERO(10),
  1IDENT(20),SRELAT(10),WDIFF(1000),HALFL(10),HL(10),
  2DELTAT(1000),COUNTS(1000),RATE(1000),ACALC(1000),
  3XLAB(5),YLAB(5),GLAB(5),THALFL(10),TEMPHL(5),
  4SSIZE(10),TM(1000),CORR(10),DIFF(1000),VAR(1000),
  5AZERO(10),C(10,10)
  REAL LAMBDA(10),LOGACT(1000),LOGFC(1000)
  INTEGER DF
  COMMON NSTEPS,NCOMP,FIT2,IFIRST,SSIZE,LAMBDA,ORFIT,
  1IDENT,TM,RATE,VAR,XLAB,YLAB,GLAB,DATLAB,IPLLOT,COUNTS,
  2ACALC,DIFF,DF,HL,AO,C,P,WDIFF,KS,DEADT,BACKGR,SIGMAB,
  3HALFL,TO,DELTAT,NP,FIT1,NVAR
  EQUIVALENCE (LOGACT(1),WDIFF(1)),(LOGFC(1),ACALC(1))
  DO 400 I=1,NP
400  TM(I)=TM(I)+TO
      DO 401 I=1,NCOMP
          CORR(I)=EXP(TO*LAMBDA(I))
          AZERO(I)=AO(I)*CORR(I)
          SAZERO(I)=SQRT(C(I,I))*CORR(I)*FIT1
401  SRELAT(I)=SAZERO(I)/AZERO(I)*100.0
          IPERC1=0
          IPERC2=0
          IPERC3=0
          DO 406 I=1,NP
              VAR(I)=SQRT(VAR(I))
              WDIFF(I)=DIFF(I)/VAR(I)
              IWDIFF=IABS(IFIX(WDIFF(I)))+1
              IF (ABS(WDIFF(I))-3.0) 402,403,403
402  GO TO (406,404,405),IWDIFF
403  IPERC3=IPERC3+1
              GO TO 406
404  IPERC1=IPERC1+1
              GO TO 406
405  IPERC2=IPERC2+1
406  CONTINUE
          PERC1=FLOAT(IPERC1+IPERC2+IPERC3)/FLOAT(NP)*100.0
          PERC2=FLOAT(IPERC2+IPERC3)/FLOAT(NP)*100.0
          PERC3=FLOAT(IPERC3)/FLOAT(NP)*100.0
          WRITE (6,407) (IDENT(I),I=1,20)
407  FORMAT (1H1,20A4)
          IF (ICASE) 408,410,414
408  WRITE (6,409) NSTEPS
409  FORMAT (86H THE SOLUTION IS NOT YET REACHED, OUTPUT IS
  1CALCULATED WITH THE PARAMETER VALUES AFTER,I5,6H STEPS
  2/1H0)
      GO TO 412

```

```

410 WRITE (6,411)
411 FORMAT (45H RESULTS OBTAINED WITH FINAL PARAMETER
1VALUES/1H0)
412 WRITE (6,413) NP,NSTEPS,NCOMP,PERC1,NVAR,DF,PERC2,
2BACKGR,SIGMAB,PERC3,DEADT,ORFIT,FIT1
413 FORMAT (15X,16HINPUT QUANTITIES,50X,17HOUTPUT QUANTITI
1ES//12X,23HNUMBER OF DATA POINTS =,I5,56X,17HNUMBER OF
2 STEPS =,I5/13X,22HNUMBER OF COMPONENTS =,I5,23X,50HPE
3RCENTAGE OF POINTS DEVIATING MORE THAN 1 SIGMA =,F8.2/
44X,31HNUMBER OF VARIABLE DECAY CONS =,I5,34X,28H(THEOR
5ETICAL VALUE = 31.74 ) /15X,20HDEGREES OF FREEDOM =,I5
6,23X,50HPERCENTAGE OF POINTS DEVIATING MORE THAN 2 SIG
7MA =,F8.2/7X,28HBACKGROUND (COUNTS/MINUTE) =,F9.1,30X,
828H(THEORETICAL VALUE = 4.56 )/1H ,34HSIGMA BACKGRCON
9D (COUNTS/MINUTE) =,F7.1,21X,50HPERCENTAGE OF POINTS D
8EVIATING MORE THAN 3 SIGMA =,F8.2/8X,27HDEAD TIME (MIC
7RO SECONDS) =,F7.1,32X,29H(THEORETICAL VALUE = 0.26 )
6//21X,14HORIGINAL FIT =,F14.6,53X,11HFINAL FIT =,F14.6
5//1H0)
IF (ICASE) 445,548,417
445 WRITE (6,447)
447 FORMAT (1H0/58X,17H*****WARNING*****/51X,30H*****CHECK
1 YOUR ESTIMATES*****/1H0/1H0)
GO TO 448
548 NEG=0
DO 442 I=1,NCOMP
IF (AZERO(I)) 443,443,442
443 NEG=1
442 CONTINUE
IF (NEG-1) 438,460,460
460 WRITE (6,444)
444 FORMAT (1H0/58X,17H*****WARNING*****/38X,56H*****THE N
1UMBER OF COMPONENTS IS PROBABLY TOO LARGE*****/1H0)
GO TO 448
438 IF (FIT2-2.0) 448,439,439
439 WRITE (6,440)
440 FORMAT (1H0/58X,17H*****WARNING*****/38X,56H*****THE N
1UMBER OF COMPONENTS IS PROBABLY TOO SMALL*****/1H0)
GO TO 448
414 WRITE (6,415)
415 FORMAT (48H RESULTS OBTAINED WITH ORIGINAL PARAMETER
1VALUES/1H0)
DO 416 I=1,NCOMP
TEMPHL(I)=HL(I)
THALFL(I)=HALFL(I)
HALFL(I)=ABS(HALFL(I))
416 HL(I)=0.0
FIT1=FIT2
NV=NVAR
NVAR=0

```

```

ORFIT=0.0
GO TO 412
417 IF (NV) 448,449,448
449 IF (FIT1-2.0) 448,450,450
450 WRITE (6,447)
448 IF (ICASE) 420,420,418
418 NVAR=NV
420 WRITE (6,421)
421 FORMAT (1H0,22X,9HCOMPONENT,8X,8HORIGINAL,9X,5HFINAL,9
1X,8HACTIVITY,9X,5HSIGMA,9X,5HSIGMA/39X,9HDECAY CON,7X,
29HDECAY CON,8X,6HAT EOB,8X,8HABSOLUTE,7X,8HRELATIVE//)
WRITE (6,422) (I,HALFL(I),HL(I),AZERO(I),SAZERO(I),
1SRELAT(I),I=1,NCOMP)
422 FORMAT (22X,I5,F21.4,F16.4,F16.3,F14.3,F13.3)
WRITE (6,423)
423 FORMAT (1H0//1H0)
424 WRITE (6,425)
425 FORMAT (8X,7HMDTIME,7X,4HTIME,10X,8HORIGINAL,8X,9HCO
1RRECTED,8X,5HSIGMA,8X,10HCALCULATED,9X,8HABSOLUTE,11X,
210HDIFFERENCE/9X,5HCOUNT,6X,8HINTERVAL,10X,4HDATA,13X,
34HRATE,11X,4HRATE,11X,4HRATE,11X,10HDIFFERENCE,8X,13H(
4SIGMA UNITS)/1H0)
WRITE (6,426) (I, TM(I), DELTAT(I), COUNTS(I), RATE(I),
1VAR(I), ACALC(I), DIFF(I), WDIFF(I), I=1, NP)
426 FORMAT (I4, F10.6, F12.6, F18.1, F17.1, F14.1, F16.1,
1F18.1, F18.3)
427 DO 428 I=1, NP
428 VAR(I)=VAR(I)**2
IF (IPLOT) 429,432,431
429 DO 430 I=1, NP
IF (RATE(I)) 461,461,462
461 RATE(I)=1.0
462 LOGACT(I)=ALOG10(RATE(I))
IF (ACALC(I)) 463,463,464
463 ACALC(I)=1.0
464 LOGFC(I)=ALOG10(ACALC(I))
430 CONTINUE
CALL ORIGIN (11.0,0.0,1)
CALL GRAPH (NP, TM, LOGACT, 3, 7, 9., -7., 0, 0, 0, 0, XLAB, YLAB,
1GLAB, DATLAB)
CALL GRAPH (NP, TM, LOGFC, 3, 2, 0, 0, 0, 0, 0, 0, 0, 0, 0)
GO TO 432
431 CALL ORIGIN (11.0,0.0,1)
CALL GRAPH (NP, TM, RATE, 3, 7, 9., 7., 0, 0, 0, 0, XLAB, YLAB,
1GLAB, DATLAB)
CALL GRAPH (NP, TM, ACALC, 3, 2, 0, 0, 0, 0, 0, 0, 0, 0, 0)
432 IF (ICASE) 437,437,433
433 DO 419 I=1, NCOMP
HL(I)=TEMPHL(I)
419 HALFL(I)=THALFL(I)

```

```
      IF (NVAR) 434,437,434
434 WRITE (6,435) (I,I=1,NCOMP)
435 FORMAT (1H1,5H STEP,6X,3HFIT,9X,9(1H-,I1,1H-,8X),1H-,
      1I2,1H-/1H0)
      WRITE (6,436) NSTEES,FIT2,(HL(I),I=1,NCOMP)
436 FORMAT (I5,F13.6,9F11.4,F12.4)
437 DO 446 I=1,NP
446 TM(I)=TM(I)-TO
      RETURN
      END
```

## APPENDIX 3: GENPLOT

GENPLOT, a utility program for the generation of plots of general data, is a combination of a WYLBUR execute file and a PL/1 program. The execute file requests input information and data from the operator. The PL/1 program accesses Simplotter with CALL GRAPH and CALL GRAPHS statements. Logarithmic or linear plots can be generated. Several data sets can be plotted on the same graph and several graphs can be plotted at one time.

GENPLOT was used to plot calibration curves, decay curves, current, voltage and time relationships and other general data. The program was written to plot general data sets with many options of Simplotter available. Increased use of GENPLOT for examination of data trends and shapes of curves should be encouraged. The listing of the program follows on subsequent pages.

```

10  SET EXEC NOL TERSE
20  SET ESC :
25  CLR TEXT
30  COPY 700/761 EXEC TO 1
40  REA VAL N0 PRO 'NUMBER OF GRAPHS ? '
50  CH '###' TO ':N0' N
55  SET VAL W0=100
60  SET VAL N1=0
70  SET VAL N1=N1+1
80  IF (N1 GT N0) EXEC 550
90  REA VAL N2 PRO 'NUMBER OF PLOTS ON GRAPH :N1 ? '
100 :W0 :N2
101 SET VAL W0=W0+1
110 SET VAL N3=0
130 REA STR S0 PRO 'X-AXIS LABEL ? '
140 :W0 ':S0'
145 SET VAL W0=W0+1
150 REA STR S0 PRO 'Y-AXIS LABEL ? '
160 :W0 ':S0'
165 SET VAL W0=W0+1
170 REA STR S0 PRO 'GRAPH LABEL ? '
180 :W0 ':S0'
181 SET VAL W0=W0+1
182 REA STR S0 PRO 'LIN=LINEAR OR LOG=LOGARITHMIC PLOT ? '
183 :W0 ':S0'
190 SET VAL W0=W0+1
200 SET VAL N3=N3+1
210 IF (N3 GT N2) EXEC 70
220 REA VAL N4 PRO 'HOW MANY POINTS IN PLOT :N3 ? '
230 REA VAL N5 PRO 'ENTER A NUMBER BETWEEN 1-13 ! '
240 SET VAL S0=N4||' '||N5
250 :W0 :S0
260 SET VAL W0=W0+1
270 SET VAL N5=0
274 COMM ENTER X VALUES ONE AT A TIME
275 SET VAL S1=''
280 SET VAL N5=N5+1
285 IF (N5 GT N4) EXEC 340
300 REA STR S0 PRO 'X (:N5) = '
310 SET VAL S1=S1||' '||S0
320 IF (SIZE(S1) LE 60) EXEC 280
330 EXEC 500 SAVE
333 IF (N5 EQ N4) EXEC 360
335 EXEC 275
340 :W0 :S1
350 SET VAL W0=W0+1
360 SET VAL N5=0
364 COMM ENTER Y VALUES ONE AT A TIME
365 SET VAL S1=''
370 SET VAL N5=N5+1

```



```

375 IF (N5 GT N4) EXEC 430
390 REA STR S0 PRO 'Y(:N5) = '
400 SET VAL S1=S1||' '||S0
410 IF (SIZE(S1) LE 60) EXEC 370
420 EXEC 500 SAVE
423 IF (N5 EQ N4) EXEC 450
425 EXEC 365
430 :W0 :S1
440 SET VAL W0=W0+1
450 REA STR S0 PRO 'DATA LABEL ? '
460 :W0 ':S0'
470 SET VAL W0=W0+1
480 EXEC 200
500 :W0 :S1
510 SET VAL W0=W0+1
520 EXEC RETURN
550 COMM TO PLOT DATA TYPE EXEC NEXT
560 EXEC PAUSE
570 COPY 800/805 EXEC TO L+1
600 RUN UNN
610 EXEC PAUSE
700 //A411GJO JOB A0099,GJO,TIME=(,29)
701 //S1 EXEC PL1LFCG,PARM.PL1L='A,X,NEST',REGION.GC=128K
702 //PL1L.SYSIN DD *
703 PLOT:PROC OPTIONS (MAIN);
704 DCL GRAPH ENTRY(FIXED BIN, (*) FLOAT, (*) FLOAT, FIXED
705 BIN, FIXED BIN, FLOAT, FLOAT, FLOAT, FLOAT, FLOAT,
706 CHAR(20), CHAR(20), CHAR(20), CHAR(20));
707 DCL GRAPHS ENTRY (FIXED BIN, (*) FLOAT, (*) FLOAT, FIXED
708 BIN, FIXED BIN, CHAR(20));
709 DCL LETTRS ENTRY (FLOAT, FLOAT, FLOAT, CHAR(80), FLOAT,
709.5 FIXED BIN);
710 DCL ORIGIN ENTRY (FLOAT, FLOAT, FIXED BIN);
711 DCL (XLAB, YLAB, GLAB, DATLAB) CHAR(20) VARYING;
712 DCL (STRING) CHAR (3);
713 CALL ORIGIN (0.0, 3.0, 1);
714 DO I=1 TO ###;
715 CALL ORIGIN (8.5, 0.0, 1);
716 CALL ORIGIN (1.0, -1.5, 6);
717 GET LIST (IPLOT);
718 GET LIST (XLAB, YLAB, GLAB);
719 GET LIST (STRING);
720 GET LIST (NPOINTS, ISYM);
721 PLOT1:BEGIN;
722 DCL (X(NPOINTS), Y(NPOINTS)) FLOAT;
723 GET LIST (X);
724 GET LIST (Y);
725 GET LIST (DATLAB);
726 IF STRING='LOG' THEN DO;
727 X=LOG10(X);

```

```

728     Y=LOG10(Y) ;
729     END;
730     IF STRING='LOG' THEN DO;
731     I5=-5;
732     XYSF=0.5;
733     END;
734     ELSE DO;
735     I5=5;
736     XYSF=0.0;
737     END;
738     CALL GRAPH (NPOINTS,X,Y,ISYM,7,I5,I5,XYSF,0.0,XYSF,
739     0.0,' ',' ',' ',' ',DATLAB);
740     CALL LETTRS (0.0,5.5,0.2,GLAB,0.0,80);
741     CALL LETTRS ((5-(LENGTH(XLAB)/5))/2,-1.0,0.2,XLAB,
741.5 0.0,20);
742     CALL LETTRS (-1.0,(5-(LENGTH(YLAB)/5))/2,0.2,YLAB,
742.5 90.0,20);
743     END PLOT1;
744     IF IPLOTS=1 THEN GO TO STOP;
745     DO J=2 TO IPLOT;
746     GET LIST (NPOINTS,ISYM);
747     PLOTS:BEGIN;
748     DCL (X(NPOINTS),Y(NPOINTS)) FLOAT;
749     GET LIST (X);
750     GET LIST (Y);
751     GET LIST (DATLAB);
752     IF STRING='LOG' THEN DO;
753     X=LOG10(X);
754     Y=LOG10(Y);
755     END;
756     CALL GRAPHS (NPOINTS,X,Y,ISYM,107,DATLAB);
757     END PLOTS;
758     END;
759     END;
760     STOP:END PLOT;
761     //GO.SYSIN DD *
800     //GO.FT14F001 DD DSN=ESM,UNIT=SCRATCH,DISP=(NEW,PASS),
801     // SPACE=(800,(120,15)),DCB=(RECFM=VS,LRECL=796,
802     // BLKSIZE=800)
803     /*
804     //SMPLTR EXEC PLOT,PLOTTER=INCRMNTL,FORM=W
805     /*
806     //

```

## APPENDIX 4: TRSGJO

TRSGJO is an assembly language program which runs on the PDP8/E minicomputer. TRSGJO controls the x-ray pulse generation, data acquisition and format of the paper tape data set of the pulsed XEOL system. The assembly language program is composed of several subroutines. Many of the subroutines are utilities for accepting input from the keyboard or paper tape reader, generating output on the teletype or paper tape punch or performing simple numerical operations. The subroutines which contain interface instructions control the x-ray supply or gated integrator. The program, in compiled form, appears on the following pages.

/ TRSGJO  
/ OESTREICH 5-20-77

0000 FIELD 0

0000 \*0

0020 \*20

00020 7402 HLT  
00021 0000 CNTR1, 0  
00022 0000 CNTR2, 0  
00023 3777 ISTORE, 3777  
00024 0000 P, 0  
00025 0000 PASSES, 0  
00026 0000 SUM2, 0  
00027 0000 NUMWAV, 0  
00030 0000 DELTIM, 0  
00031 0000 PUN1, 0  
00032 0000 RUNCNT, 0  
00033 0000 LUMIN, 0  
00034 0000 DATPOT, 0  
00035 0000 RANGE, 0  
00036 0000 N, 0  
00037 0000 SUM, 0  
00040 0000 DELRAN, 0  
00041 0000 TEMPST, 0  
00042 0000 0  
00043 0000 CNT1, 0  
00044 0000 CNT2, 0  
00045 0000 HIGH, 0  
00046 0000 LOW, 0

0200 \*200

00200 7300 START, CLA CLL /CLEAR LINK & LINK  
00201 6046 TLS /RAISE TTY PRINT FLAG  
00202 4577 JMS I DATTIM /INPUT DATE & TIME  
00203 4576 RESET, JMS I RESET1 /RESET ROUTINE  
00204 4231 PASS, JMS SET1 /SET WORKING VARIABLES  
00205 4575 JMS I PREP /ROTOR ON & ENABLE  
00206 1033 TAD LUMIN  
00207 7650 SNA CLA  
00210 4304 JMS BCMB2 /XRAYS FAST  
00211 4254 JMS BOMB /X-RAYS SLOW  
00212 4574 JMS I SUMDAT  
00213 4573 JMS I SUMSQR /SUM SQUARES  
00214 2024 ISZ P /TEST PASS COUNT  
00215 5204 JMP PASS

00216	4572		JMS I DATOUT	
00217	7200		CLA	
00220	1377		TAD (MSG15-1	/ANOTHER RUN ?
00221	3017		DCA 17	
00222	4571		JMS I MESSAGE	
00223	4570		JMS I NUMGET	/GET ANSWER
00224	7640		SZA CLA	
00225	5203		JMP RESET	
00226	4567		JMS I ENDFIL	
00227	4566		JMS I CRLF	
00230	7402		HLT	
00231	0000	SET1,	0	/SET WORKING VARIABLES
00232	7200		CLA	
00233	1023		TAD ISTORE	/SET STORAGE POINTER
00234	3010		DCA 10	
00235	1033		TAD LUMIN	/FAST OR SLOW
00236	7650		SNA CLA	
00237	5251		JMP POINTS	/FAST, GO BOMB
00240	7340		CLA CLL CMA	/SLOW, SET OTHERS
00241	1034		TAD DATPOT	/DATA POINT COUNTER
00242	3037		DCA SUM	
00243	7340		CLA CLL CMA	
00244	1010		TAD 10	
00245	3010		DCA 10	
00246	1034		TAD DATPOT	/DATA REFERENCE
00247	3026		DCA SUM2	
00250	5631		JMP I SET1	
00251	1027	POINTS,	TAD NUMWAV	
00252	3026		DCA SUM2	
00253	5631		JMP I SET1	
00254	0000	BOMB,	0	/BCMB ROUTINE
00255	6337		CSTART	/CONTROLLER STARTS
00256	1027		TAD NUMWAV	/# OF WAVES
00257	3036		DCA N	
00260	6331		CREADY	/COMPUTER READY
00261	6332		NOW	/ZERO CROSSING OF WAVE
00262	5261		JMP .-1	
00263	6333	MULTI,	XON	/TURN XRAY ON
00264	7346		CLA CLL CMA RTL	
00265	4565		JMS I DEL	/5 USEC * AC DELAY
00266	6332		NOW	/INDICATES X-RAY OFF
00267	5266		JMP .-1	
00270	6334		XOFF	/HOLDS X-RAYS OFF
00271	7346		CLA CLL CMA RTL	
00272	4565		JMS I DEL	/5 USEC * AC DELAY
00273	2036		ISZ N	/ANOTHER WAVE ?
00274	5263		JMP MULTI	/YES, REPEAT PROCESS
00275	6336		CWAIT	/NO, RESET NOW PULSE

00276	6344		XDABLE	/XRAY DISABLE
00277	6342		ROTROF	/TURN ROTOR OFF
00300	1030		TAD DELTIM	/TRANSIENT DELAY
00301	4565		JMS I DEL	/5 USEC * AC DELAY
00302	4564		JMS I DATA	/COLLECT DATA
00303	5654		JMP I BOMB	
00304	0000	BOMB2,	0	/BCMB ROUTINE FAST
00305	6337		CSTART	/CONTROLLER START
00306	1027		TAD NUMWAV	
00307	3036		DCA N	
00310	6331		CREADY	/COMPUTER READY
00311	6332		NOW	
00312	5311		JMP .-1	
00313	6333	MULT,	XON	/TURN XRAY ON
00314	1376		TAD (-1440	
00315	4565		JMS I DEL	/5 USEC * AC DELAY
00316	6345		STBOX	/START INTEGRATOR
00317	6332		NOW	
00320	5317		JMP .-1	
00321	6334		XOFF	/HOLD XRAY OFF
00322	1376		TAD (-1440	
00323	4565		JMS I DEL	/5 USEC * AC DELAY
00324	6455		STATOD	/START A TO D
00325	7346		CLA CLL CMA RTL	
00326	4565		JMS I DEL	/5 USEC * AC DELAY
00327	6354		GETDAT	/GET DATA POINT
00330	6346		INBOX	/RESET INTEGRATOR
00331	3410		DCA I 10	
00332	6332		NOW	
00333	5332		JMP .-1	
00334	7346		CLA CLL CMA RTL	
00335	4565		JMS I DEL	/5 USEC * AC DELAY
00336	2036		ISZ N	/MORE WAVES ?
00337	5313		JMP MULT	/YES, BOMB
00340	6336		CWAIT	/NO, RESET
00341	6344		XDABLE	/DISABLE XRAY
00342	6342		ROTROF	/TURN ROTOR OFF
00343	2304		ISZ BOMB2	
00344	5704		JMP I BOMB2	
00376	6340			
00377	3206			
	0400	* 400		
00400	0000	MESSAGE,	0	/MESSAGE ROUTINE
00401	7300	ENT10,	CLA CLL	
00402	1241		TAD LIT1	
00403	3240		DCA BYTCNT	

00404	1417		TAD I 17	
00405	3246		DCA STOR1	
00406	1246		TAD STOR1	
00407	7002		BSW	/BYTE SWAP
00410	0242	ENT11,	AND LIT2	/CHECK FOR TERMINATOR
00411	7440		SZA	/ZERO IN AC ?
00412	5214		JMP .+2	/NO; CONTINUE
00413	5600		JMP I MESSAGE	/YES; END MESSAGE
00414	1243		TAD LIT3	
00415	7500		SMA	
00416	5221		JMP .+3	
00417	1244		TAD LIT4	
00420	5222		JMP .+2	
00421	1245		TAD LIT5	
00422	3247		DCA STOR2	
00423	1247		TAD STOR2	/CHECK FOR CRLF
00424	1250		TAD MDOLAR	
00425	7640		SZA CLA	/IS THE CHARACTER A \$
00426	5231		JMP .+3	/NO; PRINT IT
00427	4566		JMS I CRLF	/YES; CRLF
00430	5233		JMP .+3	
00431	1247		TAD STOR2	
00432	4563		JMS I TYPEIT	
00433	2240		ISZ BYTCNT	/GET NEXT CHARACTER
00434	5236		JMP .+2	
00435	5201		JMP ENT10	
00436	1246		TAD STOR1	
00437	5210		JMP ENT11	
00440	0000	BYTCNT,	0	
00441	7776	LIT1,	7776	
00442	0077	LIT2,	0077	
00443	7745	LIT3,	7745	
00444	0333	LIT4,	0333	
00445	0233	LIT5,	0233	
00446	0000	STOR1,	0	
00447	0000	STOR2,	0	
00450	7534	MDOLAR,	-244	
00451	0000	NUMGET,	0	/NO INTERPRETER ROUTINE
00452	7300		CLA CLL	
00453	3323		DCA DIGITS	
00454	1324		TAD DIGLOC	
00455	3010		DCA DIGPTR	
00456	3325		DCA TEMP	
00457	4562	GETDIG,	JMS I READ	/READ CHARACTER
00460	3325		DCA TEMP	
00461	1325		TAD TEMP	/CHECK FOR ERASE
00462	1326		TAD MSLASH	/KEY (SLASH)
00463	7650		SNA CLA	/IS CHAR A SLASH ?
00464	5311		JMP ERROR	/YES; REPEAT ENTRY

00465	1325	TAD TEMP	/NO; TEST FOR TERMINAL
00466	1327	TAD RETURN	/RETURN CHARACTER
00467	7650	SNA CLA	/IS IT A RETURN ?
00470	5316	JMP CLEAR	/YES; EXIT THIS ROUTINE
00471	1325	TAD TEMP	/NO; CHECK FOR
00472	1377	TAD (-260	/OCTAL INPUT
00473	7510	SPA	/IS CHAR < 260 ?
00474	5311	JMP ERROR	/YES; GO TO ERROR
00475	1330	TAD MNINE	/NO; SUBTRACT 9 DECIMAL
00476	7740	SMA SZA CLA	/IS CHAR > 271 ?
00477	5311	JMP ERROR	/YES; GO TO ERROR
00500	1325	TAD TEMP	/NO; GET THE CHAR
00501	3410	DCA I DIGPTR	
00502	2323	ISZ DIGITS	/INCREMENT DIGIT CCUNT
00503	7300	CLA CLL	
00504	1323	TAD DIGITS	/CHECK DIGIT COUNT
00505	1376	TAD (-4	
00506	7740	SMA SZA CLA	/DIGITS <= 4 ?
00507	5311	JMP ERROR	/NO; GO TO ERROR BRANCH
00510	5257	JMP GETDIG	
00511	4566	ERROR, JMS I CRLF	/CRLF
00512	1322	TAD MQM	/GET ?
00513	7041	CIA	
00514	4563	JMS I TYPEIT	/PRINT THE ?
00515	5252	JMP NUMGET+1	/DISREGARD BAD ENTRY
00516	7300	CLEAR, CLA CLL	
00517	4331	JMS CONVRT	/CONVERT TO OCTAL
00520	5651	JMP I NUMGET	
00521	0000	MDIGIT, 0	
00522	7501	MQM, -277	
00523	0000	DIGITS, 0	
00524	0567	DIGLOC, 567	
00525	0000	TEMP, 0	
00526	7521	MSLASH, -257	
00527	7555	RETURN, -223	
00530	7767	MNINE, -11	
	0010	DIGPTR=10	
00531	0000	CONVRT, 0	/CONVERT ASCII TO OCTAL
00532	7300	CLA CLL	
00533	1323	TAD DIGITS	/SET DIGIT COUNTER
00534	7041	CIA	
00535	3321	DCA MDIGIT	
00536	1324	TAD DIGLOC	/SET POINTER
00537	3010	DCA DIGPTR	
00540	3325	DCA TEMP	/ZERO TEMPORARY STORAGE
00541	1325	PACK, TAD TEMP	/LOAD PARTIAL NUMBER
00542	7106	CLL RTL	/MULTIPLY BY 10
00543	1325	TAD TEMP	
00544	7004	RAL	



00545	3325		DCA TEMP	
00546	1410		TAD I DIGPTR	/ADD NEXT STORED DIGIT
00547	1377		TAD (-260	/SUBTRACT 260
00550	1325		TAD TEMP	/ADD TO PARTIAL NUMBER
00551	3325		DCA TEMP	/STORE PARTIAL NUMBER
00552	2321		ISZ MDIGIT	/ALL DIGITS DONE ?
00553	5341		JMP PACK	/NO; GET ANOTHER
00554	1325		TAD TEMP	/YES; GET PACKED NUMBER
00555	5731		JMP I CONVRT	
	0570	*570		
00570	0000		0	
00571	0000		0	
00572	0000		0	
00573	0000		0	
00576	7774			
00577	7520			
	0600	* 600		
00600	0000	SDPRNT, 0		
00601	7300		CLA CLL	
00602	1600		TAD I SDPRNT	/PICK UP ADDRESS OF
00603	3303		DCA SDGET	/HIGH ORDER WORD
00604	6211		CDF 10	
00605	1703		TAD I SDGET	/GET HIGH ORDER WORD
00606	7700		SMA CLA	/IS IT NEGATIVE ?
00607	1272		TAD SDPLUS	/NO, GENERATE SPACE
00610	1273		TAD SDMNS	/YES, GENERATE MINUS
00611	1377		TAD (260	
00612	4563		JMS I TYPEIT	/TYPE IT OUT
00613	1703		TAD I SDGET	/GET HIGH ORDER WORD
00614	7510		SPA	/IS IT POSITIVE ?
00615	7060		CMA CML	/NO, COMPLEMENT IT
00616	3275		DCA SDHIGH	/STORE POSITIVE WORD
00617	2303		ISZ SDGET	
00620	1703		TAD I SDGET	/PICK UP LOW ORDER WORD
00621	6201		CDF 00	
00622	7430		SZL	/IS LINK SET ?
00623	7141		CMA CLL IAC	/YES, TWO'S COMPLEMENT
00624	7430		SZL	/DID AC OVERFLOW
00625	2275		ISZ SDHIGH	/YES, CORRECT HIGH WORD
00626	3276		DCA SDLOW	/STORE LOW ORDER WORD
00627	1270		TAD SDLOOP	/INITIALIZE COUNTER=7
00630	3274		DCA SDCNT	
00631	1271		TAD SDADDR	/INITIALIZE POINTER TO
00632	3304		DCA SDPTR	/TABLE OF POWERS OF TEN
00633	2200		ISZ SDPRNT	/INDEX RETURN LINKAGE

00634	1704	SDARND,	TAD I SDPTR	/PICK UP POWER OF TEN
00635	2304		ISZ SDPTR	/FOR USE IN SUBSTRACT
00636	3277		DCA SDHSUB	
00637	1704		TAD I SDPTR	
00640	2304		ISZ SDPTR	
00641	3300		DCA SDLSUB	
00642	7100	SDDO,	CLL	/DOUBLE PRECISION
00643	1300		TAD SDLSUB	/SUBTRACTION
00644	1276		TAD SDLOW	
00645	3302		DCA SDTEML	
00646	7004		RAL	
00647	1277		TAD SDHSUB	
00650	1275		TAD SDHIGH	
00651	7510		SPA	/DID IT UNDERFLOW ?
00652	5260		JMP SDOUT	/NO, COUNT IS DONE
00653	2301		ISZ SDBOX	/YES, COUNT NOT DONE
00654	3275		DCA SDHIGH	/DEPOSIT HIGH ORDER
00655	1302		TAD SDTEML	/PORTION RESTORE LOW
00656	3276		DCA SDLOW	/ORDER PORTION
00657	5242		JMP SDDO	/GO BACK AND SUBTRACT
00660	7200	SDOUT,	CLA	
00661	1301		TAD SDBOX	/PICK UP DIGIT
00662	1377		TAD (260	
00663	4563		JMS I TYPEIT	/TYPE IT OUT
00664	3301		DCA SDBOX	/INITIALIZE DIGIT TO 0
00665	2274		ISZ SDCNT	/HAVE WE TYPED 7 DIGITS
00666	5234		JMP SDARND	/NO, DETERMINE NEXT
00667	5600		JMP I SDPRNT	/YES, END ROUTINE
00670	7771	SDLOOP,	-7	/COUNT OF 7 DIGITS
00671	0705	SDADDR,	SDCONL	/ADDRESS OF POWERS
00672	7763	SDPLUS,	-15	/'SPACE' GENERATOR
00673	7775	SDMNS,	-3	/'MINUS' GENERATOR
00674	0000	SDCNT,	0	/STORAGE LOCATIONS
00675	0000	SDHIGH,	0	
00676	0000	SDLOW,	0	
00677	0000	SDHSUB,	0	
00700	0000	SDLSUB,	0	
00701	0000	SDBOX,	0	
00702	0000	SDTEML,	0	
00703	0000	SDGET,	0	
00704	0000	SDPTR,	0	
00705	7413	SDCONL,	7413	/TABLE OF POWERS OF TEN
00706	6700		6700	/-1,000,000
00707	7747		7747	/-100,000
00710	4540		4540	
00711	7775		7775	/-10,000
00712	4360		4360	
00713	7777		7777	/-1,000
00714	6030		6030	
00715	7777		7777	/-100

00716	7634		7634	
00717	7777		7777	/- 10
00720	7766		7766	
00721	7777		7777	/- 1
00722	7777		7777	
00723	0000	SSPRNT,	0	
00724	7100		CLL	
00725	7510		SPA	/IS IT POSITIVE ?
00726	7061		CML CMA IAC	/NO, SET LINK
00727	3370		DCA SSVAL	/STORE NUMBER
00730	3366		DCA SSBOX	/SET LOCATION TO ZERO
00731	1365		TAD SSCNTR	/INITIALIZE COUNTER=4
00732	3367		DCA SSCNT	
00733	1362		TAD SSADDR	/INITIALIZE INSTRUCTION
00734	3343		DCA SSXYZ+1	/TC GET FIRST 10
00735	1363		TAD SSPLUS	/GET CODE TO TYPE +
00736	7430		SZL	/IS NUMBER NEGATIVE ?
00737	1364		TAD SSMNS	/YES, CHANGE CODE TO -
00740	1377		TAD (260	
00741	4563		JMS I TYPEIT	/TYPE IT OUT
00742	1370	SSXYZ,	TAD SSVAL	/PICK UP NUMBER
00743	1371		TAD SSCON	/SUBTRACT POWER OF TEN
00744	7510		SPA	/IS RESULT NEGATIVE ?
00745	5351		JMP .+4	/YES, INDEXING FINISHED
00746	2366		ISZ SSBOX	/NO, INDEX DIGIT LOCA.
00747	3370		DCA SSVAL	/STORE REMAINDER SSVAL
00750	5342		JMP SSXYZ	/CONTINUE SUBTRACTING
00751	7200		CLA	
00752	1366		TAD SSBOX	/GET THE DIGIT NUMBER
00753	1377		TAD (260	
00754	4563		JMS I TYPEIT	/TYPE IT OUT
00755	3366		DCA SSBOX	/DIGIT COUNTER=0
00756	2343		ISZ SSXYZ+1	/GET POWER OF TEN
00757	2367		ISZ SSCNT	/TYPED FOUR DIGITS
00760	5342		JMP SSXYZ	/NO, CONTINUE
00761	5723		JMP I SSPRNT	/YES, RETURN
00762	1371	SSADDR,	TAD SSCON	/TO GET FIRST POWER
00763	7760	SSPLUS,	-20	/'SPACE' GENERATOR
00764	0015	SSMNS,	15	/'MINUS' GENERATOR
00765	7774	SSCNTR,	-4	/COUNT OF 4 DIGITS
00766	0000	SSBOX,	0	/STORAGE REGISTERS
00767	0000	SSCNT,	0	
00770	0000	SSVAL,	0	
00771	6030	SSCON,	6030	/- 1000
00772	7634		7634	/- 100
00773	7766		7766	/- 10
00774	7777		7777	/- 1
00777	0260			

	1000	* 1000		
01000	0000	ENDFIL,	0	/PUNCH TRAILER
01001	7200		CLA	
01002	3031		DCA PUN1	
01003	1377		TAD (204	
01004	4264		JMS TYPEIT	
01005	1376		TAD (-36	
01006	3021		DCA CNTR1	
01007	1375		TAD (377	
01010	4264		JMS TYPEIT	
01011	2021		ISZ CNTR1	
01012	5207		JMP .-3	
01013	1374		TAD (-372	
01014	3021		DCA CNTR1	
01015	4264		JMS TYPEIT	
01016	2021		ISZ CNTR1	
01017	5215		JMP .-2	
01020	5600		JMP I ENDFIL	
01021	0000	DEL,	0	/DEL ROUTINE
01022	3021		DCA CNTR1	
01023	7000		NOP	
01024	2021		ISZ CNTR1	
01025	5223		JMP .-2	
01026	5621		JMP I DEL	
01027	0000	LEADER,	0	/PUNCH LEADER
01030	1374		TAD (-372	
01031	3021		DCA CNTR1	
01032	4264		JMS TYPEIT	
01033	2021		ISZ CNTR1	
01034	5232		JMP .-2	
01035	1376		TAD (-36	
01036	3021		DCA CNTR1	
01037	1375		TAD (377	
01040	4264		JMS TYPEIT	
01041	2021		ISZ CNTR1	
01042	5237		JMP .-3	
01043	5627		JMP I LEADER	
01044	0000	SPACE,	0	/PUNCH TWO SPACES
01045	7200		CLA	
01046	1373		TAD (240	
01047	4264		JMS TYPEIT	
01050	1373		TAD (240	
01051	4264		JMS TYPEIT	
01052	5644		JMP I SPACE	

01053	0000	ENDREC, 0		/PUNCH END RECORD CHAR.
01054	7200		CLA	
01055	1372		TAD (223	
01056	4264		JMS TYPEIT	
01057	1375		TAD (377	
01060	4264		JMS TYPEIT	
01061	1375		TAD (377	
01062	4264		JMS TYPEIT	
01063	5653		JMP I ENDREC	
01064	0000	TYPEIT, 0		/TTY PRINT ROUTINE
01065	6041		TSF	
01066	5265		JMP .-1	
01067	6046		TLS	
01070	7300		CLA CLL	
01071	5664		JMP I TYPEIT	
01072	0000	CRLF, 0		/CRLF ROUTINE
01073	7300		CLA CLL	
01074	1371		TAD (215	
01075	4264		JMS TYPEIT	
01076	1370		TAD (212	
01077	4264		JMS TYPEIT	
01100	5672		JMP I CRLF	
01101	0000	READ, 0		/KEYBOARD READ ROUTINE
01102	6031		KSF	
01103	5302		JMP .-1	
01104	7300		CLA CLL	
01105	6036		KRB	
01106	6046		TLS	
01107	5701		JMP I READ	
01170	0212			
01171	0215			
01172	0223			
01173	0240			
01174	7406			
01175	0377			
01176	7742			
01177	0204			
	1200	*1200		
01200	0000	DST, 0		/DOUBLE PRECISION STORE
01201	3222		DCA ACC	/SAVE AC
01202	6214		RDF	/SAVE DATA FIELD
01203	1220		TAD KCDF	
01204	3211		DCA CHG	/GENERATE CDF INSTRUCT.
01205	6201		CDF 00	

01206	1600		TAD I DST	/GET STORAGE ADDRESS
01207	3221		DCA ARG	
01210	2200		ISZ DST	/SET RETURN ADDRESS
01211	0000	CHG,	0	/CHANGE DATA FIELD BACK
01212	1222		TAD ACC	/RECOVER AC
01213	3621		DCA I ARG	/STORE HIGH ORDER WORD
01214	2221		ISZ ARG	
01215	7701		ACL	/LOAD AC FROM MQ
01216	3621		DCA I ARG	/STORE LOW ORDER WORD
01217	5600		JMP I DST	
01220	6201	KCDF,	CDF	
01221	0000	ARG,	0	
01222	0000	ACC,	0	
01223	0000	DCM,	0	/DOUBLE PRECISION
01224	7100		CLL	/COMPLEMENT
01225	7040		CMA	/SET AC TO 7777
01226	7521		SWP	
01227	7041		CIA	/NEGATE MQ CONTENTS
01230	7521		SWP	
01231	7430		SZL	/CHECK FOR OVERFLOW
01232	7001		IAC	
01233	5623		JMP I DCM	
01234	0000	DAD,	0	/DOUBLE PRECISION ADD
01235	3222		DCA ACC	/SAVE AC
01236	6214		RDF	/SAVE DATA FIELD
01237	1220		TAD KCDF	
01240	3245		DCA CHANG	
01241	6201		CDF 00	
01242	1634		TAD I DAD	/GET ADDRESS OF
01243	3221		DCA ARG	/STORED VALUES
01244	2234		ISZ DAD	/SET RETURN ADDRESS
01245	0000	CHANG,	0	/CHANGE DATA FIELD BACK
01246	1621		TAD I ARG	/GET HIGH ORDER STORED
01247	3262		DCA HIGHT	/VALUE AND SAVE
01250	2221		ISZ ARG	
01251	7100		CLL	
01252	7521		SWP	/LOAD MQ INTO AC
01253	1621		TAD I ARG	/GET LOW ORDER STORED
01254	7521		SWP	/LOW ORDER SUM IN MQ
01255	7430		SZL	/WAS THERE A CARRY ?
01256	7101		IAC CLL	/YES, INCREMENT AC
01257	1222		TAD ACC	/NO, ADD HIGH ORDER
01260	1262		TAD HIGHT	
01261	5634		JMP I DAD	/RETURN
01262	0000	HIGHT,	0	
01263	0000	SUMDAT,	0	/SUM DATA
01264	7200		CLA	

01265	1023		TAD ISTORE	/FIND DATA
01266	3010		DCA 10	
01267	3306		DCA MSHPNT	/SET MSH POINTER
01270	3310		DCA MSHPNT+2	
01271	1026		TAD SUM2	
01272	3021		DCA CNTR1	/DATA COUNTER
01273	7621	SUMLUP,	CAM	
01274	1410		TAD I 10	/GET FIRST VALUE
01275	7500		SMA	/IS IT NEGATIVE ?
01276	5303		JMP ADD1	/NO, ADD IT
01277	7041		CIA	/YES, MAKE IT POSITIVE
01300	7521		SWP	/PUT IN MQ
01301	4223		JMS DCM	/MAKE IT NEGATIVE
01302	7410		SKP	
01303	7521	ADD1,	SWP	/PUT IN MQ
01304	6211		CDF 10	
01305	4234		JMS DAD	/DCUBLE PRECISION ADD
01306	0000	MSHPNT,	0	
01307	4200		JMS DST	/DCUBLE PRECISION STOPE
01310	0000	DUMMY,	0	
01311	6201		CDF 00	
01312	2306		ISZ MSHPNT	/SET NEW ADDRESS
01313	2306		ISZ MSHPNT	
01314	2310		ISZ MSHPNT+2	
01315	2310		ISZ MSHPNT+2	
01316	2021		ISZ CNTR1	/ALL DATA SUMMED ?
01317	5273		JMP SUMLUP	/NO, NEXT VALUE
01320	7300		CLA CLL	/YES, DELAY
01321	1033		TAD LUMIN	/DELAY TEST
01322	7650		SNA CLA	/FAST OR SLOW ?
01323	5347		JMP STDEL	/FAST, DELAY
01324	1035		TAD RANGE	/SLOW, TEST
01325	7041		CIA	
01326	7001		IAC	
01327	7450		SNA	/10 MSEC RANGE ?
01330	5342		JMP TESTA	/YES, TEST TWO
01331	7001		IAC	/NO, 100 MSEC RANGE ?
01332	7640		SZA CLA	
01333	5663		JMP I SUMDAT	/NC, FORGET DELAY
01334	1034		TAD DATPOT	/YES, TEST TWO
01335	7041		CIA	
01336	0377		AND (7400	
01337	7640		SZA CLA	
01340	5663		JMP I SUMDAT	
01341	5347		JMP STDEL	
01342	1034	TESTA,	TAD DATPOT	
01343	7041		CIA	
01344	0376		AND (4000	
01345	7640		SZA CLA	
01346	5663		JMP I SUMDAT	

01347	1375	STDEL,	TAD (-3720	/STANDARD DELAY
01350	3022		DCA CNTR2	
01351	1375	DELMIN,	TAD (-3720	
01352	4565		JMS I DEL	/5 USEC * AC DELAY
01353	2022		ISZ CNTR2	
01354	5351		JMP DELMIN	
01355	5663		JMP I SUMDAT	/END
01375	4060			
01376	4000			
01377	7400			
	1400	*1400		
01400	0000	DATOUT, 0		/PUNCH GENERAL DATA
01401	7200		CLA	
01402	1031		TAD PUN1	
01403	7650		SNA CLA	
01404	4561		JMS I LEADER	/PUNCH LEADER
01405	2031		ISZ PUN1	
01406	4566		JMS I CRLF	
01407	4560		JMS I ENDREC	
01410	1377		TAD (-6	
01411	3021		DCA CNTR1	
01412	1376		TAD (PNTDAT	
01413	3013		DCA 13	
01414	1413		TAD I 13	
01415	4563		JMS I TYPEIT	
01416	2021		ISZ CNTR1	
01417	5214		JMP .-3	
01420	4557		JMS I SPACE	
01421	1413		TAD I 13	
01422	1413		TAD I 13	
01423	7200		CLA	
01424	1375		TAD (-4	
01425	3021		DCA CNTR1	
01426	1413		TAD I 13	
01427	4563		JMS I TYPEIT	
01430	2021		ISZ CNTR1	
01431	5226		JMP .-3	
01432	4557		JMS I SPACE	
01433	1032		TAD RUNCNT	
01434	4556		JMS I SSPRNT	
01435	4557		JMS I SPACE	
01436	1027		TAD NUMWAV	
01437	7041		CIA	
01440	4556		JMS I SSPRNT	
01441	4557		JMS I SPACE	
01442	1025		TAD PASSES	
01443	7041		CIA	



01444	4556		JMS I	SSPRNT	
01445	4557		JMS I	SPACE	
01446	1026		TAD	SUM2	
01447	7041		CIA		
01450	4556		JMS I	SSPRNT	
01451	4557		JMS I	SPACE	
01452	1033		TAD	LUMIN	
01453	4556		JMS I	SSPRNT	
01454	4557		JMS I	SPACE	
01455	1033		TAD	LUMIN	
01456	7650		SNA	CLA	
01457	5267		JMP	CONTIN	
01460	1030		TAD	DELTIM	
01461	7041		CIA		
01462	4556		JMS I	SSPRNT	
01463	4557		JMS I	SPACE	
01464	1035		TAD	RANGE	
01465	4556		JMS I	SSPRNT	
01466	4557		JMS I	SPACE	
01467	4566	CONTIN,	JMS I	CRLF	
01470	4560		JMS I	ENDREC	
01471	4555		JMS I	PUNCH	
01472	4554		JMS I	PUNSQR	
01473	5600		JMP I	DATOUT	/END
01474	0000	PUNCH,	0		/SUMMED DATA OUTPUT
01475	7200		CLA		
01476	3305		DCA	ADR	
01477	1026		TAD	SUM2	
01500	3021		DCA	CNTR1	
01501	1374	LOP,	TAD	(-7	
01502	3022		DCA	CNTR2	
01503	7200	INLOP,	CLA		
01504	4553		JMS I	SDPRNT	
01505	0000	ADR,	0		
01506	4557		JMS I	SPACE	
01507	2305		ISZ	ADR	
01510	2305		ISZ	ADR	
01511	2021		ISZ	CNTR1	
01512	5314		JMP	+.2	
01513	5321		JMP	ENDTAP	
01514	2022		ISZ	CNTR2	
01515	5303		JMP	INLOP	
01516	4566		JMS I	CRLF	
01517	4560		JMS I	ENDREC	
01520	5301		JMP	LOP	
01521	4566	ENDTAP,	JMS I	CRLF	
01522	4560		JMS I	ENDREC	
01523	1373		TAD	(5777	/OVERLOAD OUTPUT
01524	3010		DCA	10	

01525	3305		DCA	ADR	
01526	2305		ISZ	ADR	
01527	1026		TAD	SUM2	
01530	3021		DCA	CNTR1	
01531	1372		TAD	(-5	
01532	3022		DCA	CNTR2	
01533	7200	LOPIN,	CLA		
01534	1410		TAD	I 10	
01535	7450		SNA		
01536	5352		JMP	POL	
01537	4556		JMS	I SSPRNT	
01540	4557		JMS	I SPACE	
01541	1305		TAD	ADR	
01542	4556		JMS	I SSPRNT	
01543	4557		JMS	I SPACE	
01544	2022		ISZ	CNTR2	
01545	5352		JMP	POL	
01546	4566		JMS	I CRLF	
01547	4560		JMS	I ENDREC	
01550	1372		TAD	(-5	
01551	3022		DCA	CNTR2	
01552	2305	POL,	ISZ	ADR	
01553	2021		ISZ	CNTR1	
01554	5333		JMP	LOPIN	
01555	7200		CLA		
01556	4556		JMS	I SSPRNT	
01557	4557		JMS	I SPACE	
01560	4556		JMS	I SSPRNT	
01561	4557		JMS	I SPACE	
01562	4566		JMS	I CRLF	
01563	4560		JMS	I ENDREC	
01564	5674		JMP	I PUNCH	
01572	7773				
01573	5777				
01574	7771				
01575	7774				
01576	1711				
01577	7772				
	1600	*1600			
01600	0000	RESET1, 0			/RESET FOR RUN
01601	2032		ISZ	RUNCNT	/SET RUN COUNTER
01602	7200		CLA		
01603	1377		TAD	(MSG03-1	/REPEAT RUN
01604	3017		DCA	17	
01605	4571		JMS	I MESSAGE	
01606	4570		JMS	I NUMGET	/GET ANSWER
01607	7650		SNA	CLA	/REPEAT ?

01610	4552		JMS I MESSY	/NO, PRINT MESSAGES
01611	1025		TAD PASSES	/YES, RESET VARIABLES
01612	3024		DCA P	
01613	3021		DCA CNTR1	/ZERO FIELD 1
01614	6211		CDF 10	
01615	3421	ZLOOP,	DCA I CNTR1	
01616	2021		ISZ CNTR1	
01617	5215		JMP ZLOOP	
01620	6201		CDF 00	
01621	1376		TAD (3777	/ZERO OVERLOAD
01622	3010		DCA 10	
01623	1375		TAD (-3000	
01624	3021		DCA CNTR1	
01625	3410		DCA I 10	
01626	2021		ISZ CNTR1	
01627	5225		JMP -2	
01630	5600		JMP I RESET1	
01631	0000	PREP,	0	/ROTOR ON & ENABLE
01632	6341		ROTRON	/TURN ROTOR ON
01633	7200		CLA	
01634	1374		TAD (-764	/DELAY 5 SEC
01635	3022		DCA CNTR2	
01636	1373	RLOOP,	TAD (-3720	
01637	4565		JMS I DEL	/5 USECD * AC DELAY
01640	2022		ISZ CNTR2	
01641	5236		JMP RLOOP	
01642	6343		XABLE	/ENABLE X-RAYS
01643	1372		TAD (-6	/DELAY 60 MSEC
01644	3022		DCA CNTR2	
01645	1373	XLOOP,	TAD (-3720	
01646	4565		JMS I DEL	/5 USEC * AC DELAY
01647	2022		ISZ CNTR2	
01650	5245		JMP XLOOP	
01651	6455		INATOD	/INITIALIZE A TO D
01652	6346		INBOX	/INITIALIZE INTEGRATOR
01653	5631		JMP I PREP	/END
01654	0000	DATTIM,	0	/DATE & TIME ROUTINE
01655	1371		TAD (MSG01-1	
01656	3017		DCA 17	
01657	4571		JMS I MESSAGE	/PRINT MESSAGE
01660	7200		CLA	
01661	1372		TAD (-6	
01662	3021		DCA CNTR1	/SET DIGIT COUNTER
01663	1310		TAD DATPNT	/GET STORAGE LOCATION
01664	3311		DCA PNTDAT	
01665	4562	DNEXT,	JMS I READ	/GET DIGIT
01666	3711		DCA I PNTDAT	/STORE DIGIT
01667	2311		ISZ PNTDAT	/RESET STORAGE LOCATION

01670	2021		ISZ CNTR1	/MORE DIGITS ?
01671	5265		JMP DNEXT	/YES, GET DIGIT
01672	1370		TAD (MSG02-1	/NO, GET TIME
01673	3017		DCA 17	
01674	4571		JMS I MESSAGE	/PRINT MESSAGE
01675	7200		CLA	
01676	1367		TAD (-4	
01677	3021		DCA CNTR1	/SET DIGIT COUNTER
01700	1320		TAD TIMPNT	/GET STORAGE LOCATION
01701	3321		DCA PNTTIM	
01702	4562	TNEXT,	JMS I READ	/GET DIGIT
01703	3721		DCA I PNTTIM	/STORE DIGIT
01704	2321		ISZ PNTTIM	/RESET
01705	2021		ISZ CNTR1	/MORE DIGITS ?
01706	5302		JMP TNEXT	/YES, GET DIGIT
01707	5654		JMP I DATTIM	/NO, END ROUTINE
01710	1712	DATEPNT,	DATEPNT+2	
01711	0000	PNTDAT,	0	
01712	0000		0	/STORAGE OF DATE
01713	0000		0	
01714	0000		0	
01715	0000		0	
C1716	0000		0	
01717	0000		0	
01720	1722	TIMPNT,	TIMPNT+2	
01721	0000	PNTTIM,	0	
01722	0000		0	/STORAGE OF TIME
01723	0000		0	
01724	0000		0	
01725	0000		0	
01767	7774			
01770	3006			
01771	2777			
01772	7772			
01773	4060			
01774	7014			
C1775	5000			
01776	3777			
01777	3020			
	2000	*2000		
02000	0000	MESSY,	0	/INFORMATION INPUT
02001	1377		TAD (MSG04-1	/GET # OF WAVES
02002	3017		DCA 17	
02003	4571		JMS I MESSAGE	
02004	4570		JMS I NUMGET	/GET ANSWER
02005	7041		CIA	
02006	3027		DCA NUMWAV	

02007	1376	TAD (MSG05-1	/# OF PASSES
02010	3017	DCA 17	
02011	4571	JMS I MESSAGE	
02012	4570	JMS I NUMGET	/GET ANSWER
02013	7041	CIA	
02014	3025	DCA PASSES	
02015	1375	TAD (MSG06-1	/FAST OR SLOW ?
02016	3017	DCA 17	
02017	4571	JMS I MESSAGE	
02020	4570	JMS I NUMGET	/GET ANSWER
02021	3033	DCA LUMIN	
02022	1033	TAD LUMIN	
02023	7650	SNA CLA	
02024	5600	JMP I MESSY	
02025	1374	TAD (MSG07-1	/TRANSIENT DECAY
02026	3017	DCA 17	
02027	4571	JMS I MESSAGE	
02030	4570	JMS I NUMGET	/GET ANSWER
02031	7041	CIA	
02032	3030	DCA DELTIM	
02033	1373	TAD (MSG08-1	/# DATA POINTS
02034	3017	DCA 17	
02035	4571	JMS I MESSAGE	
02036	4570	JMS I NUMGET	/GET ANSWER
02037	7041	CIA	
02040	3034	DCA DATPOT	
02041	1372	TAD (MSG09-1	/RANGE CODE
02042	3017	DCA 17	
02043	4571	JMS I MESSAGE	
02044	4570	JMS I NUMGET	/GET ANSWER
02045	3035	DCA RANGE	
02046	1035	TAD RANGE	
02047	1255	TAD PTR	
02050	3254	DCA TEMPER	
02051	1654	TAD I TEMPER	
02052	3040	DCA DELRAN	
02053	5600	JMP I MESSY	
02054	0000	TEMPER, 0	
02055	2055	PTR, PTR	
02056	2217	DEL1	
02057	2223	DEL2	
02060	2233	DEL3	
02172	3162		
02173	3152		
02174	3116		
02175	3070		
02176	3056		
02177	3041		

	2200	*2200		
02200	0000	DATA,	0	/DATA ROUTINE
02201	6455		STATOD	/START A TO D
02202	7346		CLA CLL CMA RTL	
02203	4565		JMS I DEL	/5 USEC * AC DELAY
02204	6354		GETDAT	/GET DATA POINT
02205	6346		INBOX	/INITIAL INTEGRATOR
02206	3410		DCA I 10	/STORE DATA
02207	2037		ISZ SUM	/MORE DATA ?
02210	5212		JMP .+2	/YES, GET IT
02211	5600		JMP I DATA	/NO, STOP
02212	1377		TAD (-276	
02213	4565		JMS I DEL	/5 USEC * AC DELAY
02214	6345		STBOX	/START INTEGRATOR
02215	4440		JMS I DELRAN	/DELAY RANGE VALUE
02216	5201		JMP DATA+1	
02217	0000	DEL1,	0	/10 MSEC DELAY
02220	1376		TAD (-3405	
02221	4565		JMS I DEL	
02222	5617		JMP I DEL1	
02223	0000	DEL2,	0	/100 MSEC DELAY
02224	1375		TAD (-5	
02225	3022		DCA CNTR2	
02226	1374		TAD (213	
02227	4565		JMS I DEL	
02230	2022		ISZ CNTR2	
02231	5226		JMP .-3	
02232	5623		JMP I DEL2	
02233	0000	DEL3,	0	/1 SEC DELAY
02234	1373		TAD (-62	
02235	3022		DCA CNTR2	
02236	1372		TAD (147	
02237	4565		JMS I DEL	
02240	7000		NOP	
02241	2022		ISZ CNTR2	
02242	5236		JMP .-4	
02243	5633		JMP I DEL3	
02244	0000	UDPRNT,	0	
02245	7300		CLA CLL	
02246	1644		TAD I UDPRNT	/PICK UP ADDRESS OF
02247	3331		DCA UDGET	/HIGH ORDER WORD
02250	6211		CDF 10	
02251	1731		TAD I UDGET	/PICK UP BOTH WORDS FOR
02252	3323		DCA UDHIGH	/USE IN SUBROUTINE
02253	2331		ISZ UDGET	

02254	1731		TAD I UDGET	
02255	3324		DCA UDLOW	
02256	6201		CDF 00	
02257	1320		TAD UDLOOP	/INITIALIZE COUNTER
02260	3322		DCA UDCNT	
02261	1321		TAD UDADDR	/INITIALIZE TO TABLE OF
02262	3332		DCA UDPTR	/POWERS OF TEN
02263	2244		ISZ UDPRNT	/SET RETURN ADDRESS
02264	1732	UDARND,	TAD I UDPTR	/PICK UP FIRST POWER
02265	2332		ISZ UDPTR	/FOR USE IN SUBTRACTION
02266	3325		DCA UDHSUB	
02267	1732		TAD I UDPTR	
02270	2332		ISZ UDPTR	
02271	3326		DCA UDLSUB	
02272	7100	UDDO,	CLL	/DOUBLE PRECISION SUB
02273	1326		TAD UDLSUB	
02274	1324		TAD UDLOW	
02275	3330		DCA UDTEML	
02276	7004		RAL	
02277	1325		TAD UDHSUB	
02300	1323		TAD UDHIGH	
02301	7420		SNL	/DID IT OVERFLOW ?
02302	5310		JMP UDOUT	/NO, COUNT IS DONE
02303	2327		ISZ UDBOX	/YES, CONTINUE
02304	3323		DCA UDHIGH	/SAVE REMAINDER
02305	1330		TAD UDTEML	
02306	3324		DCA UDLOW	
02307	5272		JMP UDDO	
02310	7200	UDOUT,	CLA	
02311	1327		TAD UDBOX	/GET DIGIT
02312	1371		TAD (260	
02313	4563		JMS I TYPEIT	/TYPE IT
02314	3327		DCA UDBOX	
02315	2322		ISZ UDCNT	/MORE DIGITS ?
02316	5264		JMP UDARND	/YES, GET NEXT
02317	5644		JMP I UDPRNT	/NO, DONE
02320	7770	UDLOOP,	-10	
02321	2333	UDADDR,	UDCONL	
02322	0000	UDCNT,	0	
02323	0000	UDHIGH,	0	
02324	0000	UDLOW,	0	
02325	0000	UDHSUB,	0	
02326	0000	UDLSUB,	0	
02327	0000	UDBOX,	0	
02330	0000	UDTEML,	0	
02331	0000	UDGET,	0	
02332	0000	UDPTR,	0	
02333	3166	UDCONL,	3166	/POWERS OF TEN
02334	4600		4600	/-10,000,000
02335	7413		7413	/-1,000,000

02336	6700		6700	
02337	7747		7747	/-100,000
02340	4540		4540	
02341	7775		7775	/-10,000
02342	4360		4360	
02343	7777		7777	/-1000
02344	6030		6030	
02345	7777		7777	/-100
02346	7634		7634	
02347	7777		7777	/-10
02350	7766		7766	
02351	7777		7777	/-1
02352	7777		7777	
02371	0260			
02372	0147			
02373	7716			
02374	0213			
02375	7773			
02376	4373			
02377	7502			
	2400	*2400		
02400	0000	SQR,	0	/SQUARE ROUTINE
02401	1600		TAD I SQR	/GET DATA ADDRESS
02402	3273		DCA ARGU	
02403	2200		ISZ SQR	/SET RETURN ADDRESS
02404	1673		TAD I ARGU	/GET DATA POINT
02405	7041		CIA	/MAKE IT POSITIVE
02406	3274		DCA STORE	/STORE TEMPORARILY
02407	1274		TAD STORE	
02410	3275		DCA TEST	/SET TEST VALUE
02411	7001		IAC	
02412	3276		DCA MASK	/SET MASK TO ONE
02413	1377		TAD (-14	/SET BIT COUNTER
02414	3044		DCA CNT2	
02415	3045		DCA HIGH	
02416	3046		DCA LOW	
02417	1275	TESTBT,	TAD TEST	
02420	0276		AND MASK	/CHECK FOR BIT TRUE
02421	7740		SZA CLA CLL	/TRUE ?
02422	5235		JMP ADD	/YES, ADD PARTIAL PROD.
02423	1276	RETUR,	TAD MASK	/RESET MASK
02424	7104		RAL CLL	
02425	3276		DCA MASK	
02426	2044		ISZ CNT2	/MORE BITS ?
02427	5217		JMP TESTBT	/YES, TEST NEXT
02430	1046		TAD LOW	/NO, LOAD RESULT IN
02431	7521		SWP	/MQ AND AC



02432	7200		CLA	
02433	1045		TAD HIGH	
02434	5600		JMP I SQR	/END
02435	1044	ADD,	TAD CNT2	/DETERMINE WHICH BIT
02436	1376		TAD (14	/WAS BEING TESTED
02437	7140		CMA CLL	
02440	3043		DCA CNT1	
02441	1274		TAD STORE	
02442	3041		DCA TEMPST	
02443	3042		DCA TEMPST+1	
02444	2043	REDO,	ISZ CNT1	/SET VALUE OF
02445	5247		JMP .+2	/PARTIAL PRODUCT
02446	5262		JMP DADSTP	/ADD PARTIAL PRODUCT
02447	1042		TAD TEMPST+1	
02450	7004		RAL	
02451	3042		DCA TEMPST+1	
02452	1041		TAD TEMPST	
02453	7004		RAL	
02454	3041		DCA TEMPST	
02455	7420		SNL	/CHECK FOR OVERFLOW
02456	5244		JMP REDO	/NO, CONTINUE
02457	2042		ISZ TEMPST+1	/YES, INCREMENT MSD
02460	7100		CLL	
02461	5244		JMP REDO	
02462	1041	DADSTP,	TAD TEMPST	/DOUBLE PRECISION ADD
02463	7521		SWP	
02464	7200		CLA	
02465	1042		TAD TEMPST+1	
02466	4551		JMS I DAD	/ADD ROUTINE
02467	0045		HIGH	
02470	4550		JMS I DST	/STORE ROUTINE
02471	0045		HIGH	
02472	5223		JMP RETUR	
02473	0000	ARGU,	0	
02474	0000	STORE,	0	
02475	0000	TEST,	0	
02476	0000	MASK,	0	
02477	0000	SUMSQR,	0	/SUM OF SQUARES
02500	7300		CLA CLL	
02501	1375		TAD (4000	/STORAGE ADDRESS
02502	3317		DCA MSHSQR	
02503	1375		TAD (4000	
02504	3321		DCA MSHSQR+2	
02505	1375		TAD (4000	/RESET DATA LOCATOR
02506	3314		DCA DATLOC	
02507	1026		TAD SUM2	/GET # DATA POINTS
02510	3021		DCA CNTR1	
02511	1374		TAD (6000	/OVERFLOW COUNTERS
02512	3022		DCA CNTR2	

02513	4200	SQRSUM,	JMS SQR	/SQUARE VALUE
02514	4000	DATLOC,	4000	
02515	6211		CDF 10	
02516	4551		JMS I DAD	/DOUBLE PRECISION ADD
02517	0000	MSHSQR,	0	
02520	4550		JMS I DST	/DOUBLE PRECISION STORE
02521	0000	DUMB,	0	
02522	6201		CDF 00	
02523	7430		SZL	/TEST, OVERFLOW
02524	2422		ISZ I CNTR2	/YES, INCREMENT COUNTER
02525	7100		CLL	
02526	2022		ISZ CNTR2	/RESET ADDRESS
02527	2314		ISZ DATLOC	
02530	2317		ISZ MSHSQR	
02531	2317		ISZ MSHSQR	
02532	2321		ISZ MSHSQR+2	
02533	2321		ISZ MSHSQR+2	
02534	2021		ISZ CNTR1	/MORE DATA ?
02535	5313		JMP SQRSUM	/YES, SQUARE & ADD
02536	5677		JMP I SUMSQR	/NO, RETURN
02537	0000	PUNSQR,	0	/SUMMED SQUARES OUTPUT
02540	7200		CLA	
02541	1375		TAD (4000	
02542	3351		DCA ADRSQR	
02543	1026		TAD SUM2	
02544	3021		DCA CNTR1	
02545	1373	LOPSQR,	TAD (-7	
02546	3022		DCA CNTR2	
02547	7200	INSQR,	CLA	
02550	4547		JMS I UDPRNT	
02551	0000	ADRSQR,	0	
02552	4557		JMS I SPACE	
02553	2351		ISZ ADRSQR	
02554	2351		ISZ ADRSQR	
02555	2021		ISZ CNTR1	
02556	5360		JMP .+2	
02557	5365		JMP ENDSQR	
02560	2022		ISZ CNTR2	
02561	5347		JMP INSQR	
02562	4566		JMS I CRLF	
02563	4560		JMS I ENDREC	
02564	5345		JMP LOPSQR	
02565	4566	ENDSQR,	JMS I CRLF	
02566	4560		JMS I ENDREC	
02567	5737		JMP I PUNSQR	
02573	7771			
02574	6000			
02575	4000			

02576 0014  
02577 7764

3000 \*3000

03000 4424 MSG01, TEXT /\$TODAYS DATE /

03001 1704

03002 0131

03003 2340

03004 0401

03005 2405

03006 4000

03007 4040 MSG02, TEXT / TIME (MILITARY) /

03010 2411

03011 1505

03012 4050

03013 1511

03014 1411

03015 2401

03016 2231

03017 5140

03020 0000

03021 4422 MSG03, TEXT /\$REPEAT PREVIOUS RUN 1-YES,  
0-NO /

03022 0520

03023 0501

03024 2440

03025 2022

03026 0526

03027 1117

03030 2523

03031 4022

03032 2516

03033 4061

03034 5531

03035 0523

03036 5440

03037 6055

03040 1617

03041 4000

03042 4416 MSG04, TEXT /\$NUMBER OF WAVES IN BOMB /

03043 2515

03044 0205

03045 2240

03046 1706

03047 4027

03050 0126

03051 0523

03052 4011

03053 1640

03054 0217

03055	1502	
03056	4000	
03057	4040	MSG05, TEXT / NUMBER OF PASSES /
03060	1625	
03061	1502	
03062	0522	
03063	4017	
03064	0640	
03065	2001	
03066	2323	
03067	0523	
03070	4000	
03071	4406	MSG06, TEXT /\$FAST OR SLOW LUMINESCENCE
03072	0123	0-FAST, 1-SLOW /
03073	2440	
03074	1722	
03075	4023	
03076	1417	
03077	2740	
03100	1425	
03101	1511	
03102	1605	
03103	2303	
03104	0516	
03105	0305	
03106	4060	
03107	5506	
03110	0123	
03111	2454	
03112	4061	
03113	5523	
03114	1417	
03115	2740	
03116	0000	
03117	4424	MSG07, TEXT /\$TRANSIENT DECAY 5.0 USEC-CNT
03120	2201	INITIAL OFFSET 12.6 USEC /
03121	1623	
03122	1105	
03123	1624	
03124	4004	
03125	0503	
03126	0131	
03127	4065	
03130	5660	
03131	4025	
03132	2305	
03133	0355	
03134	0316	
03135	2440	
03136	1116	

03137	1124	
03140	1101	
03141	1440	
03142	1706	
03143	0623	
03144	0524	
03145	4061	
03146	6256	
03147	6640	
03150	2523	
03151	0503	
03152	4000	
03153	4443	MSG08, TEXT /\$# DATA POINTS /
03154	4004	
03155	0124	
03156	0140	
03157	2017	
03160	1116	
03161	2423	
03162	4000	
03163	4040	MSG09, TEXT / RANGE CODE 1-10, 2-100, 3-1000
03164	2201	MSEC /
03165	1607	
03166	0540	
03167	0317	
03170	0405	
03171	4061	
03172	5561	
03173	6054	
03174	4062	
03175	5561	
03176	6060	
03177	5440	
03200	6355	
03201	6160	
03202	6060	
03203	4015	
03204	2305	
03205	0340	
03206	0000	
03207	4403	MSG15, TEXT /\$CONTINUE RUNS 1-YES, 0-NO /
03210	1716	
03211	2411	
03212	1625	
03213	0540	
03214	2225	
03215	1623	
03216	4061	
03217	5531	
03220	0523	

03221 5440  
 03222 6055  
 03223 1617  
 03224 4000

6345	STBOX=6345
6455	STATOD=6455
6354	GETDAT=6354
6346	INBOX=6346
6455	INATOD=6455
6344	XDABLE=6344
6342	ROTRPF=6342
6337	CSTART=6337
6331	CREADY=6331
6332	NOW=6332
6333	XON=6333
6334	XOFF=6334
6336	CWAIT=6336
6343	XABLE=6343
6341	ROTRON=6341
7701	ACL=7701
7621	CAM=7621

\$

00147 2244  
 00150 1200  
 00151 1234  
 00152 2000  
 00153 0600  
 00154 2537  
 00155 1474  
 00156 0723  
 00157 1044  
 00160 1053  
 00161 1027  
 00162 1101  
 00163 1064  
 00164 2200  
 00165 1021  
 00166 1072  
 00167 1000  
 00170 0451  
 00171 0400  
 00172 1400  
 00173 2477  
 00174 1263  
 00175 1631  
 00176 1600  
 00177 1654

ACC	1222	GETDAT	6354	PREP	1631	SUM	0037
ACL	7701	GETDIG	0457	PTR	2055	SUMDAT	1263
AED	2435	HIGH	0045	PUNCH	1474	SUMLUP	1273
ALD1	1303	HIGHT	1262	PUNSQR	2537	SUMSQR	2477
ADR	1505	INATOD	6455	PUN1	0031	SUM2	0026
ADRSQR	2551	INBOX	6346	RANGE	0035	TEMP	0525
ARG	1221	INLOP	1503	READ	1101	TEMPER	2054
ARGU	2473	INSQR	2547	REDO	2444	TEMPST	0041
BCMB	0254	ISTORE	0023	RESET	0203	TEST	2475
BCMB2	0304	KCDF	1220	RESET1	1600	TESTA	1342
BYTCNT	0440	LEADER	1027	RETUR	2423	TESTBT	2417
CAM	7621	LIT1	0441	RETURN	0527	TIMPNT	1720
CHANG	1245	LIT2	0442	RLOOP	1636	TNEXT	1702
CHG	1211	LIT3	0443	ROTRUF	6342	TYPEIT	1064
CLEAR	0516	LIT4	0444	ROTRON	6341	UDADDR	2321
CNTR1	0021	LIT5	0445	RUNCNT	0032	UDARND	2264
CNTR2	0022	LOP	1501	SDADDR	0671	UDBOX	2327
CNT1	0043	LOPIN	1533	SDARND	0634	UDCNT	2322
CNT2	0044	LOPSQR	2545	SDBOX	0701	UDCONL	2333
CCNTIN	1467	LOW	0046	SDCNT	0674	UDDO	2272
CCNVRT	0531	LUMIN	0033	SDCONL	0705	UDGET	2331
CREADY	6331	MASK	2476	SDDO	0642	UDHIGH	2323
CRLF	1072	MDIGIT	0521	SDGET	0703	UDHSUB	2325
CSTART	6337	MDOLAR	0450	SDHIGH	0675	UDLOOP	2320
CWAIT	6336	MESSAGE	0400	SDHSUB	0677	UDLOW	2324
DAD	1234	MESSY	2000	SDLOOP	0670	UDLSUB	2326
DADSTP	2462	MNINE	0530	SDLOW	0676	UDOUT	2310
DATA	2200	MQM	0522	SDLSUB	0700	UDPRNT	2244
DATLOC	2514	MSG01	3000	SDMNS	0673	UDPTR	2332
DATOUT	1400	MSG02	3007	SDOUT	0660	UDTEML	2330
DATPNT	1710	MSG03	3021	SDPLUS	0672	XABLE	6343
DATPOT	0034	MSG04	3042	SDPRNT	0600	XDABLE	6344
DATTIM	1654	MSG05	3057	SDPTR	0704	XLOOP	1645
DCM	1223	MSG06	3071	SDTEML	0702	XOFF	6334
DEL	1021	MSG07	3117	SET1	0231	XON	6333
DELMIN	1351	MSG08	3153	SPACE	1044	ZLOOP	1615
DELRA	0040	MSG09	3163	SQR	2400		
DELTIM	0030	MSG15	3207	SQRSUM	2513		
DEL1	2217	MSHPNT	1306	SSADDR	0762		
DEL2	2223	MHSQR	2517	SSBOX	0766		
DEL3	2233	MSLASH	0526	SSCNT	0767		
DIGITS	0523	MULT	0313	SSCNTR	0765		
DIGLOC	0524	MULTI	0263	SSCON	0771		
DIGPTR	0010	N	0036	SSMNS	0764		
DNEXT	1665	NOW	6332	SSPLUS	0763		
DST	1200	NUMGET	0451	SSPRNT	0723		
DUMB	2521	NUMWAV	0027	SSVAL	0770		
DUMMY	1310	P	0024	SSXYZ	0742		
ENDFIL	1000	PACK	0541	START	0200		
ENDREC	1053	PASS	0204	STATOD	6455		

ENDSQR	2565	PASSES	0025	STBOX	6345
ENDTAP	1521	PNTDAT	1711	STDEL	1347
ENT10	0401	PNTTIM	1721	STORE	2474
ENT11	0410	POINTS	0251	STOR1	0446
ERROR	0511	POL	1552	STOR2	0447

ERRORS DETECTED: 0  
LINKS GENERATED: 0



## APPENDIX 5: JCL

JCL is the acronym for job control language. The listing which follows contains all the JCL statements required to run the job which calculates the experimental results. The sections where data and program source decks belong are indicated in the listing. The WYLBUR execute file, EXECRS3 (see Appendix 6), moves the the proper data sets to the indicated positions when the job is created. The statements in the listing are applicable only to the Iowa State University Computation Center and are subject to change as system changes are implemented.

```

1 //A411GJO JOB A0099,GJO,TIME=(1,59)
2 /*JOBPARM LINES=10
3 //S1 EXEC PGM=IEBGENER
4 //SYSPRINT DD SYSOUT=A
5 //SYSIN DD DUMMY
6 //SYSUT2 DD DSN=&CARDS1,UNIT=DISK,DISP=(NEW,PASS),
7 // SPACE=(3520,(5,5),RLSE),DCB=(RECFM=FB,LRECL=80,
8 // BLKSIZE=3520)
9 //SYSUT1 DD *
   Control Variables
180 /*
801 //S2 EXEC PL1LFCLG,PARM.PL1L='A,X,NEST',REGION.GO=160K
802 //PL1L.SYSIN DD *
   TRS3 Source Deck
803 /*
804 //GO.SYSIN DD DSN=CPS07.A0986.GJO1,DISP=SHR
805 //IN          DD DSN=&CARDS1,DISP=(OLD,DELETE)
807 //OUT        DD DSN=CPS07.A0986.GJO2,UNIT=DISK,
808 // VOL=SER=RJEPAK,DISP=(NEW,KEEP,DELETE),SPACE=(3520,
809 // (5,5)),DCB=(RECFM=FB,LRECL=80,BLKSIZE=3520)
810 //GO.FT14F001 DD DSN=&SM,UNIT=SCRATCH,DISP=(NEW,PASS),
811 // SPACE=(800,(120,15)),DCB=(RECFM=VS,LRECL=796,
812 // BLKSIZE=800)
813 //SIMPLTR EXEC PLOT,PLOTTER=INCRMNTL,FORM=W
814 //S3 EXEC FORTG,REGION.GO=160K,TIME.GO=(2,00)
815 //FORT.SYSLIN DD DISP=(OLD,PASS)
816 //FORT.SYSIN DD *
   SMASH Source Deck
817 //LKED.SYSLMOD DD DSN=&GOSET2(GO)
818 //GO.FT05F001 DD DSN=CPS07.A0986.GJO2,DISP=SHR,
819 // VOL=SER=RJEPAK,UNIT=2314
820 //GO.FT06F001 DD SYSOUT=A
821 //GO.FT14F001 DD DSN=&SM2,UNIT=SCRATCH,DISP=(NEW,PASS),
822 // SPACE=(800,(120,15)),DCB=(RECFM=VS,LRECL=796,
823 // BLKSIZE=800)
824 //SIMPLTR EXEC PLOT,PLOTTER=INCRMNTL,FORM=W
825 //PLOT.FT14F001 DD DSN=&SM2
998 /*
999 //
1000

```

## APPENDIX 6: EXECTRS3

EXECTRS3 is a WYLBUR execute file which creates the job which calculates the experimental results. The execute file starts with the JCL statements (Appendix 5), copies TRS3 (Appendix 1) and SMASH (Appendix 2) to the appropriate lines and interrogates the operator for input information. After the job is created the execute file submits the job to the computer system for execution and erases the original input data set in preparation for the next use of the execute file. The WYLBUR statements which make up the execute file are listed on the following pages.

```

10 SET EXEC NOL TER
20 SET ESC :
40 SET VOL CAT
50 USE #JCL CLR
60 COPY ALL FROM #TRS3 TO 802.001
70 SCR $CPS07.A0986.GJO2 ON RJEPAK
80 COMM HOW MANY RUNS?
90 INS 11 UNN
100 REA VAL NO USING 11
110 COPY 1000 TO 12
120 SET VAL W0=12
130 SET VAL W1=13
140 SET VAL N1=0
150 SET VAL N1=N1+1
160 REA STR S0 PRO 'IS RUN :N1 FAST OR SLOW? '
170 SET VAL N9=2*:N1
180 IF (S0 EQ 'FAST') EXEC 400
190 REA STR S0 PRO 'WILL SMASH BE RUN? '
200 IF (S0 EQ 'NO') CH :N9/:N9 TO 0 IN :W0 N
210 COPY 1000 TO :W1
220 REA STR S1 PRO 'GRAPH LABEL RUN :N1? '
230 CH 1/20 TO ':S1' IN :W1 N
240 REA STR S1 PRO 'DATA LABEL RUN :N1? '
250 CH 21/40 TO ':S1' IN :W1 N
260 SET VAL W1=W1+1
270 IF (S0 EQ 'YES') EXEC 450 SAVE
280 IF (N1 LT N0) EXEC 150
290 COMM TO RUN JOB TYPE EXEC NEXT
300 EXEC PAUSE
310 IF (N2 NE 1) DEL 813/822
320 IF (N2 EQ 1) COPY ALL FROM #SMASH TO 816.001
350 RUN 1/999 UNN
351 SCR $CPS07.A0986.GJO3
360 EXEC PAUSE
400 CH :N9/:N9 TO 0 IN :W0 N
410 EXEC 280
450 REA VAL N8 PRO '#SMASHES RUN :N1? '
460 COPY 1000 TO :W1
470 CH 1 TO :N8 IN :W1 N
480 SET VAL W1=W1+1
490 SET VAL N2=1
500 CH :N9/:N9 TO 1 IN :W0 N
510 SET VAL N3=0
520 SET VAL N3=N3+1
530 IF (N3 GT N8) EXEC RETURN
540 COPY 1000 TO :W1
550 IF (N3 EQ 1) CH 10/10 TO 0 IN :W1 N
560 IF (N3 NE 1) CH 9/10 TO -1 IN :W1 N
570 REA STR S1 PRO 'HOW MANY COMPONENTS SMASH :N3? '
580 CH 5/5 TO ':S1' IN :W1 N

```

```
590 REA STR S1 PRO 'GRAPHS SMASH :N3? '
600 IF (S1 EQ 'YES') EXEC 630
610 CH 15/15 TO 0 IN :W1 N
620 EXEC 660
630 REA STR S1 PRO 'LIN=LINEAR, LOG=SEMILOG '
640 IF (S1 EQ 'LIN') CH 15/15 TO 1 IN :W1 N
650 IF (S1 EQ 'LOG') CH 14/15 TO -1 IN :W1 N
660 SET VAL W2=W1
670 SET VAL W1=W1+1
680 REA STR S1 PRO 'PRINTED OUTPUT HEADING? '
690 COPY 1000 TO :W1
700 CH 1/80 TO ':S1' IN :W1 N
710 SET VAL W1=W1+1
720 REA VAL W9 USING :W2 COLS 15/15
730 IF (W9 EQ 0) EXEC 840
740 COPY 1000 TO :W1
750 REA STR S1 PRO 'X-AXIS LABEL? '
760 CH 1/20 TO ':S1' IN :W1 N
770 REA STR S1 PRO 'Y-AXIS LABEL? '
780 CH 21/40 TO ':S1' IN :W1 N
790 REA STR S1 PRO 'GRAPH LABEL? '
800 CH 41/60 TO ':S1' IN :W1 N
810 REA STR S1 PRO 'DATA LABEL? '
820 CH 61/80 TO ':S1' IN :W1 N
830 SET VAL W1=W1+1
840 COPY 1000 TO :W1
850 SET VAL N4=0
860 REA VAL N5 USING :W2 COL 5/5
870 SET VAL N4= N4+1
880 SET VAL N6=N4*10-9
890 SET VAL N7=N4*10
900 REA STR S1 PRO 'DECAY CONSTANT FOR COMPONENT :N4 '
910 CH :N6/:N7 TO ':S1' IN :W1 N
920 IF (N4 LT N5) EXEC 870
930 SET VAL W1=W1+1
940 EXEC 520
```